**CETECOM™****CETECOM ICT Services**
consulting - testing - certification >>>

TEST REPORT

Test report no.: 1-0644/15-01-02

Deutsche
Akkreditierungsstelle
D-PL-12076-01-01

Testing laboratory

CETECOM ICT Services GmbH

Untertuerkheimer Strasse 6 – 10

66117 Saarbruecken / Germany

Phone: + 49 681 5 98 - 0

Fax: + 49 681 5 98 - 9075

Internet: <http://www.cetecom.com>e-mail: ict@cetecom.com**Accredited Testing Laboratory:**

The testing laboratory (area of testing) is accredited according to DIN EN ISO/IEC 17025 (2005) by the Deutsche Akkreditierungsstelle GmbH (DAkkS)

The accreditation is valid for the scope of testing procedures as stated in the accreditation certificate with the registration number: D-PL-12076-01-01

Applicant

Insys Microelectronics GmbH

Hermann-Köhl-Str. 22

93049 Regensburg / GERMANY

Phone: +49 941 58692-0

Fax: -/-

Contact: Markus Heider

e-mail: mheider@insys-tec.de

Phone: -/-

Manufacturer

Insys Microelectronics GmbH

Hermann-Köhl-Str. 22

93049 Regensburg / GERMANY

Test standard/s

47 CFR Part 15

Title 47 of the Code of Federal Regulations; Chapter I; Part 15 - Radio frequency devices

For further applied test standards please refer to section 3 of this test report.

Test Item

Kind of test item: RWE LSX Variants
Model name: LSX Mobile, LSX Mobile Extended
LSX Basis, LSX Extended
FCC ID: 2AKBXIEKA160
IC: -/-
Frequency: DTS band 2400 MHz to 2483.5 MHz
Technology tested: WLAN (DSSS/b-mode; OFDM/g- & n HT20 – mode)
Antenna: Integrated antenna
Power supply: 12 V DC by external power supply
Temperature range: -30°C to 50°C



This test report is electronically signed and valid without handwriting signature. For verification of the electronic signatures, the public keys can be requested at the testing laboratory.

Test report authorized:

Andreas Luckenbill
Lab Manager
Radio Communications & EMC

Test performed:

Marco Bertolino
Lab Manager
Radio Communications & EMC

1 Table of contents

1	Table of contents.....	2
2	General information	3
2.1	Notes and disclaimer	3
2.2	Application details.....	3
3	Test standard/s and references	3
4	Test environment.....	4
5	Test item	4
5.1	General description	4
5.2	Additional information	4
6	Test laboratories sub-contracted	4
7	Description of the test setup.....	5
7.1	Shielded semi anechoic chamber.....	6
7.2	Shielded fully anechoic chamber	7
7.3	Radiated measurements > 18 GHz.....	9
7.4	AC conducted	10
7.5	Conducted measurements	11
8	Sequence of testing	12
8.1	Sequence of testing radiated spurious 9 kHz to 30 MHz.....	12
8.2	Sequence of testing radiated spurious 30 MHz to 1 GHz.....	13
8.3	Sequence of testing radiated spurious 1 GHz to 18 GHz	14
8.4	Sequence of testing radiated spurious above 18 GHz	15
9	Measurement uncertainty	16
10	Summary of measurement results.....	17
11	Additional comments	18
12	Measurement results.....	19
12.1	Duty cycle	19
12.2	Antenna gain	24
12.3	Identify worst case data rate	27
12.4	Maximum output power.....	28
12.5	Peak power spectral density	29
12.6	6 dB DTS bandwidth	36
12.7	Occupied bandwidth – 99% emission bandwidth.....	43
12.8	Occupied bandwidth – 20 dB bandwidth.....	50
12.9	Band edge compliance conducted	57
12.10	Spurious emissions conducted	62
12.11	Spurious emissions radiated below 30 MHz.....	74
12.12	Spurious emissions radiated 30 MHz to 1 GHz.....	79
12.13	Spurious emissions radiated above 1 GHz	87
12.14	Spurious emissions conducted below 30 MHz (AC conducted).....	101
13	Observations	104
Annex A	Document history	104
Annex B	Further information.....	104
Annex C	Accreditation Certificate	105

2 General information

2.1 Notes and disclaimer

The test results of this test report relate exclusively to the test item specified in this test report. CETECOM ICT Services GmbH does not assume responsibility for any conclusions and generalizations drawn from the test results with regard to other specimens or samples of the type of the equipment represented by the test item.

The test report may only be reproduced or published in full. Reproduction or publication of extracts from the report requires the prior written approval of CETECOM ICT Services GmbH.

The testing service provided by CETECOM ICT Services GmbH has been rendered under the current "General Terms and Conditions for CETECOM ICT Services GmbH".

CETECOM ICT Services GmbH will not be liable for any loss or damage resulting from false, inaccurate, inappropriate or incomplete product information provided by the customer.

Under no circumstances does the CETECOM ICT Services GmbH test report include any endorsement or warranty regarding the functionality, quality or performance of any other product or service provided.

Under no circumstances does the CETECOM ICT Services GmbH test report include or imply any product or service warranties from CETECOM ICT Services GmbH, including, without limitation, any implied warranties of merchantability, fitness for purpose, or non-infringement, all of which are expressly disclaimed by CETECOM ICT Services GmbH.

All rights and remedies regarding vendor's products and services for which CETECOM ICT Services GmbH has prepared this test report shall be provided by the party offering such products or services and not by CETECOM ICT Services GmbH.

In no case this test report can be considered as a Letter of Approval.

This test report is electronically signed and valid without handwritten signature. For verification of the electronic signatures, the public keys can be requested at the testing laboratory.

2.2 Application details

Date of receipt of order:	2016-04-07
Date of receipt of test item:	2016-05-02
Start of test:	2016-05-02
End of test:	2016-07-08
Person(s) present during the test:	-/-

3 Test standard/s and references

Test standard	Date	Description
47 CFR Part 15	-/-	Title 47 of the Code of Federal Regulations; Chapter I; Part 15 - Radio frequency devices

Guidance	Version	Description
DTS: KDB 558074 D01	v03r05	Guidance for Performing Compliance Measurements on Digital Transmission Systems (DTS) Operating Under §15.247
ANSI C63.4-2014	-/-	American national standard for methods of measurement of radio-noise emissions from low-voltage electrical and electronic equipment in the range of 9 kHz to 40 GHz
ANSI C63.10-2013	-/-	American national standard of procedures for compliance testing of unlicensed wireless devices

4 Test environment

Temperature	:	T _{nom} T _{max} T _{min}	+22 °C during room temperature tests No tests under extreme conditions required. No tests under extreme conditions required.
Relative humidity content	:		55 %
Barometric pressure	:		not relevant for this kind of testing
Power supply	:	V _{nom} V _{max} V _{min}	12 V DC by external power supply No tests under extreme conditions required. No tests under extreme conditions required.

5 Test item

5.1 General description

Kind of test item	:	RWE LSX Variants
Type identification	:	LSX Mobile, LSX Mobile Extended LSX Basis, LSX Extended
HMN	:	-/-
PMN	:	-/-
HVIN	:	-/-
FVIN	:	-/-
S/N serial number	:	10018246002 16354011
HW hardware status	:	No information available!
SW software status	:	No information available!
Frequency band	:	DTS band 2400 MHz to 2483.5 MHz (lowest channel 2412 MHz; highest channel 2462 MHz)
Type of radio transmission	:	DSSS, OFDM
Use of frequency spectrum	:	
Type of modulation	:	(D)BPSK, (D)QPSK, 16 – QAM, 64 – QAM
Number of channels	:	11
Antenna	:	Integrated antenna
Power supply	:	12 V DC by external power supply
Temperature range	:	-30°C to +50°C

5.2 Additional information

The content of the following annexes is defined in the QA. It may be that not all of the listed annexes are necessary for this report, thus some values in between may be missing.

Test setup- and EUT-photos are included in test report: 1-0644/15-01-01_AnnexA
1-0644/15-01-01_AnnexB
1-0644/15-01-01_AnnexD

6 Test laboratories sub-contracted

None

7 Description of the test setup

Typically, the calibrations of the test apparatus are commissioned to and performed by an accredited calibration laboratory. The calibration intervals are determined in accordance with the DIN EN ISO/IEC 17025. In addition to the external calibrations, the laboratory executes comparison measurements with other calibrated test systems or effective verifications. Weekly chamber inspections and range calibrations are performed. Where possible, RF generating and signaling equipment as well as measuring receivers and analyzers are connected to an external high-precision 10 MHz reference (GPS-based or rubidium frequency standard).

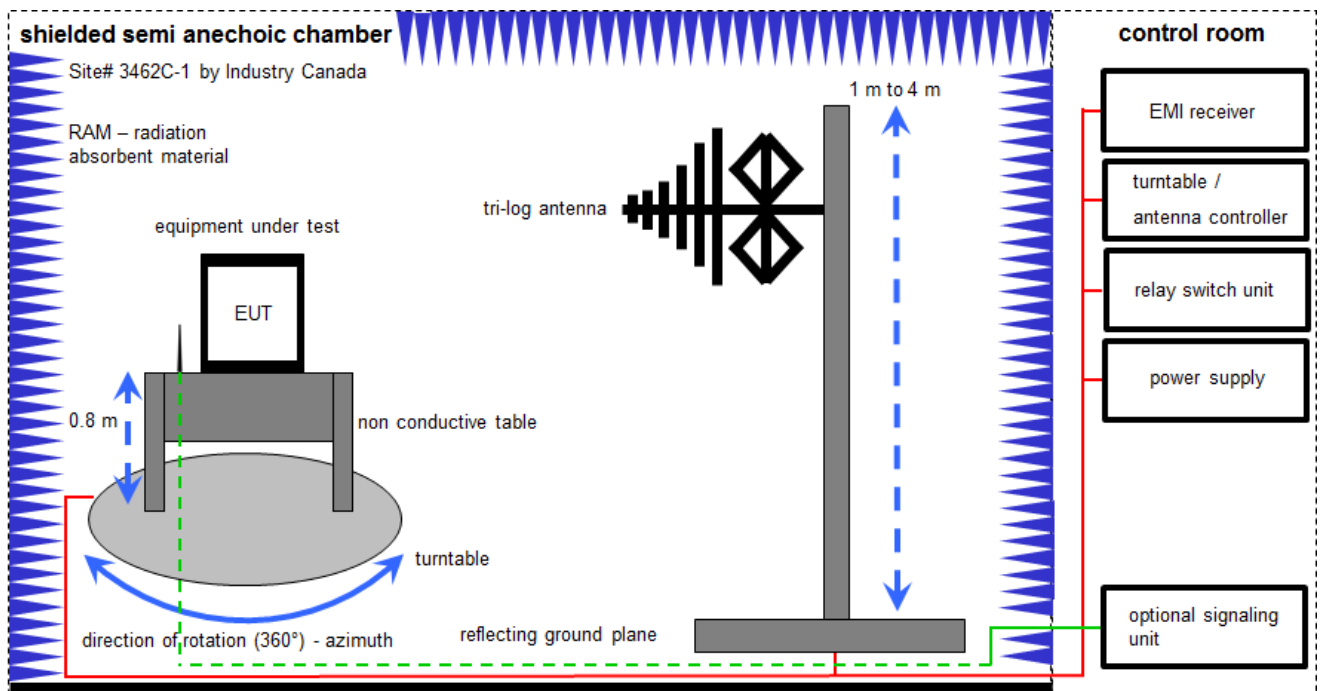
In order to simplify the identification of the equipment used at some special tests, some items of test equipment and ancillaries can be provided with an identifier or number in the equipment list below (Lab/Item).

Agenda: Kind of Calibration

k	calibration / calibrated	EK	limited calibration
ne	not required (k, ev, izw, zw not required)	zw	cyclical maintenance (external cyclical maintenance)
ev	periodic self verification	izw	internal cyclical maintenance
Ve	long-term stability recognized	g	blocked for accredited testing
v/k!	Attention: extended calibration interval		
NK!	Attention: not calibrated	*)	next calibration ordered / currently in progress

7.1 Shielded semi anechoic chamber

The radiated measurements are performed in vertical and horizontal plane in the frequency range from 9 kHz to 1 GHz in semi-anechoic chambers. The EUT is positioned on a non-conductive support with a height of 0.80 m above a conductive ground plane that covers the whole chamber. The receiving antennas are confirmed with specifications ANSI C63. These antennas can be moved over the height range between 1.0 m and 4.0 m in order to search for maximum field strength emitted from EUT. The measurement distances between EUT and receiving antennas are indicated in the test setups for the various frequency ranges. For each measurement, the EUT is rotated in all three axes until the maximum field strength is received. The wanted and unwanted emissions are received by spectrum analyzers where the detector modes and resolution bandwidths over various frequency ranges are set according to requirement ANSI C63.



Measurement distance: tri-log antenna 10 meter

$$FS = UR + CL + AF$$

(FS-field strength; UR-voltage at the receiver; CL-loss of the cable; AF-antenna factor)

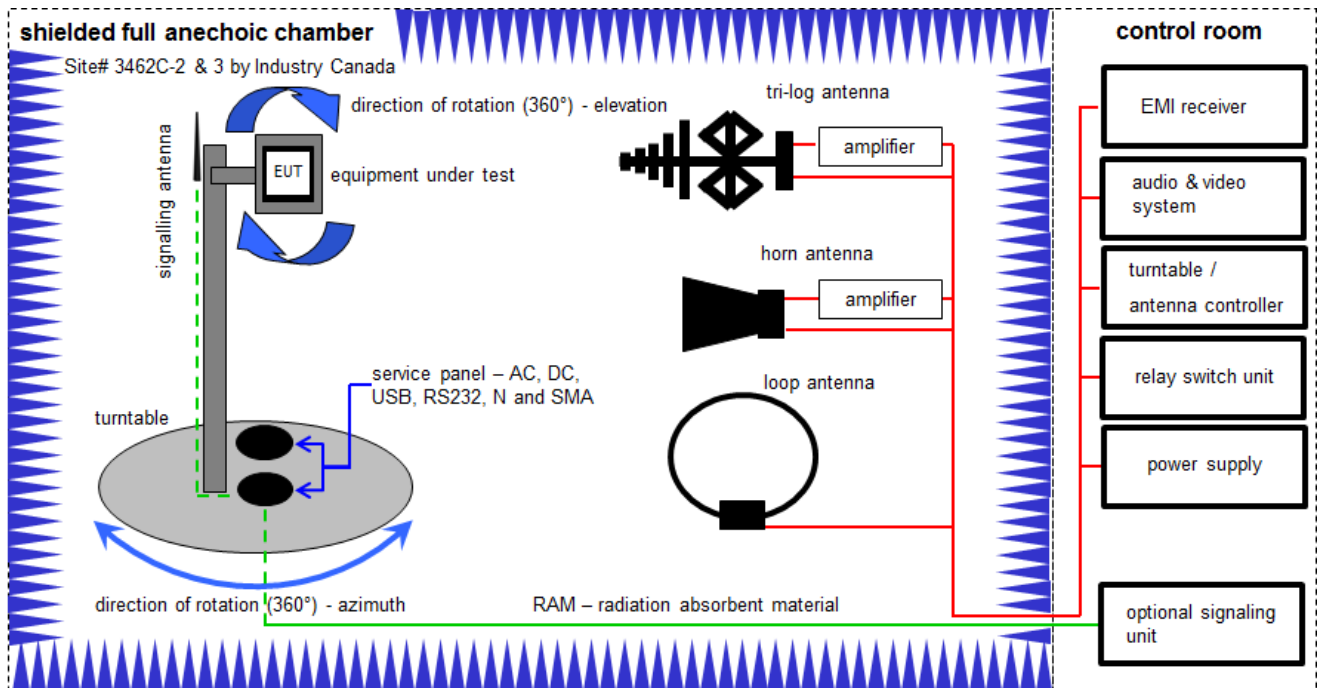
Example calculation:

$$FS [dB\mu V/m] = 12.35 [dB\mu V/m] + 1.90 [dB] + 16.80 [dB/m] = 31.05 [dB\mu V/m] (35.69 \mu V/m)$$

Equipment table:

No.	Lab / Item	Equipment	Type	Manufacturer	Serial No.	INV. No Cetecom	Kind of Calibration	Last Calibration	Next Calibration
1	A	Switch-Unit	3488A	HP	2719A14505	300000368	ev	-/-	-/-
2	A	DC power supply, 60Vdc, 50A, 1200 W	6032A	HP	2920A04466	300000580	ne	-/-	-/-
3	A	RF-Filter-section	85420E	HP	3427A00162	300002214	k	27.11.2006	-/-
4	A	EMI Test Receiver	ESCI 3	R&S	100083	300003312	k	08.03.2016	08.03.2017
5	A	Antenna Tower	Model 2175	ETS-Lindgren	64762	300003745	izw	-/-	-/-
6	A	Positioning Controller	Model 2090	ETS-Lindgren	64672	300003746	izw	-/-	-/-
7	A	Turntable Interface-Box	Model 105637	ETS-Lindgren	44583	300003747	izw	-/-	-/-
8	A	TRILOG Broadband Test-Antenna 30 MHz - 3 GHz	VULB9163	Schwarzbeck	295	300003787	k	25.04.2016	25.04.2018

7.2 Shielded fully anechoic chamber



Measurement distance: tri-log antenna and horn antenna 3 meter; loop antenna 3 meter / 1 meter

$$FS = UR + CA + AF$$

(FS-field strength; UR-voltage at the receiver; CA-loss of the signal path; AF-antenna factor)

Example calculation:

$$FS [dB\mu V/m] = 40.0 [dB\mu V/m] + (-35.8) [dB] + 32.9 [dB/m] = 37.1 [dB\mu V/m] (71.61 \mu V/m)$$

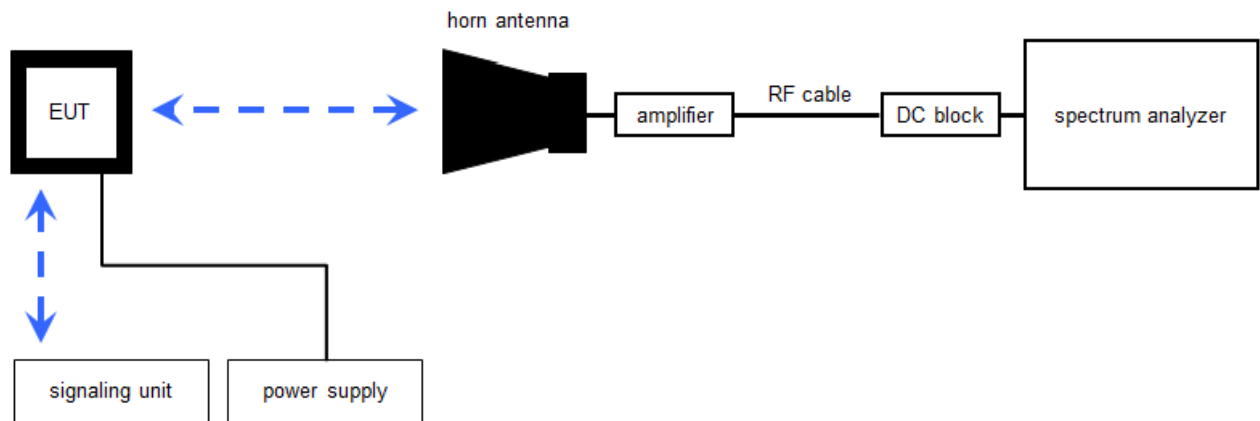
Equipment table:

No.	Lab / Item	Equipment	Type	Manufacturer	Serial No.	INV. No Cetecom	Kind of Calibration	Last Calibration	Next Calibration
1	A, B, C	DC power supply, 60Vdc, 50A, 1200 W	6032A	HP	2818A03450	300001040	Ve	20.01.2015	20.01.2018
2	B	Double-Ridged Waveguide Horn Antenna 1-18.0GHz	3115	EMCO	8812-3088	300001032	vIKI!	20.05.2015	20.05.2017
3	A, B, C	Anechoic chamber	FAC 3/5m	MWB / TDK	87400/02	300000996	ev	-/-	-/-
4	A, B, C	Switch / Control Unit	3488A	HP	*	300000199	ne	-/-	-/-
5	A	Active Loop Antenna 10 kHz to 30 MHz	6502	EMCO/2	8905-2342	300000256	k	24.06.2015	24.06.2017
6	B	Amplifier	js42-00502650-28-5a	Parzich GMBH	928979	300003143	ne	-/-	-/-
7	B	Band Reject filter	WRCG2400/2483-2375/2505-50/10SS	Wainwright	11	300003351	ev	-/-	-/-
8	B	Highpass Filter	WHKX7.0/18G-8SS	Wainwright	18	300003789	ne	-/-	-/-
9	B, C	TRILOG Broadband Test-Antenna 30 MHz - 3 GHz	VULB9163	Schwarzbeck	371	300003854	vIKI!	29.10.2014	29.10.2017
10	A, B, C	4U RF Switch Platform	L4491A	Agilent Technologies	MY50000037	300004509	ne	-/-	-/-
11	A, B, C	EMI Test Receiver 9kHz-26.5GHz	ESR26	R&S	101376	300005063	k	04.09.2015	04.09.2016
12	A	Std. Gain Horn Antenna 12.4 to 18.0 GHz	639	Narda	8402	300000787	k	14.08.2015	14.08.2017
13	A	Signal Analyzer 40 GHz	FSV40	R&S	101042	300004517	k	21.01.2016	21.01.2017
14	A	Amplifier 2-40 GHz	JS32-02004000-57-5P	MITEQ	1777200	300004541	ev	-/-	-/-

15	A	RF-Cable	ST18/SMAm/SMAm/ 48	Huber & Suhner	Batch no. 600918	400001182	ev	-/-	-/-
16	A	RF-Cable	ST18/SMAm/SMm/4 8	Huber & Suhner	Batch no. 127377	400001183	ev	-/-	-/-
17	A	DC-Blocker 0.1-40 GHz	8141A	Inmet	Batch no. 127377	400001185	ev	-/-	-/-

7.3 Radiated measurements > 18 GHz

Radiated measurements > 18 GHz



Measurement distance: horn antenna 50 cm

$$FS = U_R + CA + AF$$

(FS-field strength; U_R -voltage at the receiver; CA-loss signal path & distance correction; AF-antenna factor)

Example calculation:

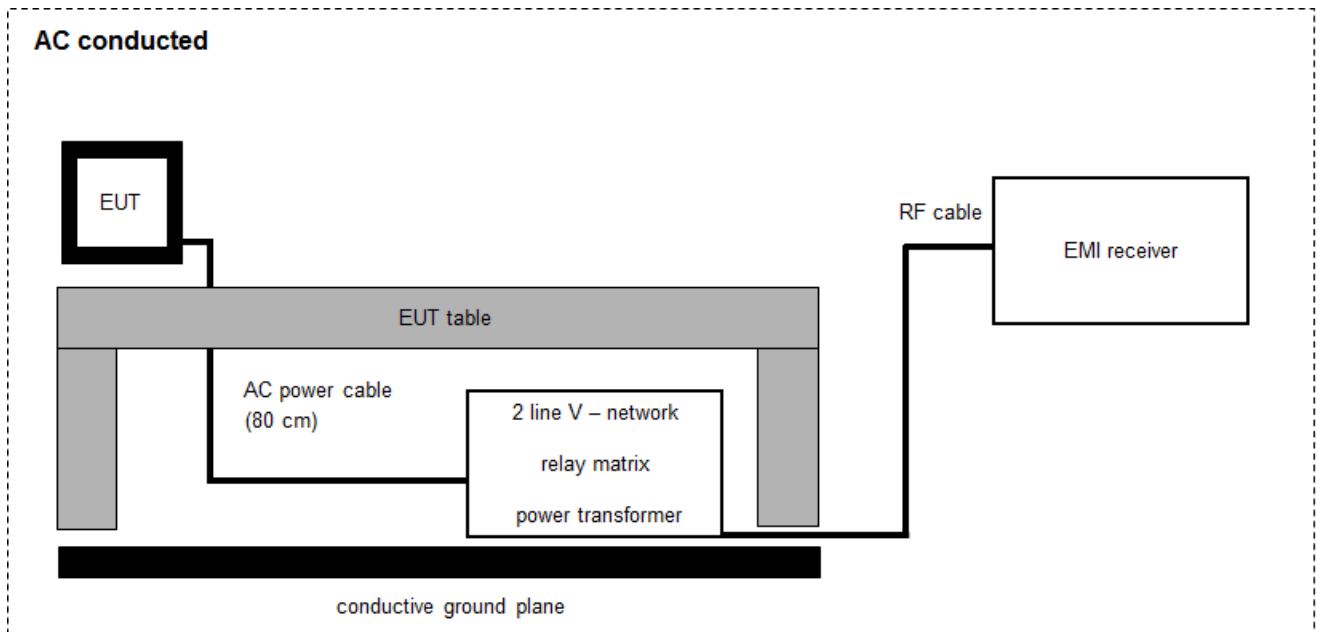
$$FS \text{ [dB}\mu\text{V/m]} = 40.0 \text{ [dB}\mu\text{V/m]} + (-60.1) \text{ [dB]} + 36.74 \text{ [dB/m]} = 16.64 \text{ [dB}\mu\text{V/m]} \text{ (6.79 } \mu\text{V/m)}$$

Equipment table:

No.	Lab / Item	Equipment	Type	Manufacturer	Serial No.	INV. No Cetecom	Kind of Calibration	Last Calibration	Next Calibration
1	A	Std. Gain Horn Antenna 18.0 to 26.5 GHz	638	Narda	8402	300000486	k	10.09.2015	10.09.2017
2	A	Signal Analyzer 40 GHz	FSV40	R&S	101042	300004517	k	21.01.2016	21.01.2017
3	A	Amplifier 2-40 GHz	JS32-02004000-57-5P	MITEQ	1777200	300004541	ev	-/-	-/-
4	A	RF-Cable	ST18/SMAm/SMAm/48	Huber & Suhner	Batch no. 600918	400001182	ev	-/-	-/-
5	A	RF-Cable	ST18/SMAm/SMm/48	Huber & Suhner	Batch no. 127377	400001183	ev	-/-	-/-
6	A	DC-Blocker 0.1-40 GHz	8141A	Inmet	Batch no. 127377	400001185	ev	-/-	-/-

7.4 AC conducted

AC conducted



$$FS = UR + CF + VC$$

(FS-field strength; UR-voltage at the receiver; CR-loss of the cable and filter; VC-correction factor of the ISN)

Example calculation:

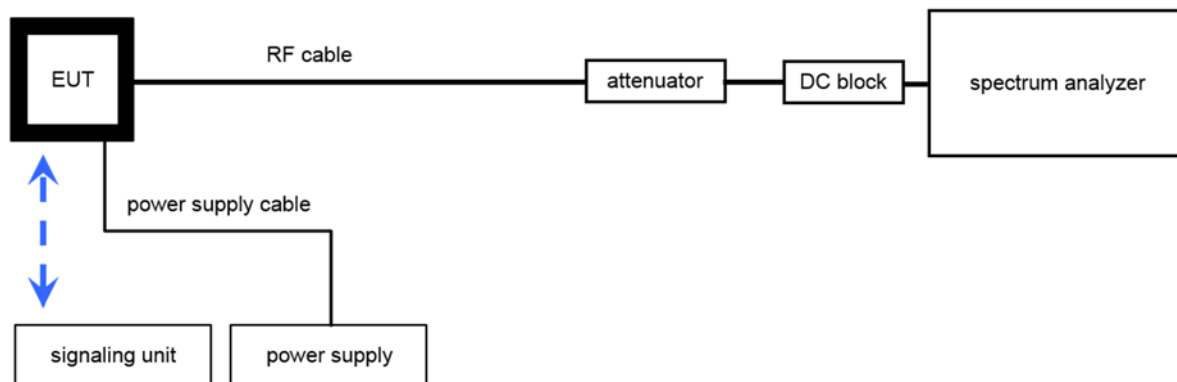
$$FS [dB\mu V/m] = 37.62 [dB\mu V/m] + 9.90 [dB] + 0.23 [dB] = 47.75 [dB\mu V/m] (244.06 \mu V/m)$$

Equipment table:

No.	Lab / Item	Equipment	Type	Manufacturer	Serial No.	INV. No Cetecom	Kind of Calibration	Last Calibration	Next Calibration
1	A	Two-line V-Network (LISN) 9 kHz to 30 MHz	ESH3-Z5	R&S	892475/017	300002209	k	17.06.2014	17.06.2016
2	A	MXE EMI Receiver 20 Hz to 26,5 GHz	N9038A	Agilent Technologies	MY51210197	300004405	k	06.03.2015	06.03.2016
3	A	software	SPS_PHE 1.4f	Spitzenberger & Spiess	B5981; 5D1081; B5979	300000210	ne	-/-	-/-

7.5 Conducted measurements

Conducted measurements normal conditions



$$OP = AV + CA$$

(OP-output power; AV-analyzer value; CA-loss signal path)

Example calculation:

$$OP \text{ [dBm]} = 6.0 \text{ [dBm]} + 11.7 \text{ [dB]} = 17.7 \text{ [dBm]} \text{ (58.88 mW)}$$

Equipment table:

No.	Lab / Item	Equipment	Type	Manufacturer	Serial No.	INV. No Cetecom	Kind of Calibration	Last Calibration	Next Calibration
1	A	Signal Analyzer 40 GHz	FSV40	R&S	101042	300004517	k	21.01.2016	21.01.2017
2	A	Teststand	Teststand Custom Sequence Editor	National Instruments GmbH	2V2403033A4523	300004590	ne	-/-	-/-
3	A	RF-Cable	ST18/SMAm/SMAm/60	Huber & Suhner	Batch no. 606844	400001181	ev	-/-	-/-
4	A	DC-Blocker 0.1-40 GHz	8141A	Inmet	Batch no. 127377	400001185	ev	-/-	-/-
5	A	Coax Attenuator 10 dB 2W 0-40 GHz	MCL BW-K10-2W44+	Mini Circuits	Batch no. 127377	400001186	ev	-/-	-/-
6	A	Power Sensor 10 MHz to 18 GHz	NRP-Z22	R&S	100039	400000189	k	17.09.2014	17.09.2016
7	A	Power Supply 0-20V, 0-5A	6632B	Agilent Technologies	GB42110541	400000562	vIKI!	26.01.2016	26.01.2019
8	A	PC-WLAN Tester	Intel Core i3 3220/3,3 GHz, Prozessor	Agilent Technologies	2V2403033A4523	300004589	ne	-/-	-/-
9	A	Switch / Control Unit	3488A	HP	2719A15013	300000151	ne	-/-	-/-

8 Sequence of testing

8.1 Sequence of testing radiated spurious 9 kHz to 30 MHz

Setup

- The equipment is set up to simulate normal operation mode as described in the user manual or defined by the manufacturer.
- If the EUT is a tabletop system, a 2-axis positioner with 1.5 m height is used.
- If the EUT is a floor standing device, it is placed directly on the turn table.
- Auxiliary equipment and cables are positioned to simulate normal operation conditions as described in ANSI C 63.4.
- The AC power port of the EUT (if available) is connected to a power outlet below the turntable.
- Measurement distance is 3 m (see ANSI C 63.4) – see test details.
- EUT is set into operation.

Premeasurement

- The turntable rotates from 0° to 315° using 45° steps.
- The antenna height is 1.5 m.
- At each turntable position the analyzer sweeps with positive-peak detector to find the maximum of all emissions.

Final measurement

- Identified emissions during the premeasurement are maximized by the software by rotating the turntable from 0° to 360°. In case of the 2-axis positioner is used the elevation axis is also rotated from 0° to 360°.
- The final measurement is done in the position (turntable and elevation) causing the highest emissions with quasi-peak (as described in ANSI C 63.4).
- Final levels, frequency, measuring time, bandwidth, turntable position, correction factor, margin to the limit and limit will be recorded. A plot with the graph of the premeasurement and the limit is stored.

8.2 Sequence of testing radiated spurious 30 MHz to 1 GHz

Setup

- The equipment is set up to simulate normal operation mode as described in the user manual or defined by the manufacturer.
- If the EUT is a tabletop system, a table with 0.8 m height is used, which is placed on the ground plane.
- If the EUT is a floor standing device, it is placed on the ground plane with insulation between both.
- Auxiliary equipment and cables are positioned to simulate normal operation conditions as described in ANSI C 63.4.
- The AC power port of the EUT (if available) is connected to a power outlet below the turntable.
- Measurement distance is 10 m or 3 m (see ANSI C 63.4) – see test details.
- EUT is set into operation.

Premeasurement

- The turntable rotates from 0° to 315° using 45° steps.
- The antenna is polarized vertical and horizontal.
- The antenna height changes from 1 m to 3 m.
- At each turntable position, antenna polarization and height the analyzer sweeps three times in peak to find the maximum of all emissions.

Final measurement

- The final measurement is performed for at least six highest peaks according to the requirements of the ANSI C63.4.
- Based on antenna and turntable positions at which the peak values are measured the software maximize the peaks by changing turntable position $\pm 45^\circ$ and antenna height between 1 and 4 m.
- The final measurement is done with quasi-peak detector (as described in ANSI C 63.4).
- Final levels, frequency, measuring time, bandwidth, antenna height, antenna polarization, turntable angle, correction factor, margin to the limit and limit are recorded. A plot with the graph of the premeasurement with marked maximum final results and the limit is stored.

8.3 Sequence of testing radiated spurious 1 GHz to 18 GHz

Setup

- The equipment is set up to simulate normal operation mode as described in the user manual or defined by the manufacturer.
- If the EUT is a tabletop system, a 2-axis positioner with 1.5 m height is used.
- If the EUT is a floor standing device, it is placed directly on the turn table.
- Auxiliary equipment and cables are positioned to simulate normal operation conditions as described in ANSI C 63.4.
- The AC power port of the EUT (if available) is connected to a power outlet below the turntable.
- Measurement distance is 3 m (see ANSI C 63.4) – see test details.
- EUT is set into operation.

Premeasurement

- The turntable rotates from 0° to 315° using 45° steps.
- The antenna is polarized vertical and horizontal.
- The antenna height is 1.5 m.
- At each turntable position and antenna polarization the analyzer sweeps with positive peak detector to find the maximum of all emissions.

Final measurement

- The final measurement is performed for at least six highest peaks according to the requirements of the ANSI C63.4.
- Based on antenna and turntable positions at which the peak values are measured the software maximizes the peaks by rotating the turntable from 0° to 360°. This measurement is repeated for different EUT-table positions (0° to 150° in 30°-steps) and for both antenna polarizations.
- The final measurement is done in the position (turntable, EUT-table and antenna polarization) causing the highest emissions with Peak and RMS detector (as described in ANSI C 63.4).
- Final levels, frequency, measuring time, bandwidth, turntable position, EUT-table position, antenna polarization, correction factor, margin to the limit and limit are recorded. A plot with the graph of the premeasurement with marked maximum final results and the limit is stored.

8.4 Sequence of testing radiated spurious above 18 GHz

Setup

- The equipment is set up to simulate normal operation mode as described in the user manual or defined by the manufacturer.
- Auxiliary equipment and cables are positioned to simulate normal operation conditions as described in ANSI C 63.4.
- The AC power port of the EUT (if available) is connected to a power outlet.
- The measurement distance is as appropriate (e.g. 0.5 m).
- The EUT is set into operation.

Premeasurement

- The test antenna is handheld and moved carefully over the EUT to cover the EUT's whole sphere and different polarizations of the antenna.

Final measurement

- The final measurement is performed at the position and antenna orientation causing the highest emissions with Peak and RMS detector (as described in ANSI C 63.4).
- Final levels, frequency, measuring time, bandwidth, correction factor, margin to the limit and limit are recorded. A plot with the graph of the premeasurement and the limit is stored.

9 Measurement uncertainty

Measurement uncertainty	
Test case	Uncertainty
Antenna gain	± 3 dB
Power spectral density	± 1.5 dB
DTS bandwidth	± 100 kHz (depends on the used RBW)
Occupied bandwidth	± 100 kHz (depends on the used RBW)
Maximum output power	± 1.5 dB
Detailed spurious emissions @ the band edge - conducted	± 1.5 dB
Band edge compliance radiated	± 3 dB
Spurious emissions conducted	± 3 dB
Spurious emissions radiated below 30 MHz	± 3 dB
Spurious emissions radiated 30 MHz to 1 GHz	± 3 dB
Spurious emissions radiated 1 GHz to 12.75 GHz	± 3.7 dB
Spurious emissions radiated above 12.75 GHz	± 4.5 dB
Spurious emissions conducted below 30 MHz (AC conducted)	± 2.6 dB

10 Summary of measurement results

<input checked="" type="checkbox"/>	No deviations from the technical specifications were ascertained
<input type="checkbox"/>	There were deviations from the technical specifications ascertained
<input type="checkbox"/>	This test report is only a partial test report. The content and verdict of the performed test cases are listed below.

TC Identifier	Description	Verdict	Date	Remark
RF-Testing	CFR Part 15	See table!	2016-11-14	-/-

Test specification clause	Test case	Guideline	Temperature conditions	Power source voltages	Mode	C	NC	NA	NP	Remark
§15.247(b)(4)	Antenna gain	-/-	Nominal	Nominal	DSSS	-/-				-/-
§15.247(e)	Power spectral density	KDB 558074 DTS clause: 10.2	Nominal	Nominal	DSSS OFDM	<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	-/-
§15.247(a)(2)	DTS bandwidth	KDB 558074 DTS clause: 8.1	Nominal	Nominal	DSSS OFDM	<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	-/-
-/-	Occupied bandwidth	-/-	Nominal	Nominal	DSSS OFDM	<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	-/-
§15.247(b)(3)	Maximum output power	KDB 558074 DTS clause: 9.1.2	Nominal	Nominal	DSSS OFDM	<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	-/-
§15.247(d)	Detailed spurious emissions @ the band edge - conducted	-/-	Nominal	Nominal	DSSS OFDM	<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	-/-
§15.205	Band edge compliance conducted / radiated	KDB 558074 DTS clause: 13.3.2 and clause 12.2.2	Nominal	Nominal	DSSS OFDM	<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	-/-
§15.247(d)	TX spurious emissions conducted	KDB 558074 DTS clause: 11.1 & 11.2 11.3	Nominal	Nominal	DSSS OFDM	<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	-/-
§15.209(a)	TX spurious emissions radiated below 30 MHz	-/-	Nominal	Nominal	DSSS OFDM	<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	-/-
§15.247(d)	TX spurious emissions radiated 30 MHz to 1 GHz	-/-	Nominal	Nominal	DSSS OFDM	<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	-/-
§15.247(d)	TX spurious emissions radiated above 1 GHz	-/-	Nominal	Nominal	DSSS OFDM	<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	-/-
§15.109	RX spurious emissions radiated 30 MHz to 1 GHz	-/-	Nominal	Nominal	RX / idle	<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	-/-
§15.109	RX spurious emissions radiated above 1 GHz	-/-	Nominal	Nominal	RX / idle	<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	-/-
§15.107(a) §15.207	Conducted emissions < 30 MHz	-/-	Nominal	Nominal	DSSS OFDM	<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	-/-

Note: C = Compliant; NC = Not compliant; NA = Not applicable; NP = Not performed

11 Additional comments

Reference documents: None

Special test descriptions: None

Configuration descriptions:

WLAN settings

/btrfs/init_wlan.sh

b - mode:athtestcmd -i wlan0 -tx tx99 -tx freq XXXX -tx rate 0 -tx pwr24 -tx antenna

g - mode:athtestcmd -i wlan0 -tx tx99 -tx freq XXXX -tx rate 4 -tx pwr24 -tx antenna

n HT20 - mode:athtestcmd -i wlan0 -tx tx99 -tx freq XXXX -tx rate 12 -tx pwr16 -tx antenna

Test mode: ☐ No test mode available.
Iperf was used to ping another device with the largest support packet size

☒ Special software is used.
EUT is transmitting pseudo random data by itself

Antennas and transmit operating modes: ☒ Operating mode 1 (single antenna)

- Equipment with 1 antenna,
- Equipment with 2 diversity antennas operating in switched diversity mode by which at any moment in time only 1 antenna is used,
- Smart antenna system with 2 or more transmit/receive chains, but operating in a mode where only 1 transmit/receive chain is used)

☐ Operating mode 2 (multiple antennas, no beamforming)

- Equipment operating in this mode contains a smart antenna system using two or more transmit/receive chains simultaneously but without beamforming.

☐ Operating mode 3 (multiple antennas, with beamforming)

- Equipment operating in this mode contains a smart antenna system using two or more transmit/receive chains simultaneously with beamforming.
In addition to the antenna assembly gain (G), the beamforming gain (Y) may have to be taken into account when performing the measurements.

12 Measurement results**12.1 Duty cycle****Measurement:****Measurement parameters:**

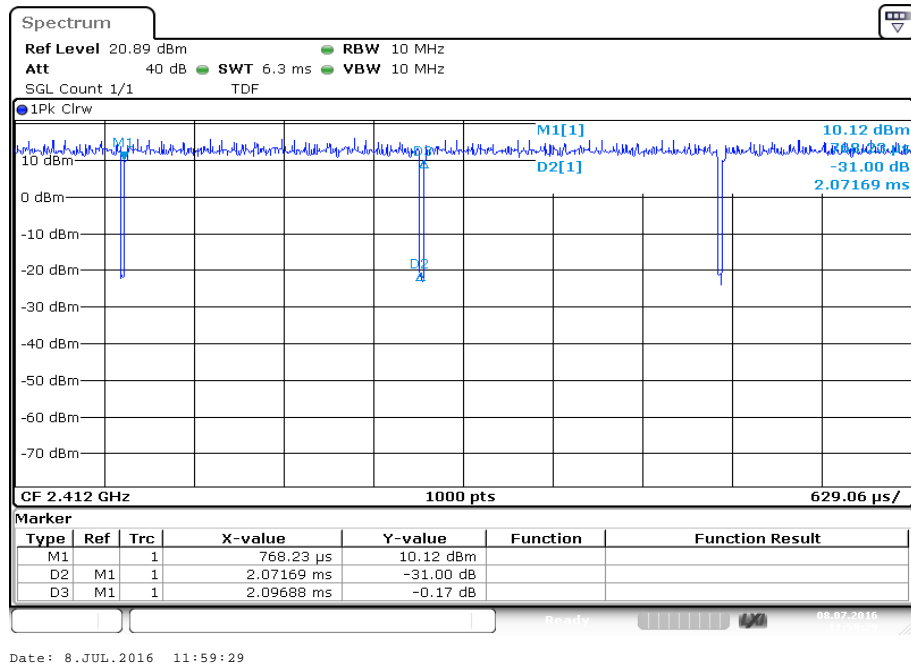
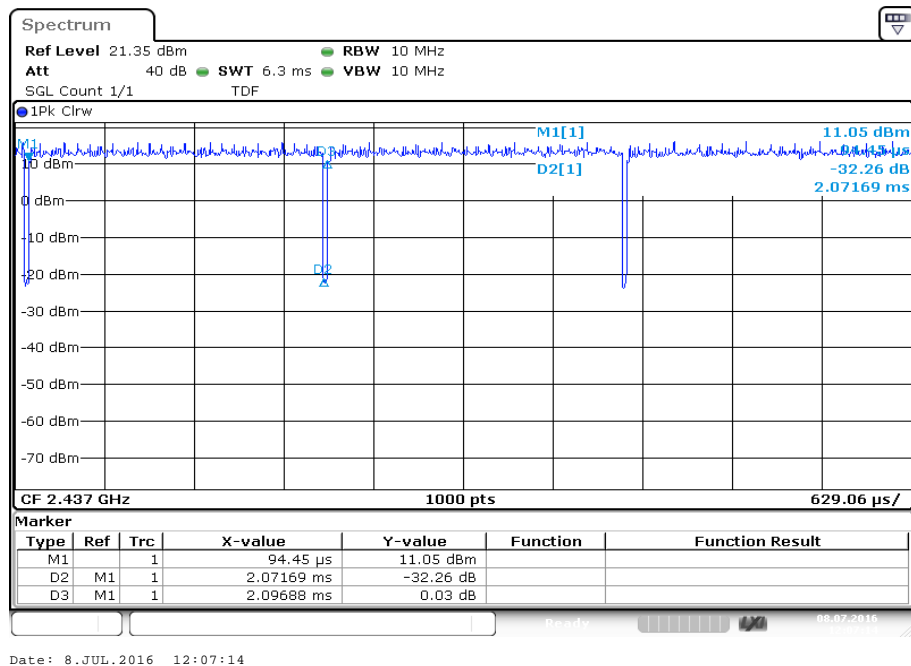
Measurement parameter	
Detector:	Peak
Sweep time:	Depends on the signal see plot
Resolution bandwidth:	10 MHz
Video bandwidth:	10 MHz
Trace mode:	Max hold
Test setup:	See sub clause 7.5 - A
Measurement uncertainty:	See sub clause 9

Limits:

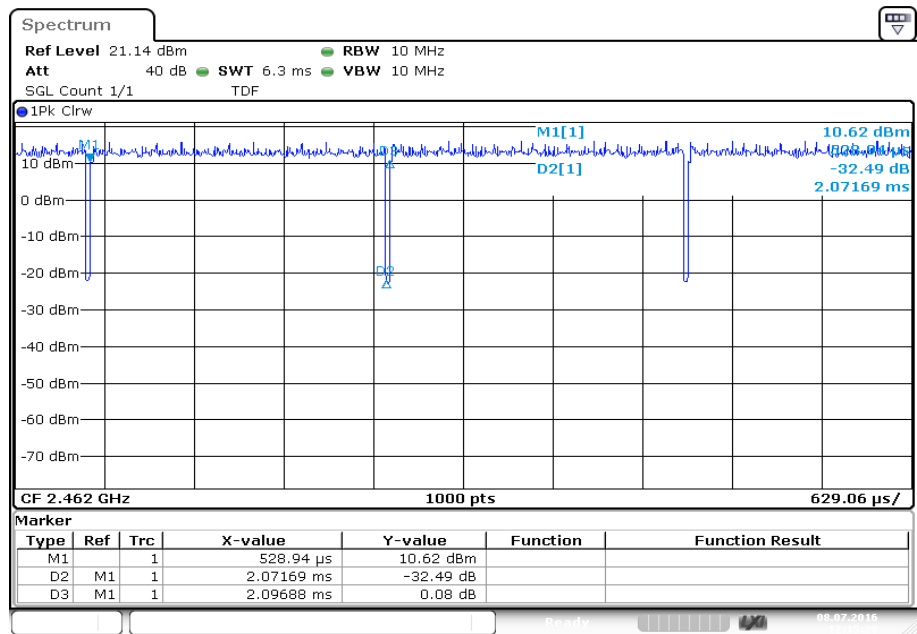
FCC	IC
-/-	

Results:

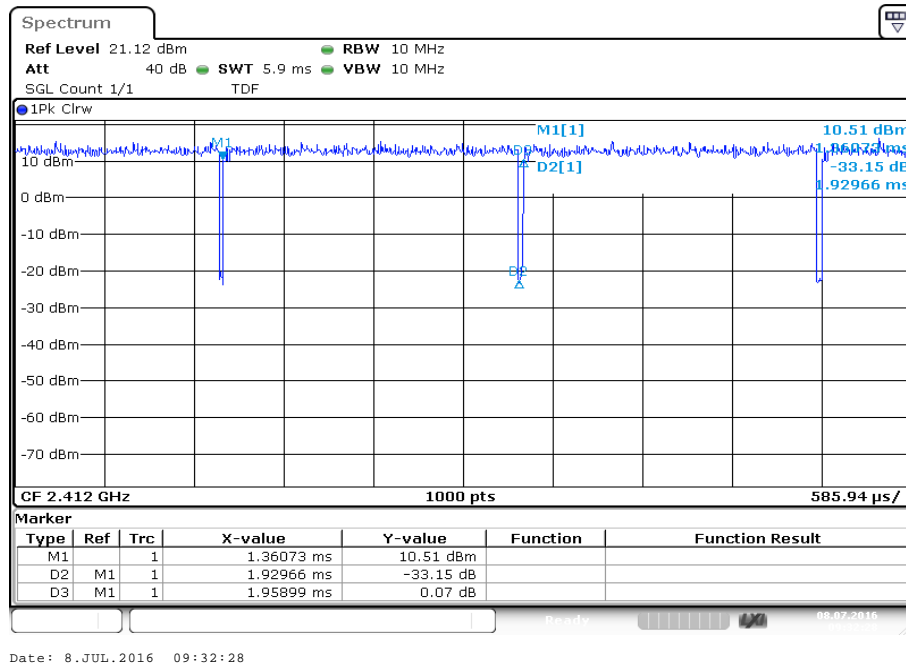
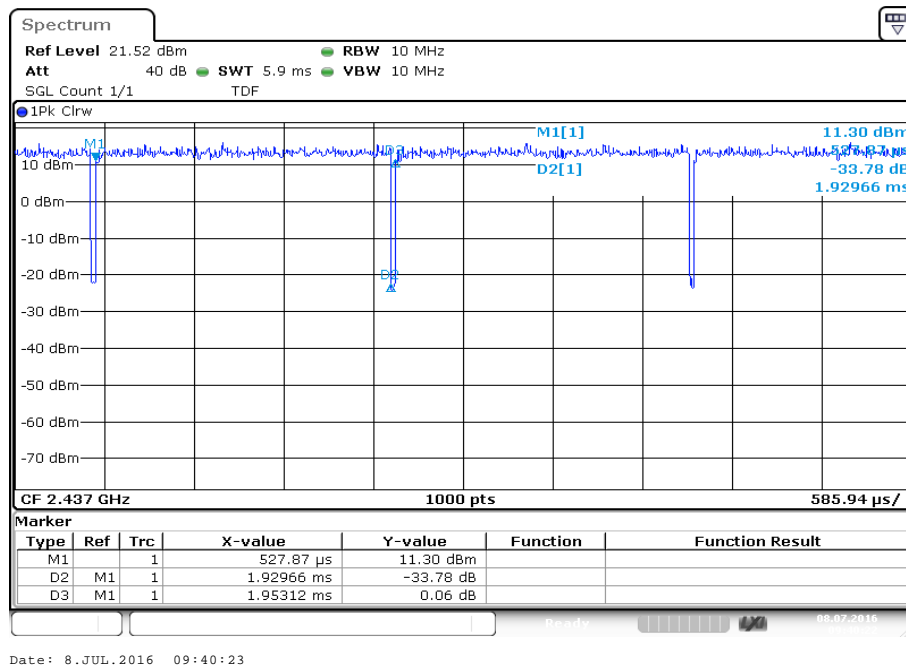
T _{nom}	V _{nom}	lowest channel 2412 MHz	middle channel 2437 MHz	highest channel 2462 MHz
DSSS / b – mode		100 % / 0.00 dB	100 % / 0.00 dB	100 % / 0.00 dB
OFDM / g – mode		98.8 % / 0.05 dB	98.8 % / 0.05 dB	98.8 % / 0.05 dB
OFDM / n HT20 – mode		98.5 % / 0.07 dB	98.8 % / 0.05 dB	98.8 % / 0.05 dB

Plots: OFDM / g – mode**Plot 1:** Lowest channel**Plot 2:** Middle channel

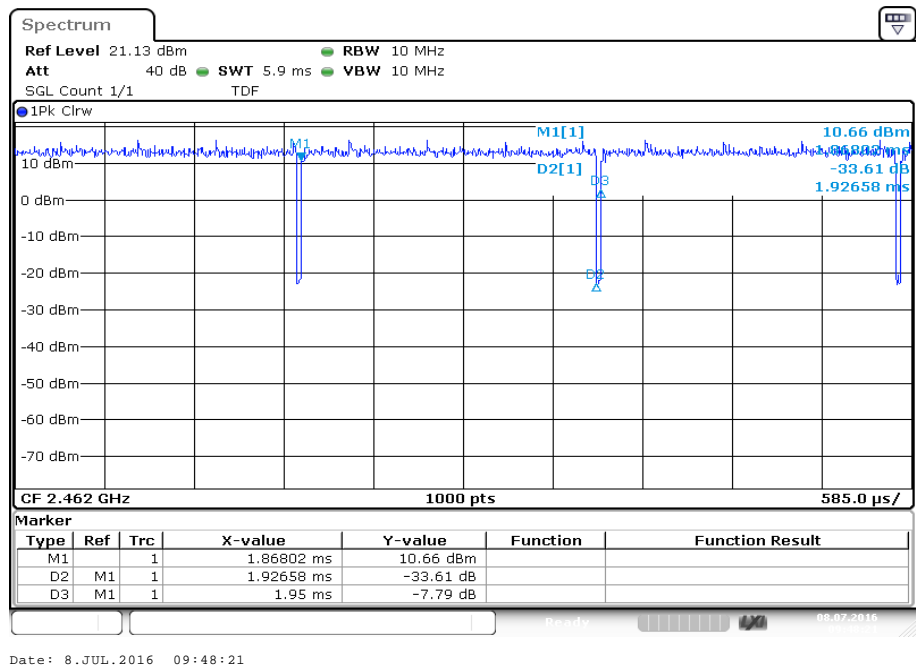
Plot 3: Highest channel



Date: 8.JUL.2016 12:15:29

Plots: OFDM / n HT20 – mode**Plot 1:** Lowest channel**Plot 2:** Middle channel

Plot 3: Highest channel



12.2 Antenna gain

Measurement:

The antenna gain of the complete system is calculated by the difference of radiated power in EIRP and the conducted power of the module. For normal WLAN devices, the DSSS mode is used.

Measurement parameters:

Measurement parameter	
Detector:	Peak
Sweep time:	Auto
Resolution bandwidth:	3 MHz
Video bandwidth:	3 MHz
Trace mode:	Max hold
Test setup:	See sub clause 7.5 – A
Measurement uncertainty:	See sub clause 9

Limits:

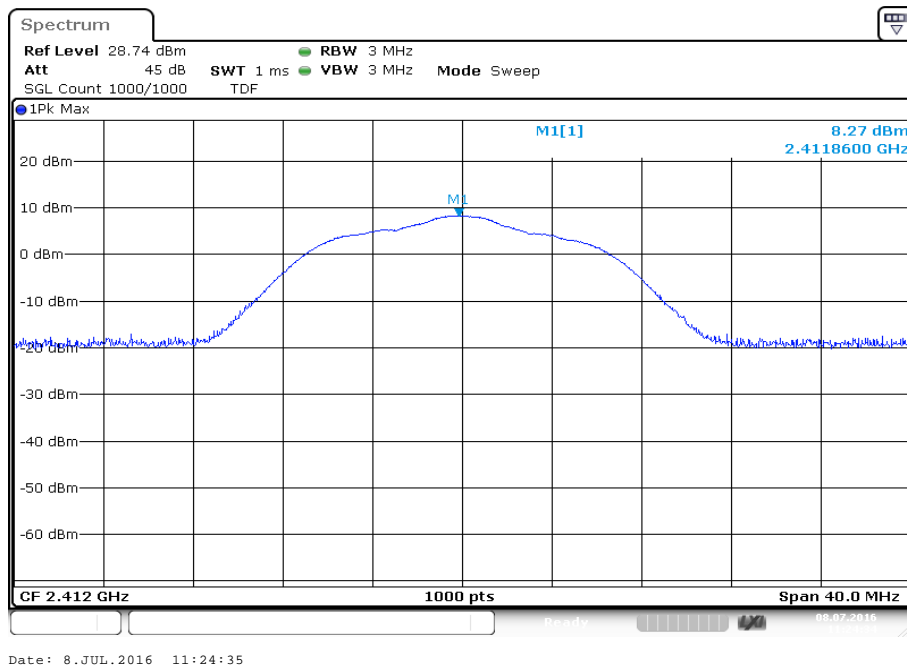
FCC	IC
6 dBi / > 6 dBi output power and power density reduction required	

Results:

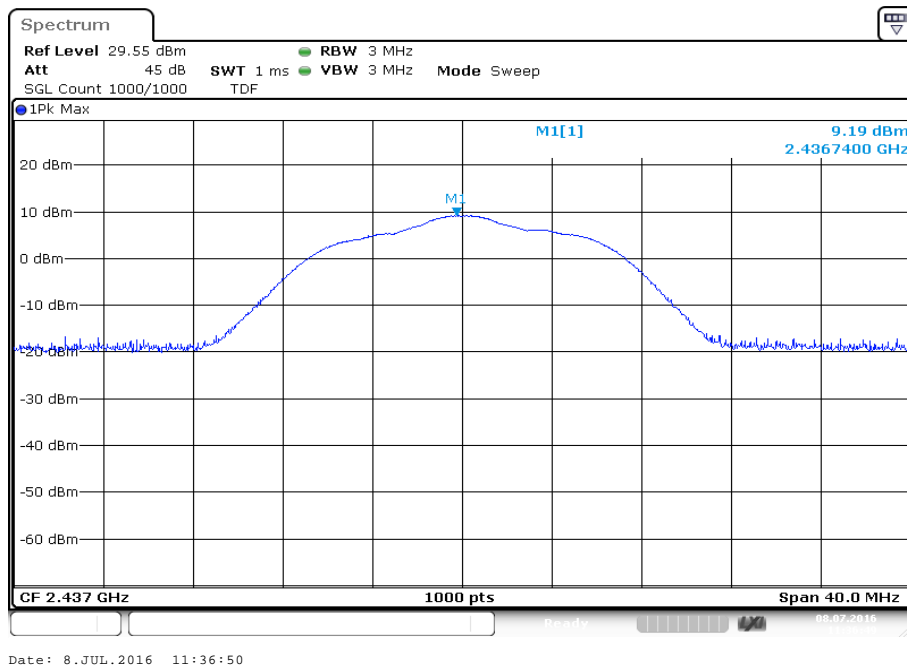
T _{nom}	V _{nom}	lowest channel 2412 MHz	middle channel 2437 MHz	highest channel 2462 MHz
Conducted power [dBm] Measured with DSSS modulation		8.3	9.2	9.0
Radiated power [dBm] Measured with DSSS modulation		11.9	12.9	13.6
Gain [dBi] Calculated		3.6	3.7	4.6

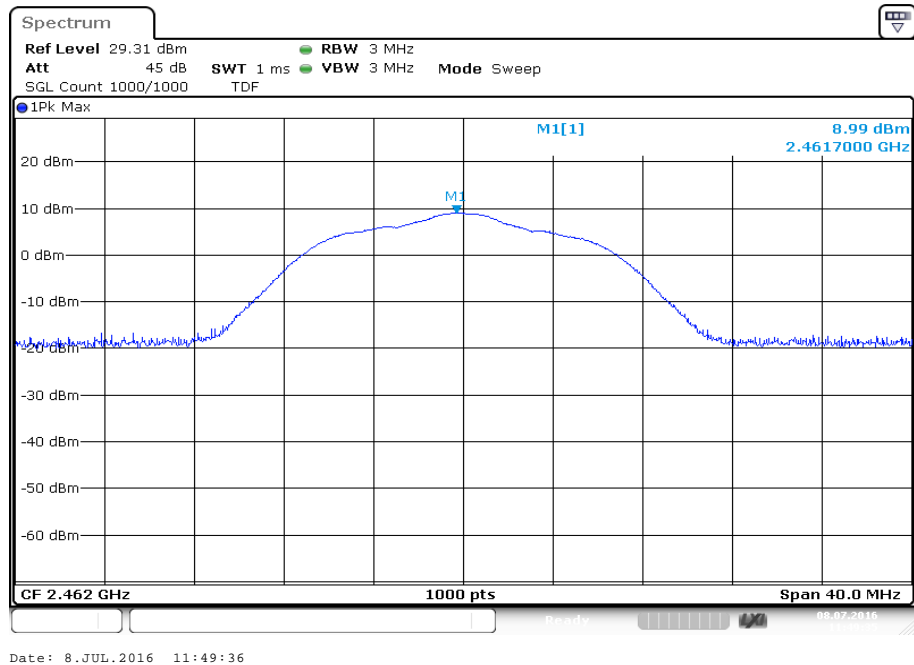
Plots: DSSS / b – mode

Plot 1: Lowest channel



Plot 2: Middle channel



Plot 3: Highest channel

12.3 Identify worst case data rate

Measurement:

All modes of the module will be measured with an average power meter or spectrum analyzer to identify the maximum transmission power.

In further tests only the identified worst case modulation scheme or bandwidth will be measured and this mode is used as representative mode for all other modulation schemes.

Additional the band edge compliance test will be performed in the lowest and highest modulation scheme.

Measurement parameters:

Measurement parameter	
Detector:	Peak
Sweep time:	Auto
Resolution bandwidth:	3 MHz
Video bandwidth:	3 MHz
Trace mode:	Max hold
Test setup:	See sub clause 7.5 – A
Measurement uncertainty:	-/-

Results:

Modulation	Modulation scheme / bandwidth
DSSS / b – mode	1 Mbit/s
OFDM / g – mode	6 Mbit/s
OFDM / n HT20 – mode	MCS0

12.4 Maximum output power

Description:

Measurement of the maximum output power conducted and radiated. The measurements are performed using the data rate producing the highest conducted output power.

Measurement:

Measurement parameter	
According to DTS clause: 9.1.2	
peak power meter	
Test setup:	See sub clause 7.5 – A
Measurement uncertainty	See sub clause 9

Limits:

FCC	IC
Conducted: 1.0 W – Antenna gain with max. 6 dBi	

Results:

Frequency	Maximum Output Power [dBm]		
	2412 MHz	2437 MHz	2462 MHz
Output power conducted DSSS / b – mode	12.2	13.0	12.9
Output power conducted OFDM / g – mode	19.0	19.1	19.0
Output power conducted OFDM / n HT20 – mode	19.0	19.0	18.9

12.5 Peak power spectral density

Description:

Measurement of the power spectral density of a digital modulated system. The measurement is repeated for both modulations at the lowest, middle and highest channel.

Measurement:

Measurement parameter	
According to DTS clause: 10.2	
Detector:	Positive Peak
Sweep time:	Auto
Resolution bandwidth:	100 kHz
Video bandwidth:	300 kHz
Span:	30 MHz
Trace mode:	Max hold (allow trace to fully stabilize)
Test setup:	See sub clause 7.5 – A
Measurement uncertainty	See sub clause 9

Limits:

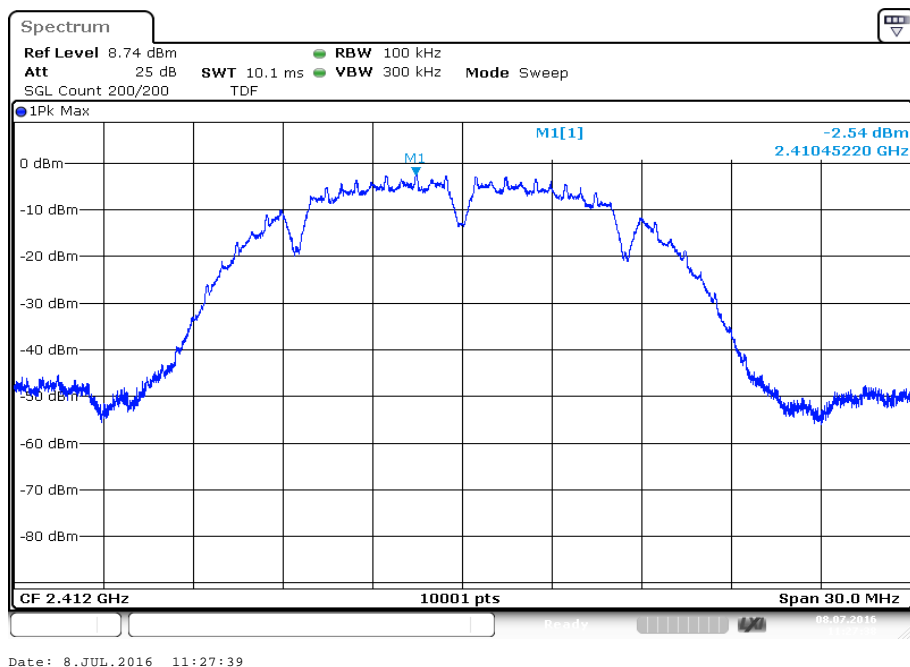
FCC	IC
8 dBm / 3kHz (conducted)	

Results:

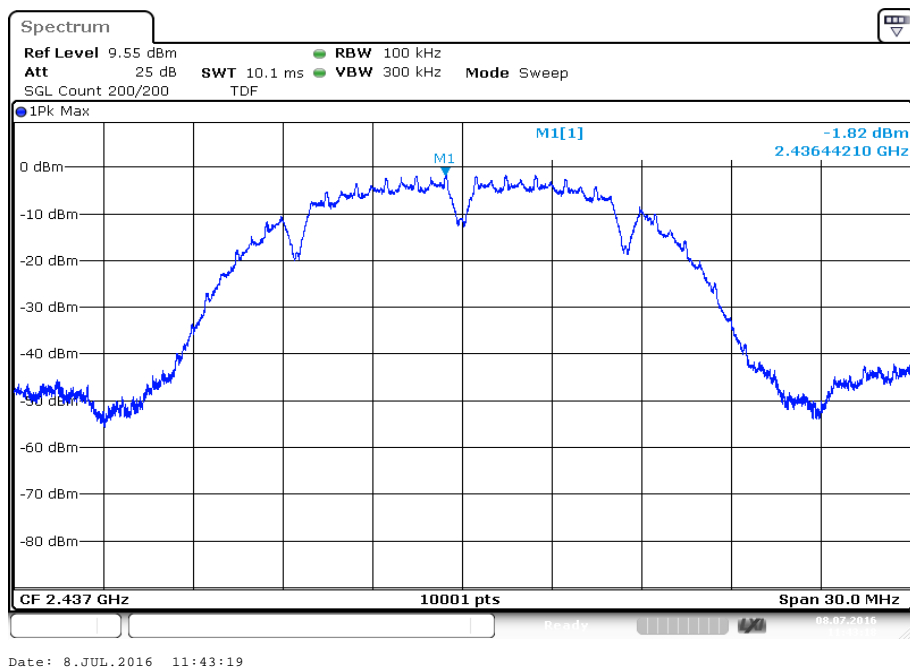
Modulation Frequency	Peak power spectral density [dBm]		
	2412 MHz	2437 MHz	2462 MHz
DSSS / b – mode	-2.54	-1.82	-1.62
OFDM / g – mode	-1.66	-0.98	-1.42
OFDM / n HT20 – mode	-1.62	-0.85	-1.54

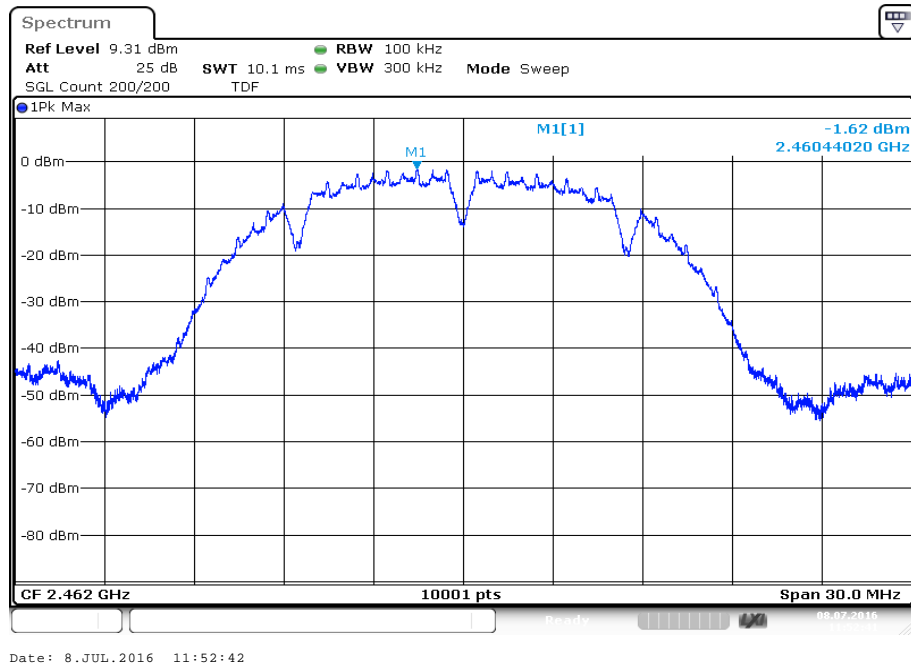
Plots: DSSS / b – mode

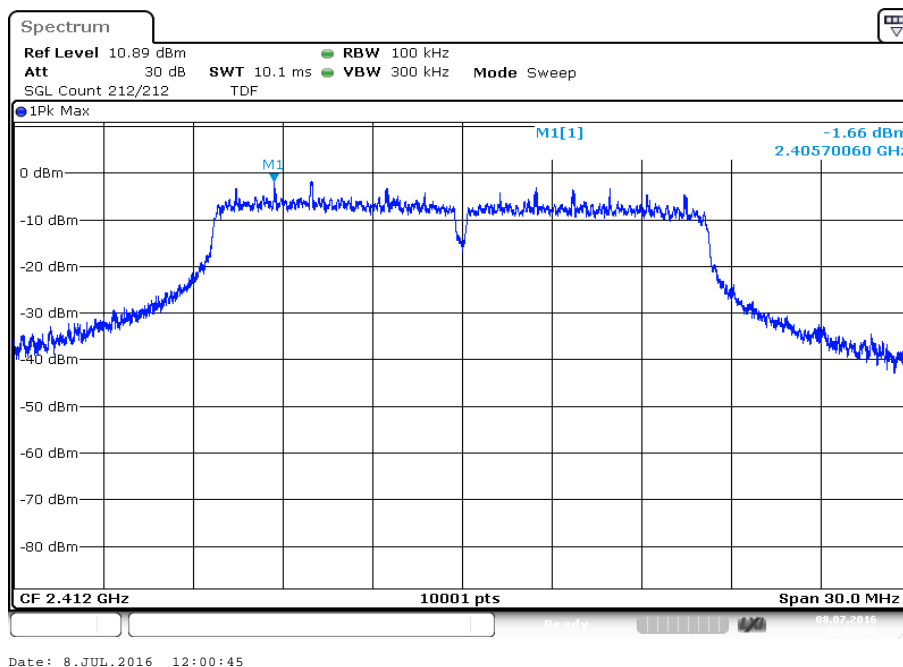
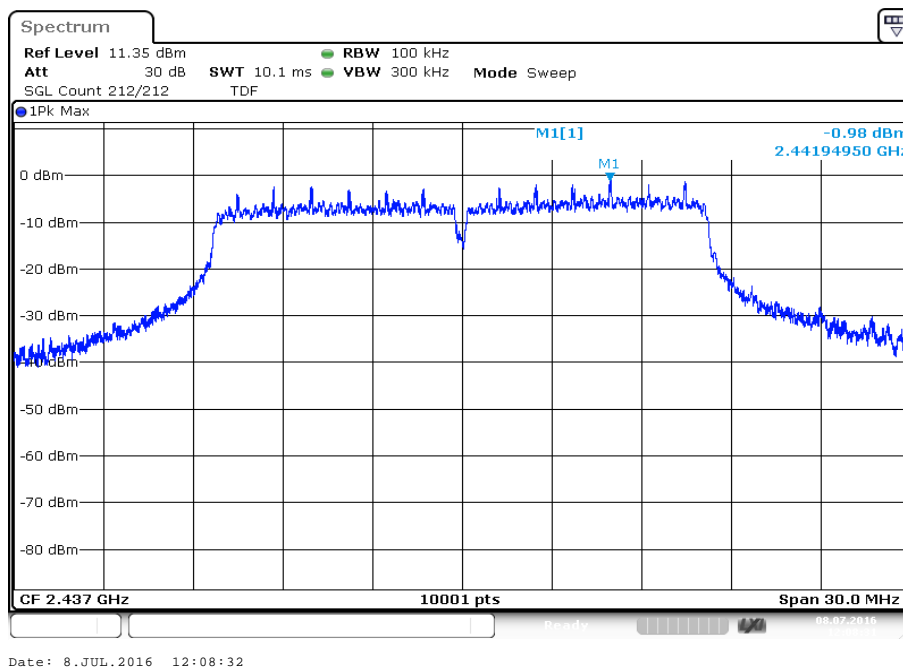
Plot 1: Lowest channel

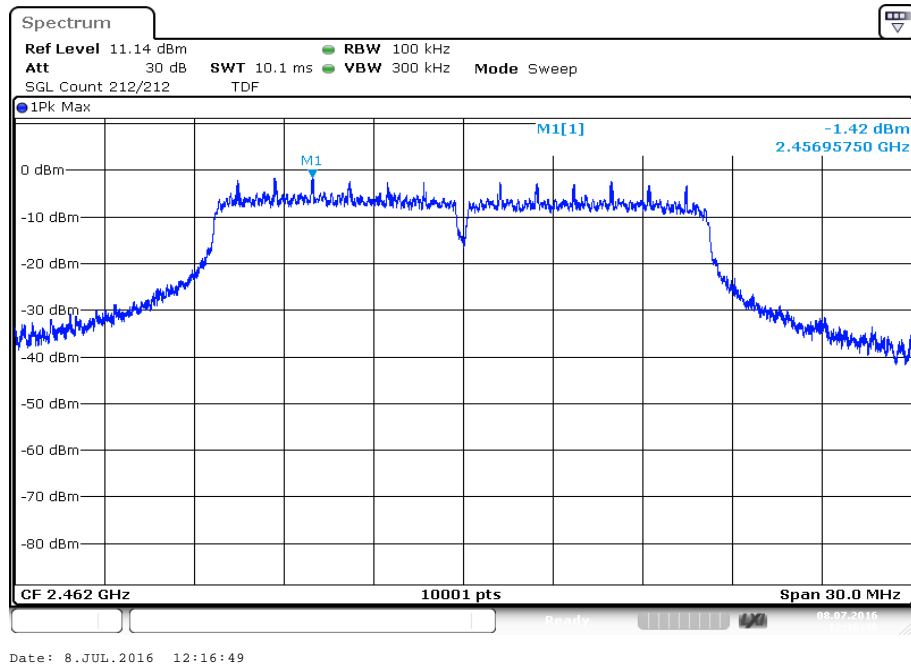


Plot 2: Middle channel



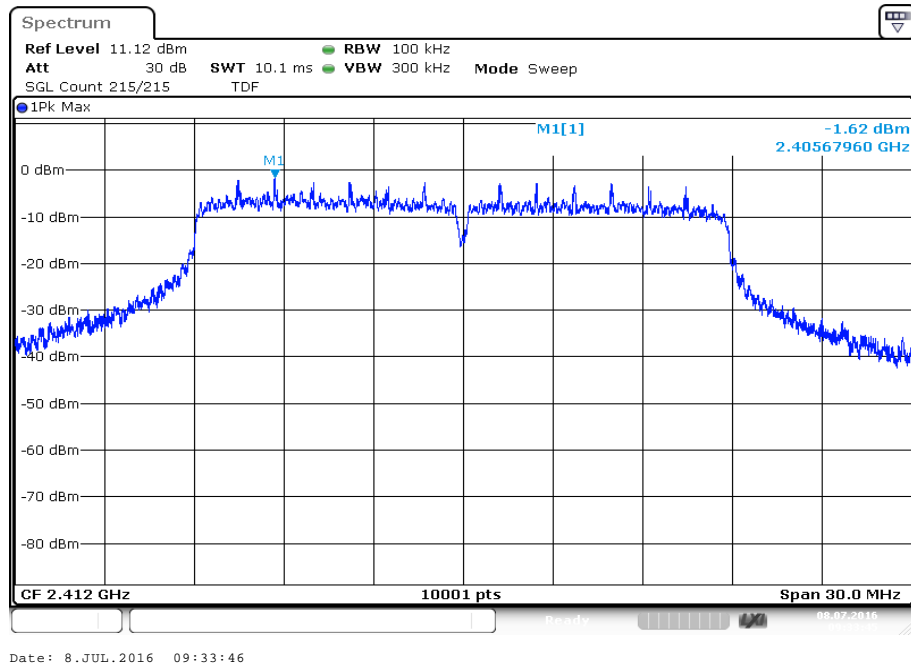
Plot 3: Highest channel

Plots: OFDM / g – mode**Plot 1:** Lowest channel**Plot 2:** Middle channel

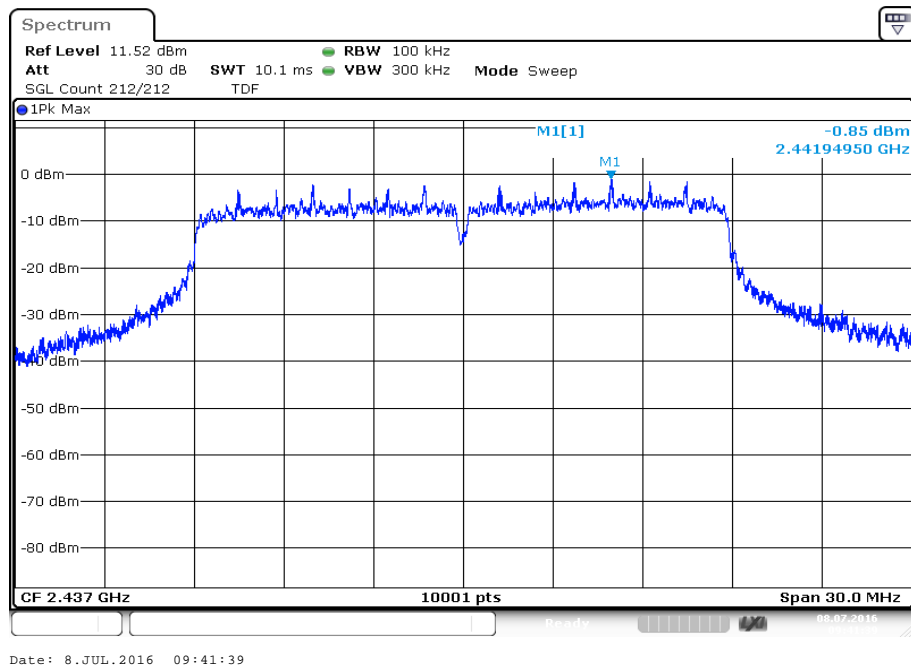
Plot 3: Highest channel

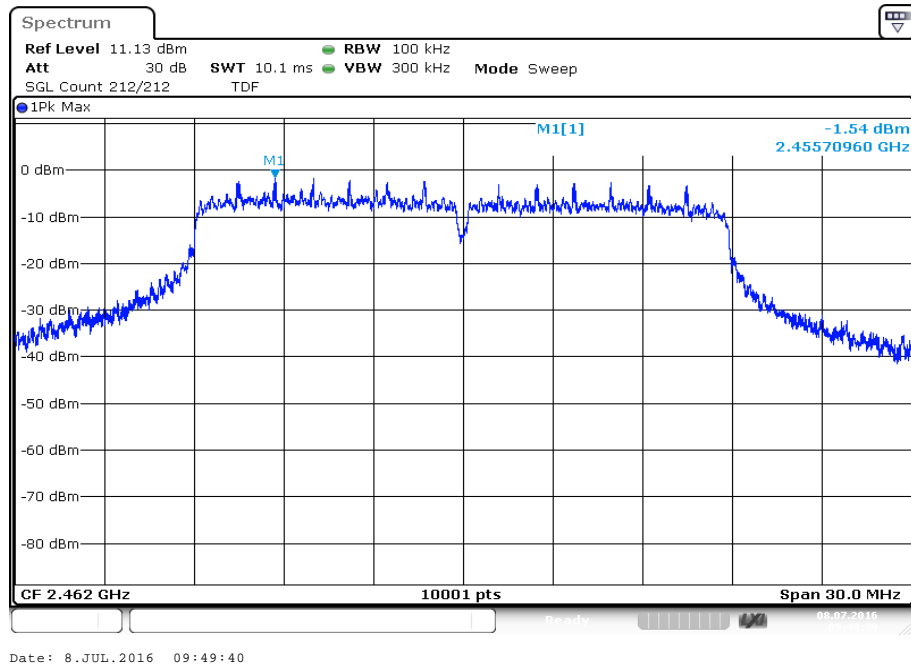
Plots: OFDM / n HT20 – mode

Plot 1: Lowest channel



Plot 2: Middle channel



Plot 3: Highest channel

12.6 6 dB DTS bandwidth

Description:

Measurement of the 6 dB bandwidth of the modulated signal.

Measurement:

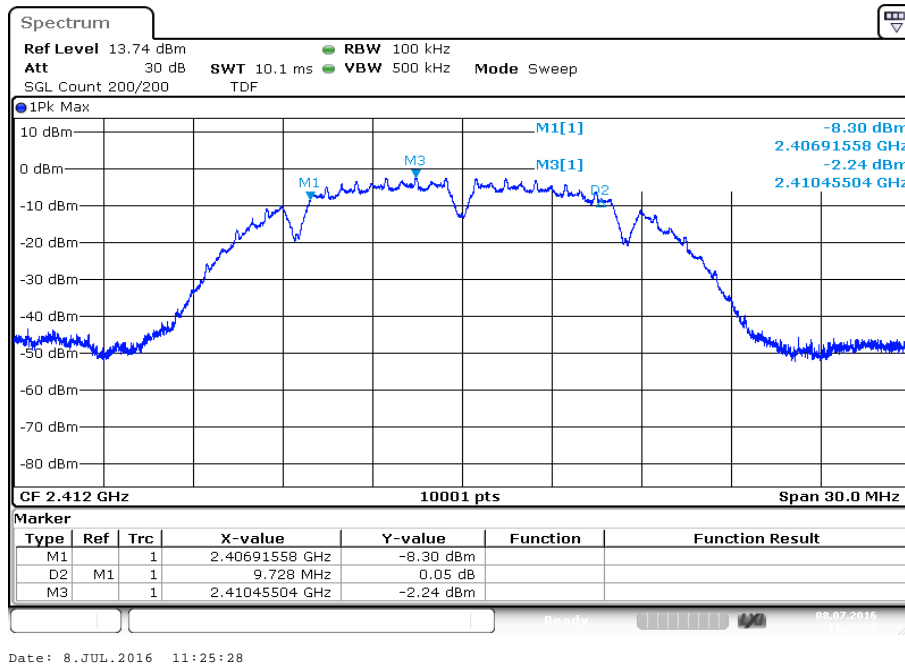
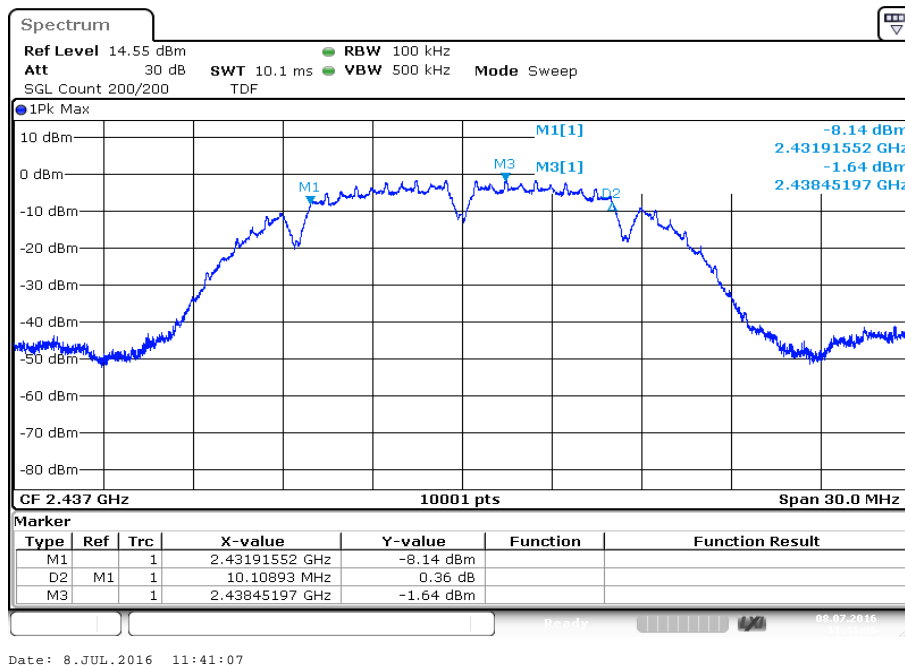
Measurement parameter	
According to DTS clause: 8.1	
Detector:	Peak
Sweep time:	Auto
Resolution bandwidth:	100 kHz
Video bandwidth:	500 kHz
Span:	30 MHz / 50 MHz
Measurement procedure:	Measurement of the 75% bandwidth using the integration function of the analyzer
Trace mode:	Single count with 200 counts
Test setup:	See sub clause 7.5 – A
Measurement uncertainty	See sub clause 9

Limits:

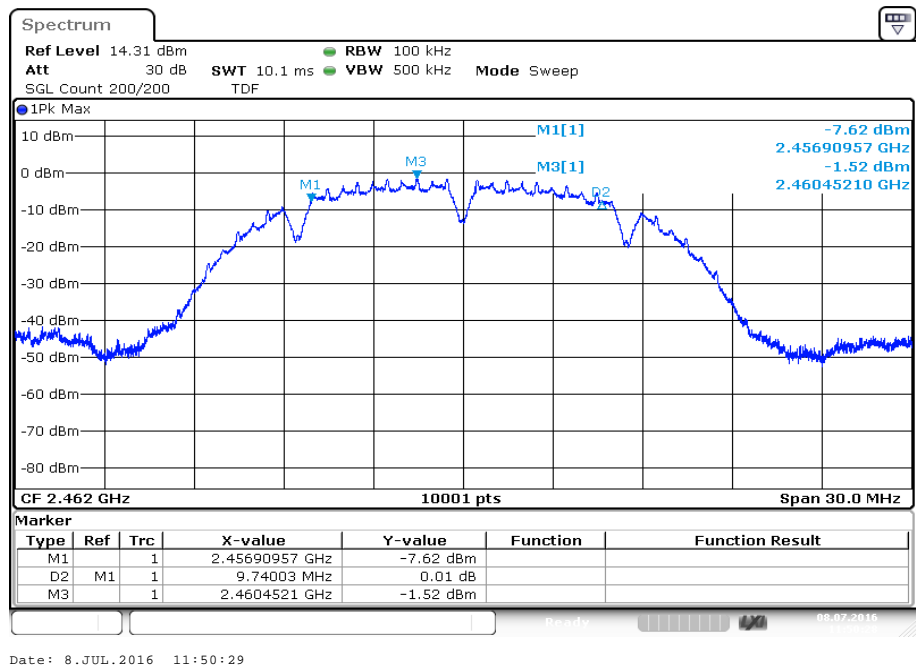
FCC	IC
Systems using digital modulation techniques may operate in the 2400–2483.5 MHz band. The minimum 6 dB bandwidth shall be at least 500 kHz.	

Results:

Frequency	6 dB DTS bandwidth [kHz]		
	2412 MHz	2437 MHz	2462 MHz
DSSS / b – mode	9728	10109	9740
OFDM / g – mode	15718	15926	16063
OFDM / n HT20 – mode	17161	16666	17173

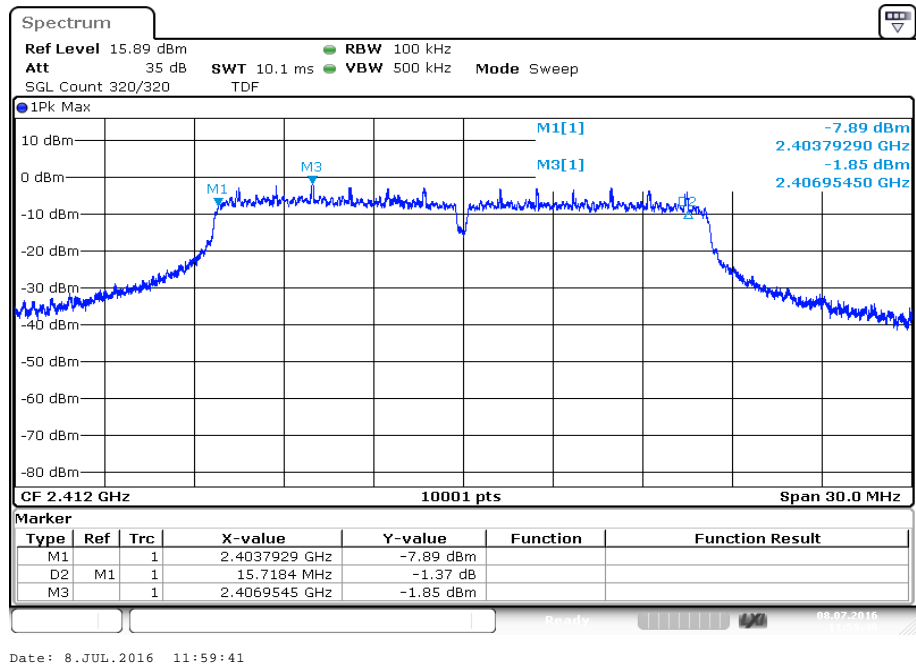
Plots: DSSS / b – mode**Plot 1:** Lowest channel**Plot 2:** Middle channel

Plot 3: Highest channel

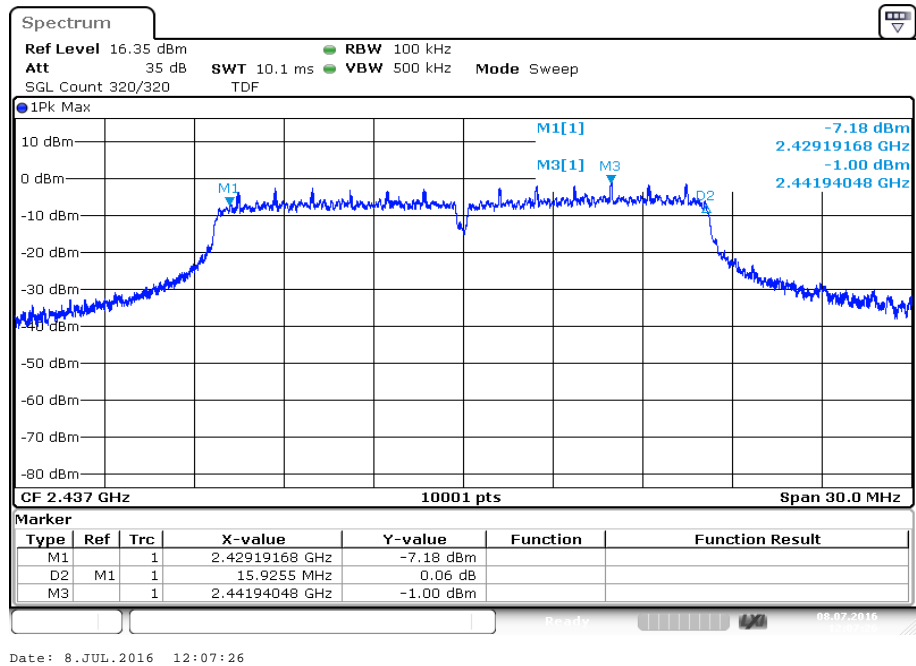


Plots: OFDM / g – mode

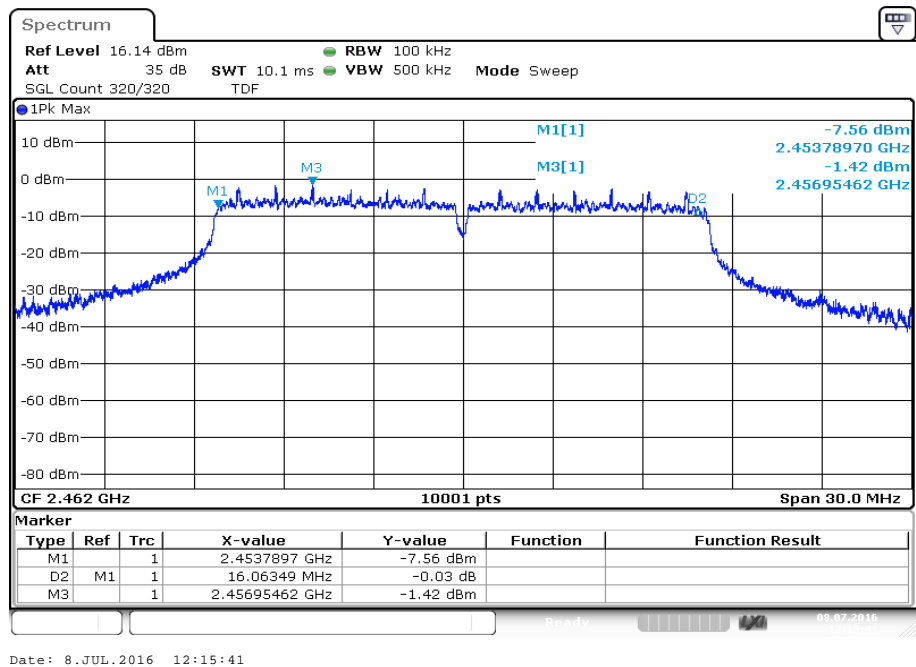
Plot 1: Lowest channel

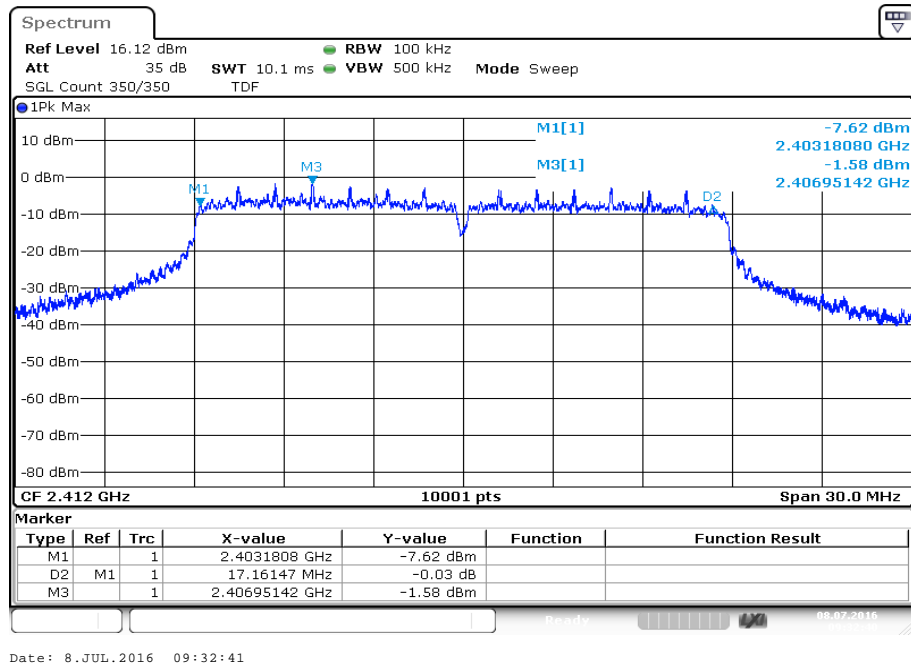
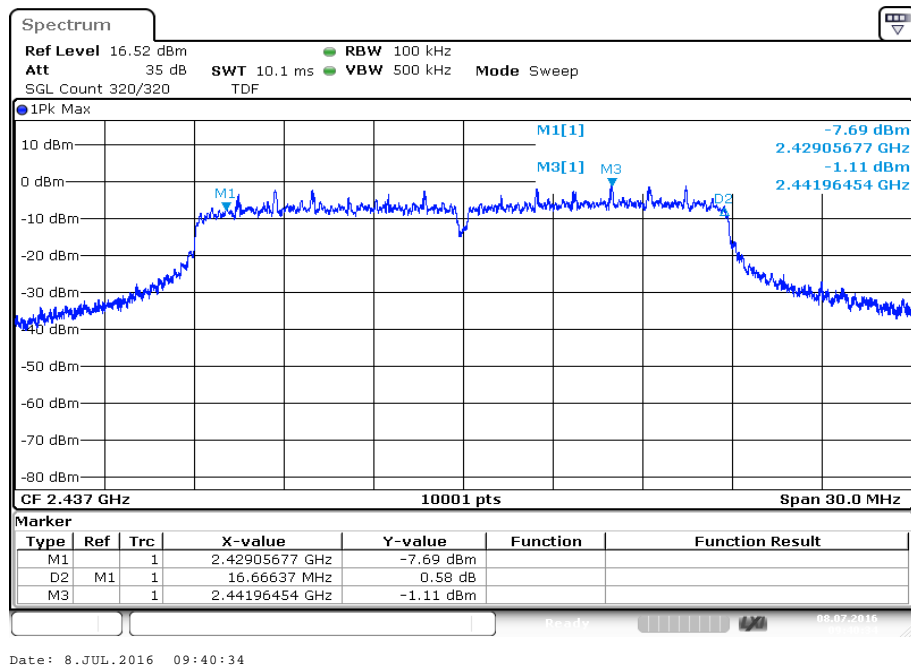


Plot 2: Middle channel

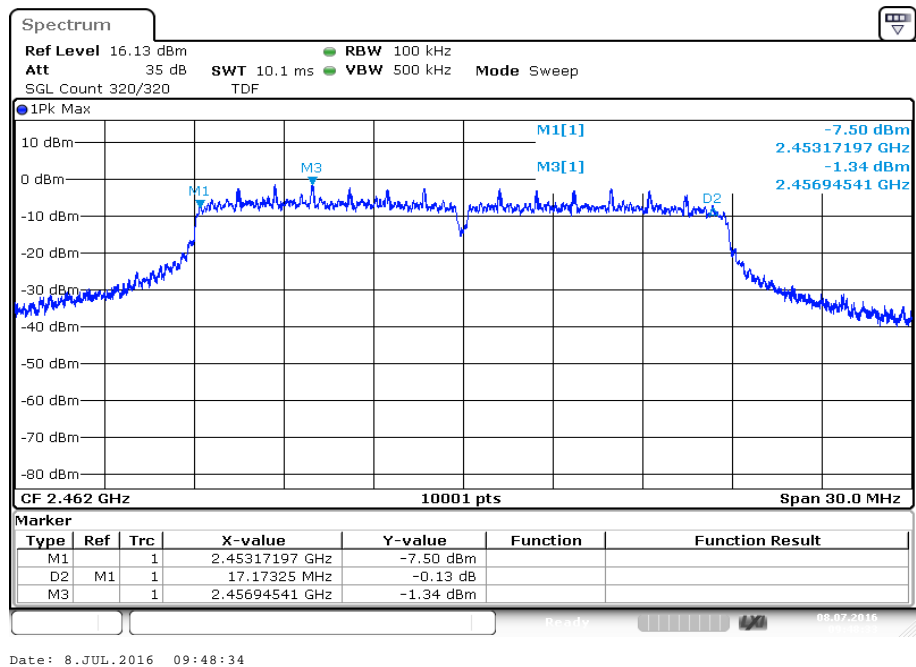


Plot 3: Highest channel



Plots: OFDM / n HT20 – mode**Plot 1:** Lowest channel**Plot 2:** Middle channel

Plot 3: Highest channel



12.7 Occupied bandwidth – 99% emission bandwidth

Description:

Measurement of the 99% bandwidth of the modulated signal acc. RSS-GEN.

Measurement:

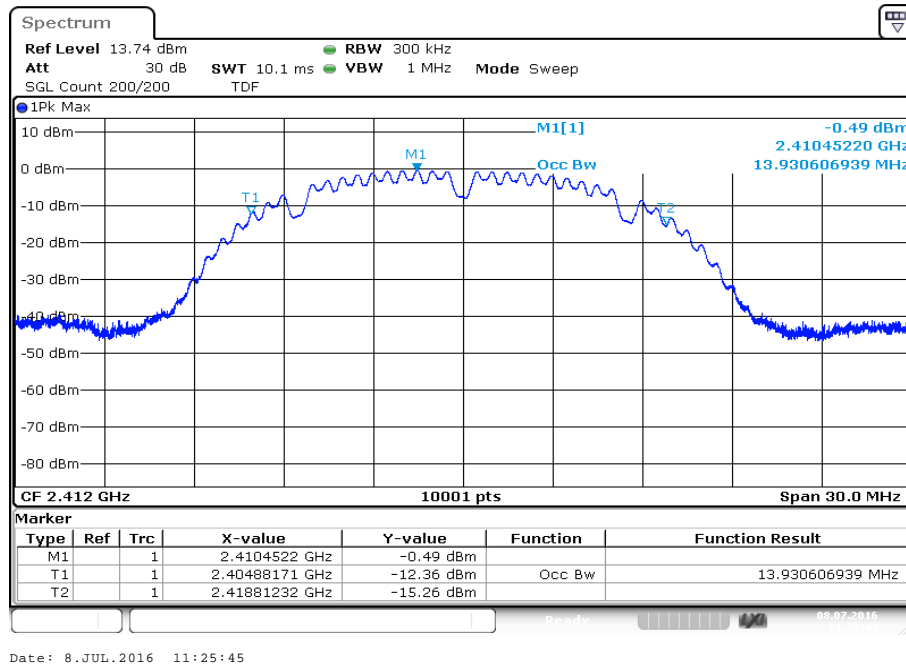
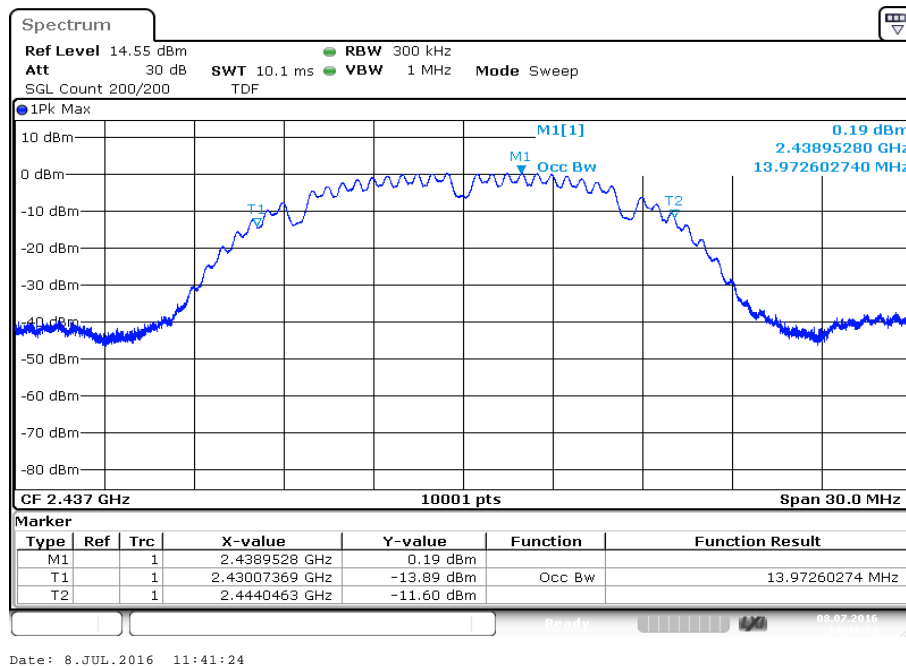
Measurement parameter	
Detector:	Peak
Sweep time:	Auto
Resolution bandwidth:	300 kHz
Video bandwidth:	1 MHz
Span:	30 MHz / 50 MHz
Measurement procedure:	Measurement of the 99% bandwidth using the integration function of the analyzer
Trace mode:	Single count with 200 counts
Test setup:	See sub clause 7.5 – A
Measurement uncertainty	See sub clause 9

Usage:

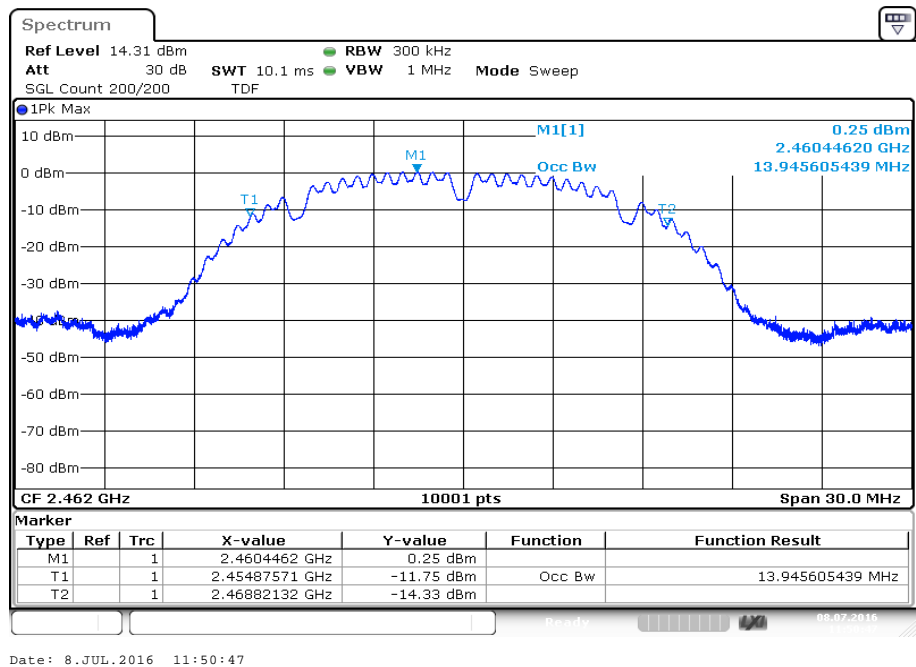
-/-	IC
OBW is necessary for Emission Designator	

Results:

Modulation Frequency	99% bandwidth [kHz]		
	2412 MHz	2437 MHz	2462 MHz
DSSS / b – mode	13931	13973	13946
OFDM / g – mode	16942	16882	16966
OFDM / n HT20 – mode	18031	18013	18046

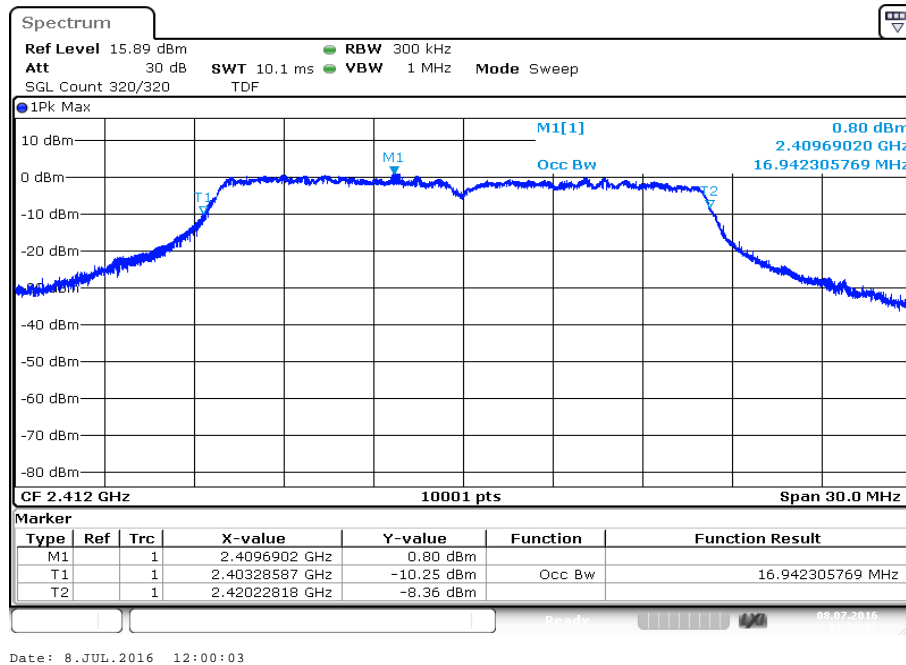
Plots: DSSS / b – mode**Plot 1:** Lowest channel**Plot 2:** Middle channel

Plot 3: Highest channel

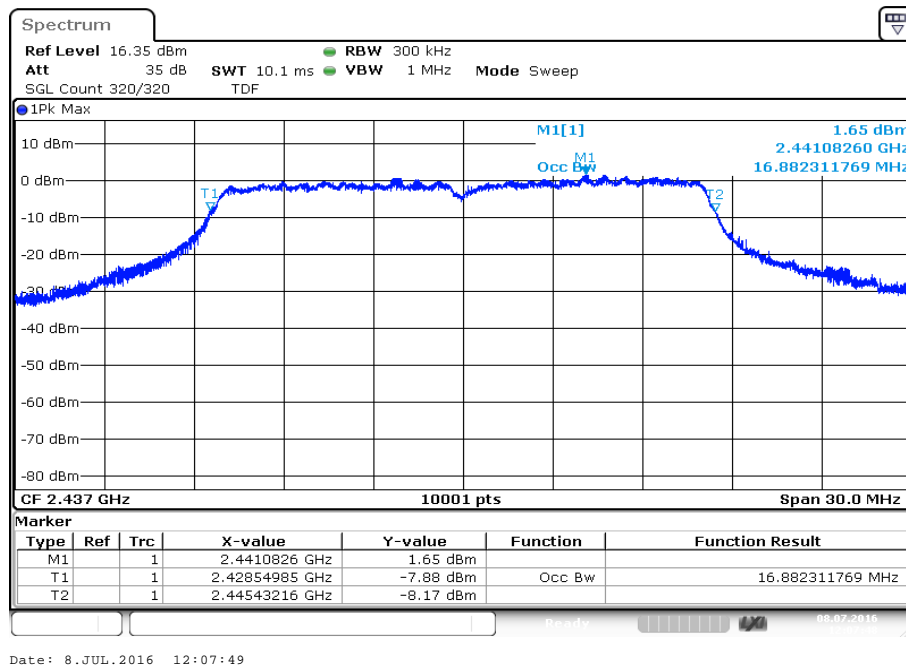


Plots: OFDM / g – mode

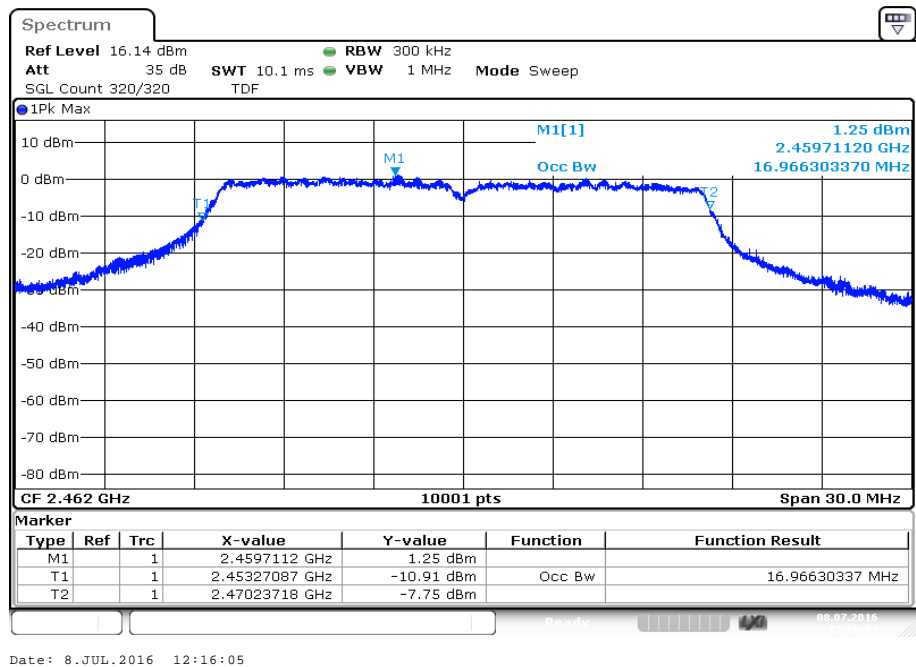
Plot 1: Lowest channel

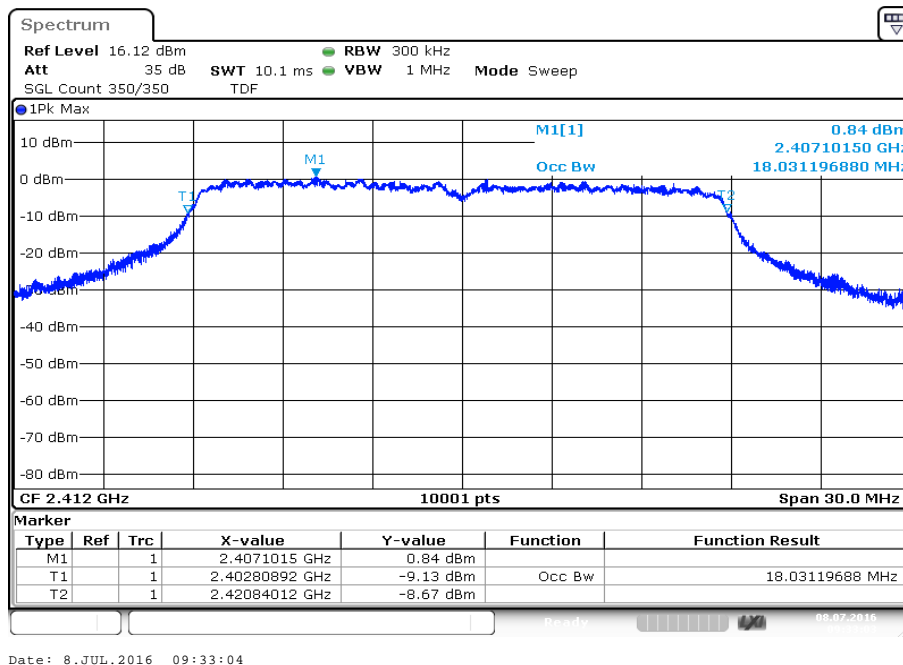
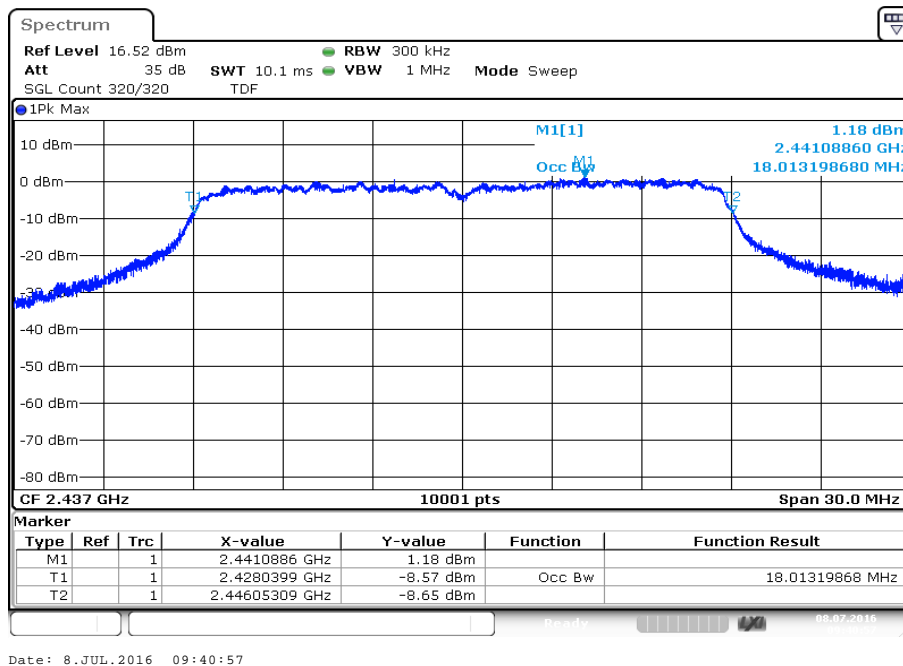


Plot 2: Middle channel

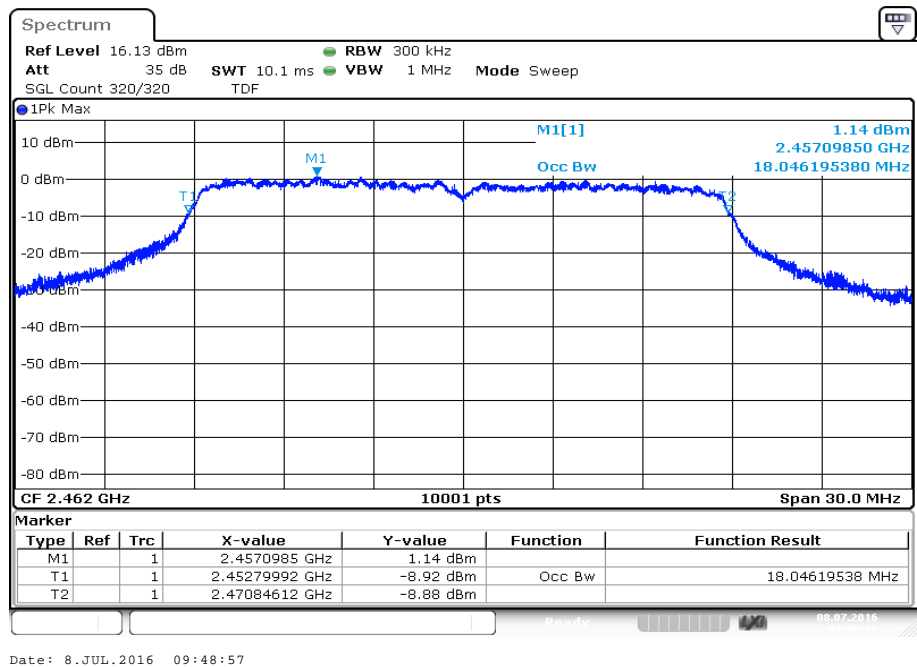


Plot 3: Highest channel



Plots: OFDM / n HT20 – mode**Plot 1:** Lowest channel**Plot 2:** Middle channel

Plot 3: Highest channel



12.8 Occupied bandwidth – 20 dB bandwidth

Description:

Measurement of the 20 dB bandwidth of the modulated carrier.

Measurement:

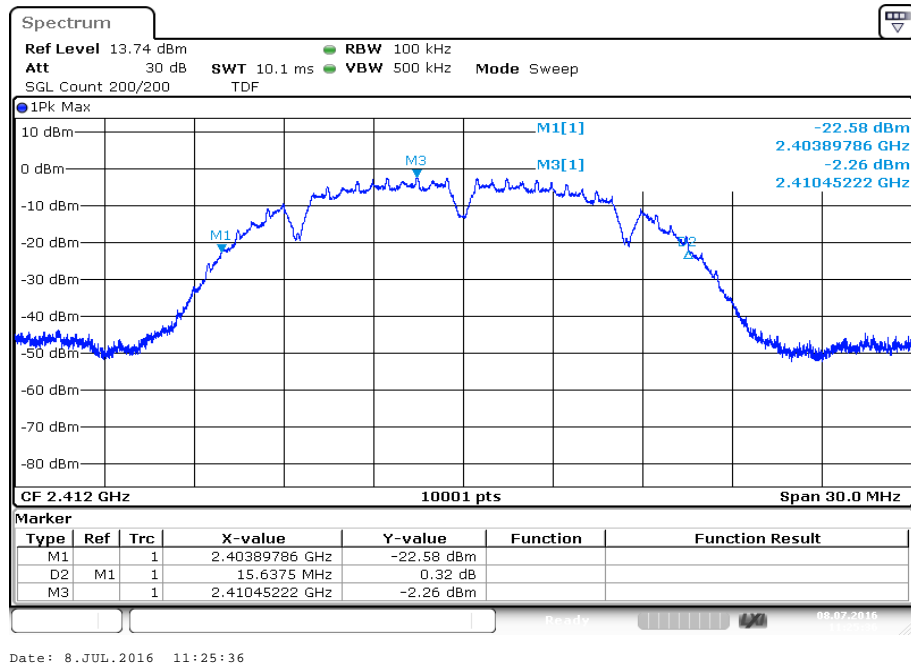
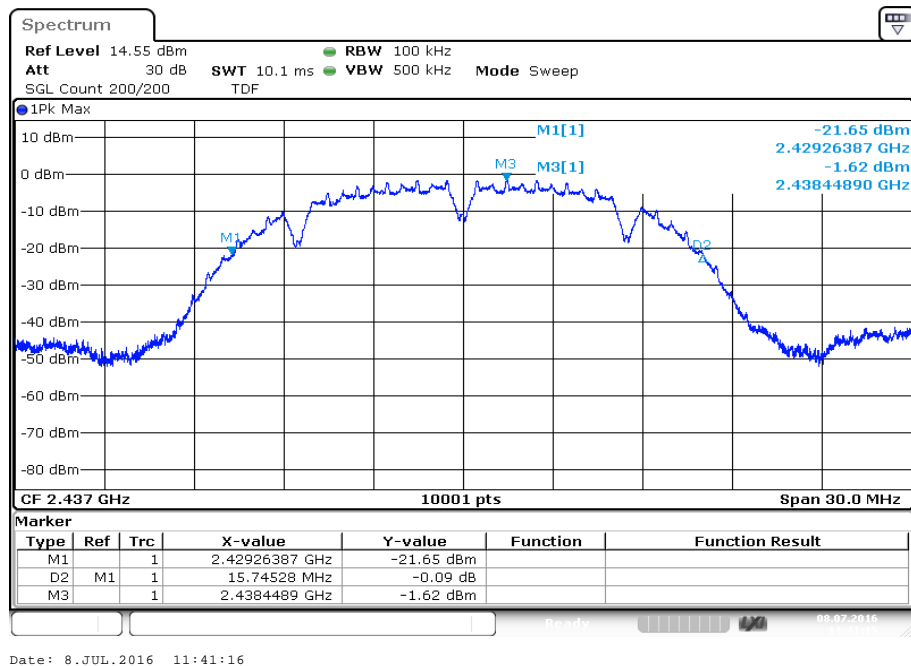
Measurement parameter	
Detector:	Peak
Sweep time:	Auto
Resolution bandwidth:	100 kHz
Video bandwidth:	500 kHz
Span:	30 MHz / 50 MHz
Trace mode:	Single count with min. 200 counts
Test setup:	See sub clause 7.5 – A
Measurement uncertainty	See sub clause 9

Usage:

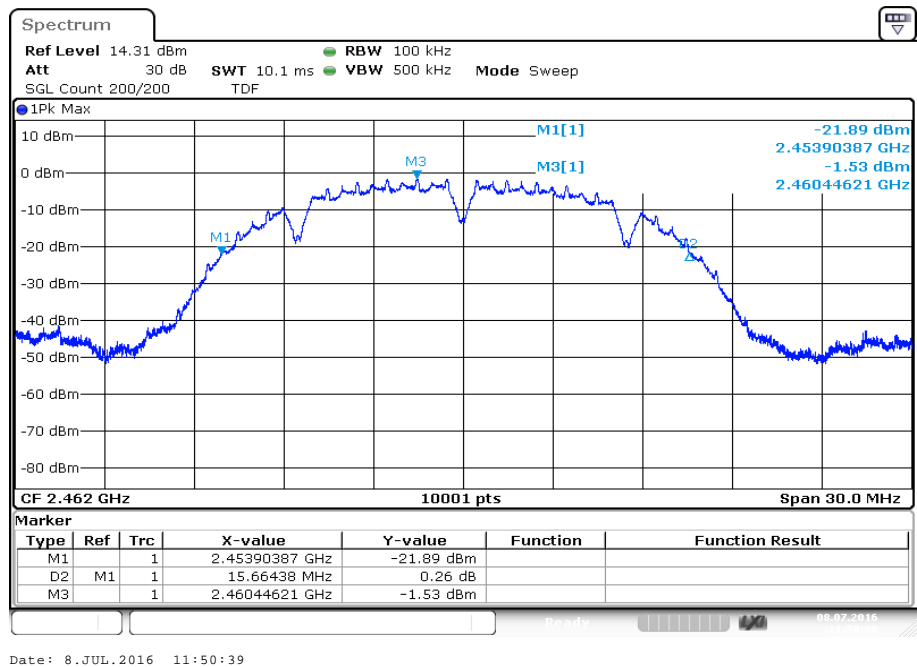
-/-	IC
Within the used band!	

Results:

Modulation Frequency	20 dB bandwidth [MHz]		
	2412 MHz	2437 MHz	2462 MHz
DSSS / b – mode	15.6	15.7	15.7
OFDM / g – mode	17.6	17.6	17.6
OFDM / n HT20 – mode	18.6	18.6	18.6

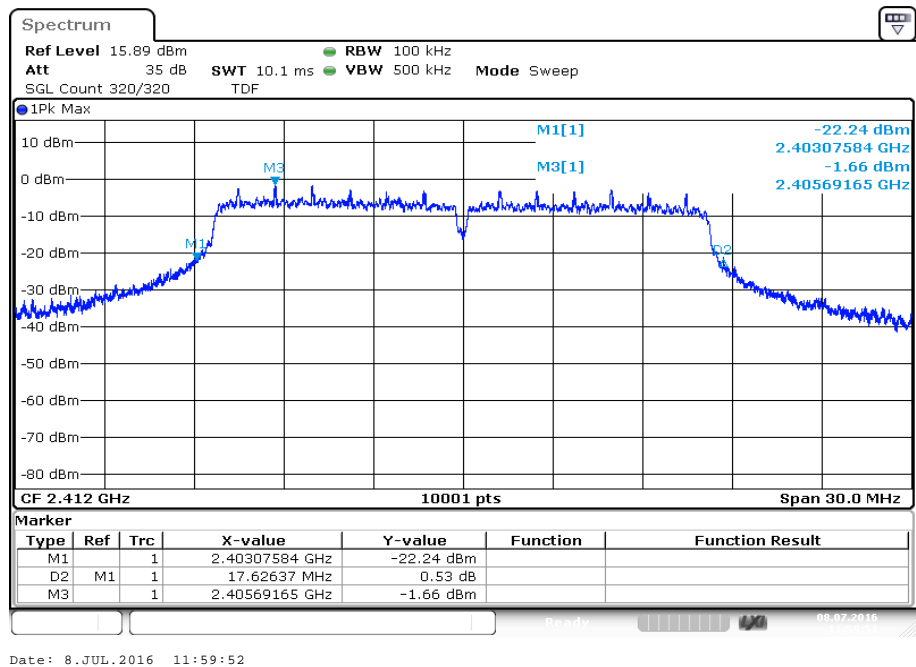
Plots: DSSS / b – mode**Plot 1:** Lowest channel**Plot 2:** Middle channel

Plot 3: Highest channel

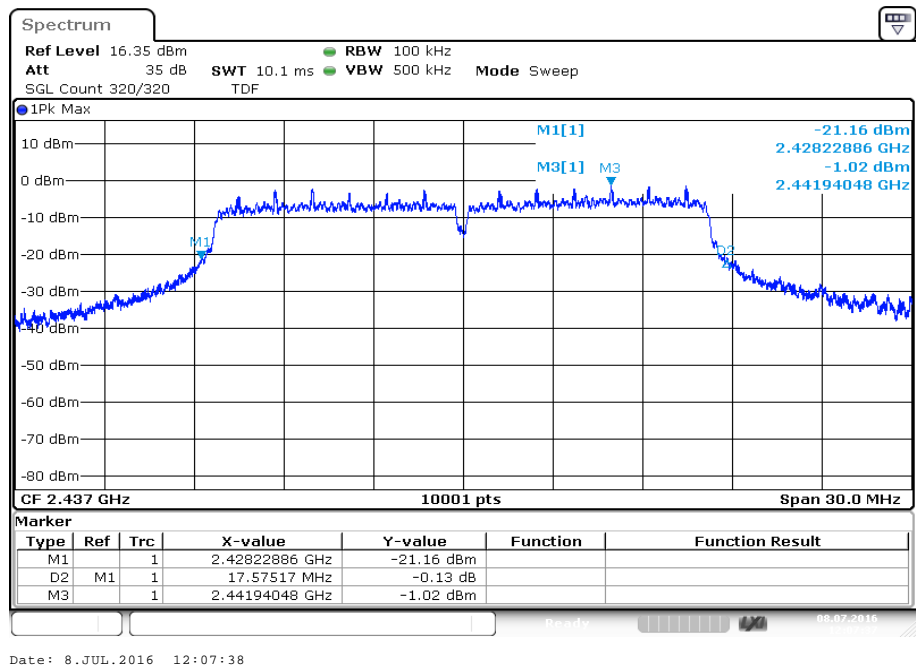


Plots: OFDM / g – mode

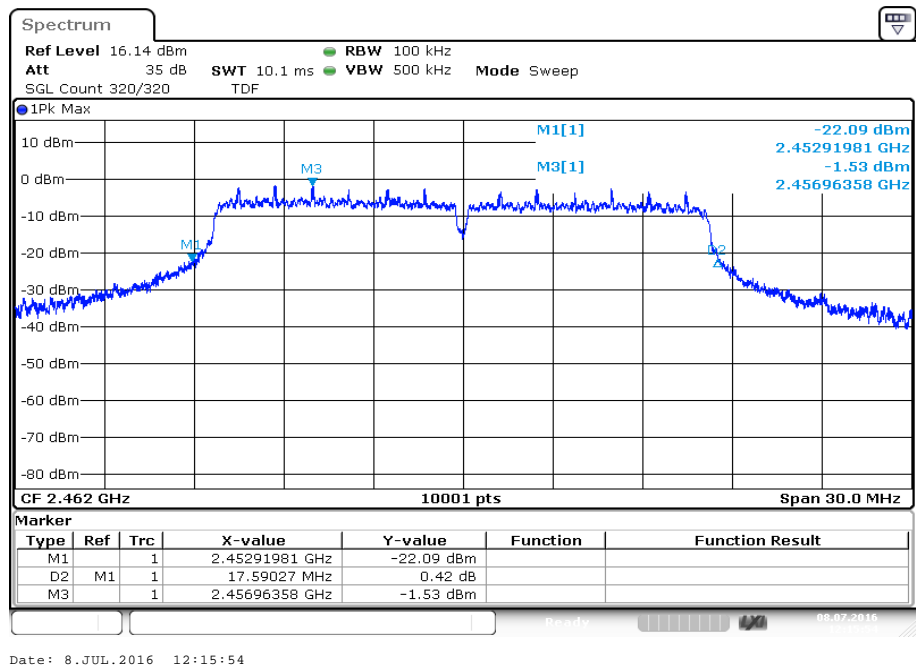
Plot 1: Lowest channel



Plot 2: Middle channel

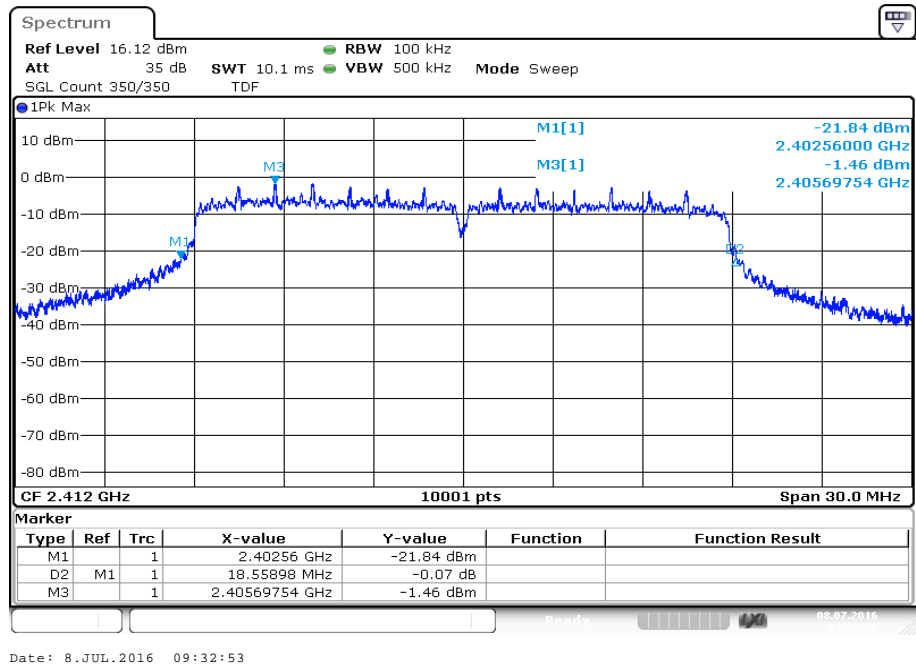


Plot 3: Highest channel

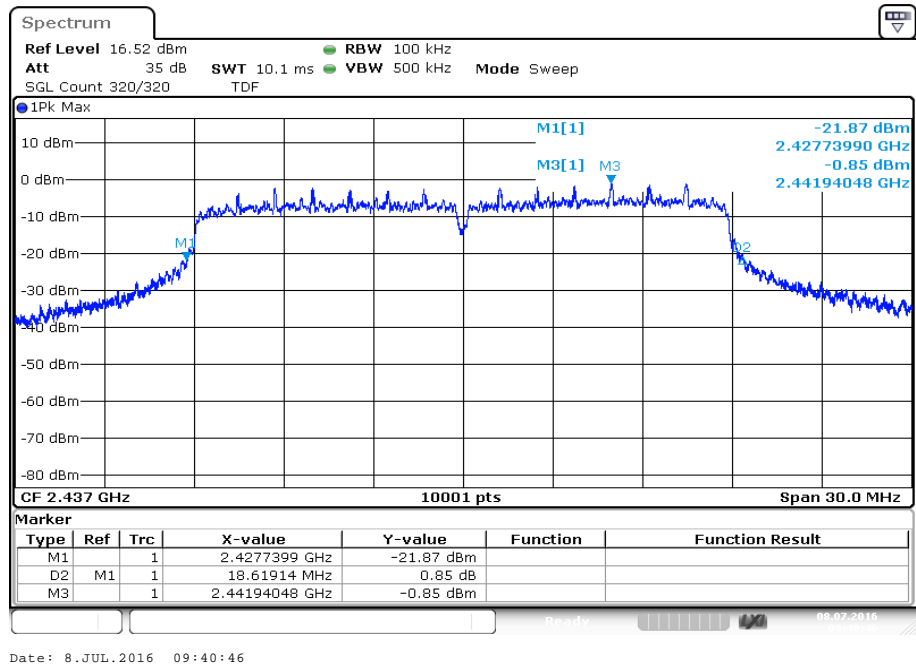


Plots: OFDM / n HT20 – mode

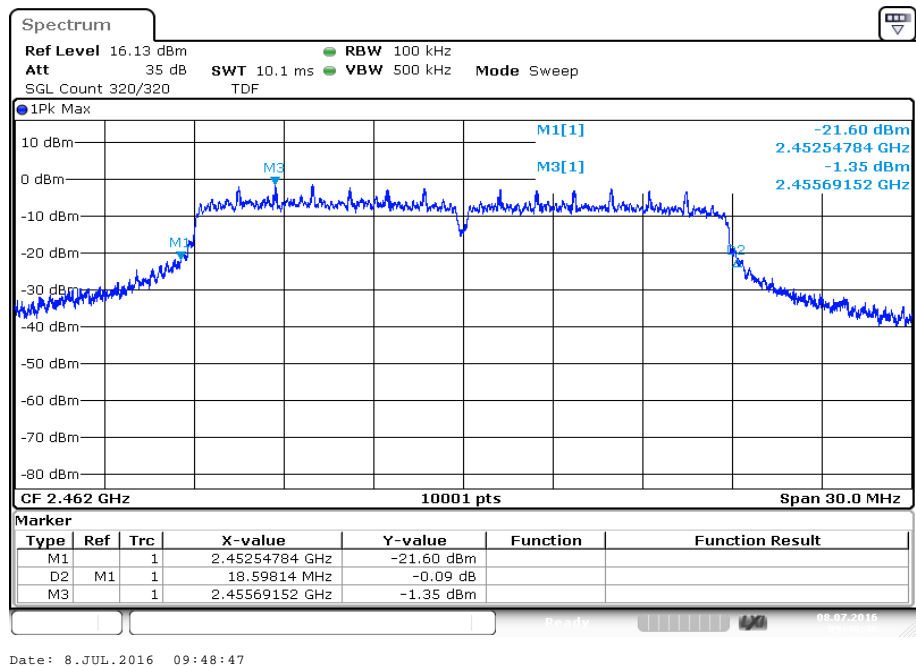
Plot 1: Lowest channel



Plot 2: Middle channel



Plot 3: Highest channel



12.9 Band edge compliance conducted

Description:

Measurement of the radiated band edge compliance with a conducted test setup.

Measurement:

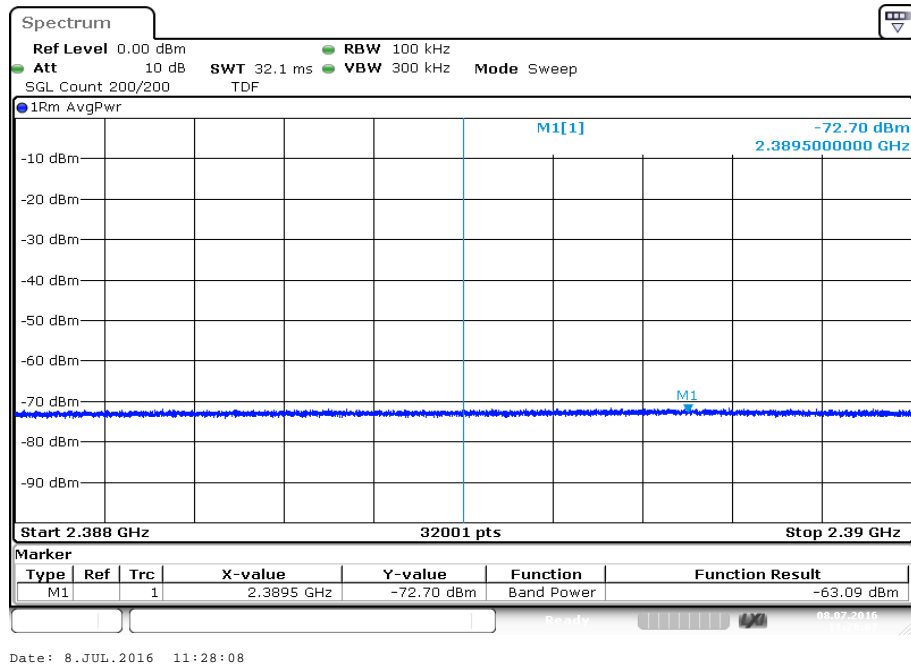
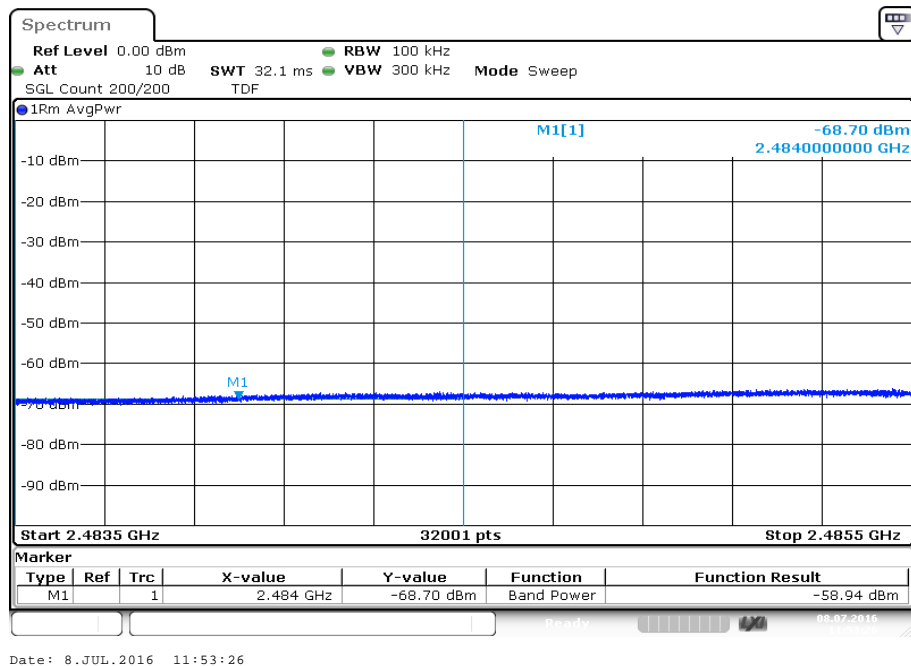
Measurement parameter for measurements	
According to DTS clause: 13.3.2 and clause 12.2.2	
Detector:	RMS
Sweep time:	Auto
Resolution bandwidth:	100 kHz
Video bandwidth:	300 kHz
Span:	Lower band edge: 2388 MHz to 2390 MHz (2 MHz) Upper band edge: 2483.5 MHz to 2485.5 MHz (2 MHz)
Trace mode:	Trace average with 200 counts
Test setup:	See sub clause 7.5 – A + chapter 12.1
Measurement uncertainty	See sub clause 9

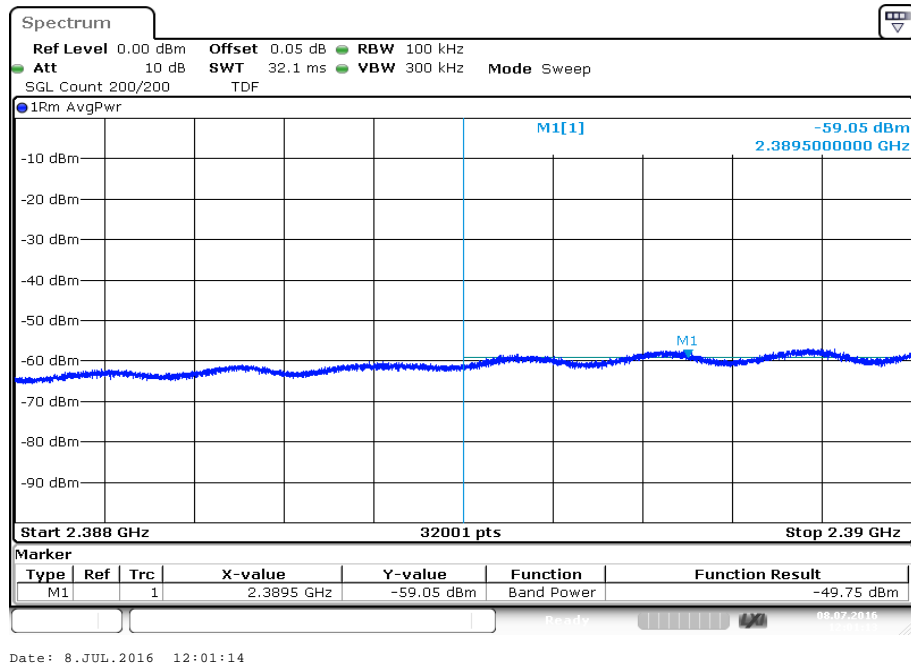
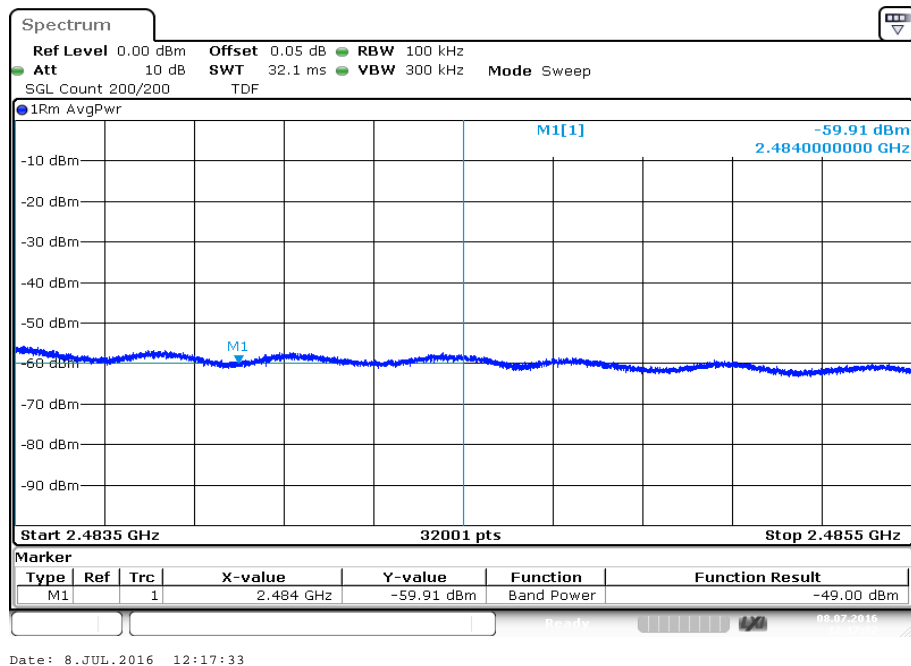
Limits:

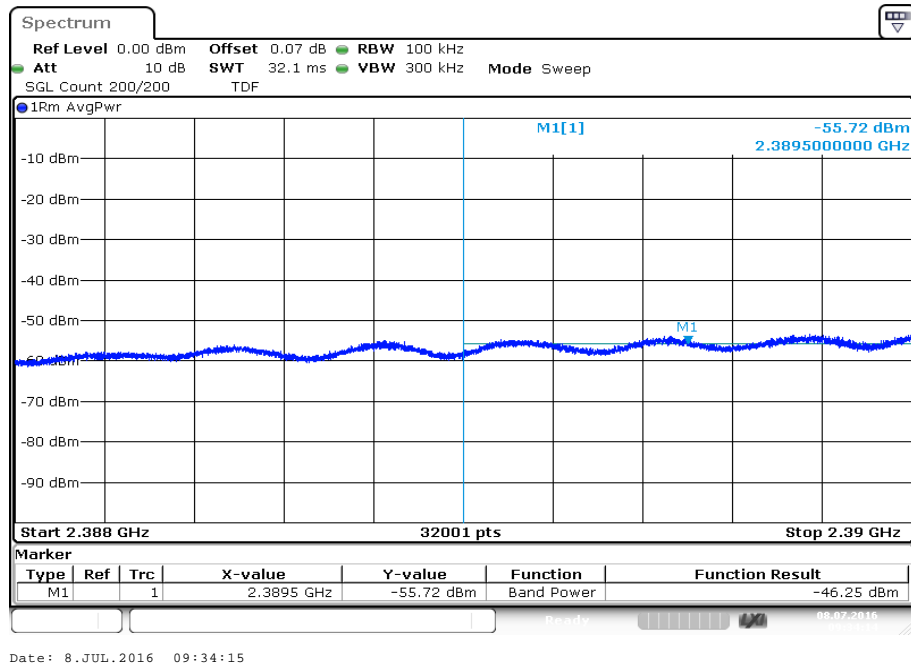
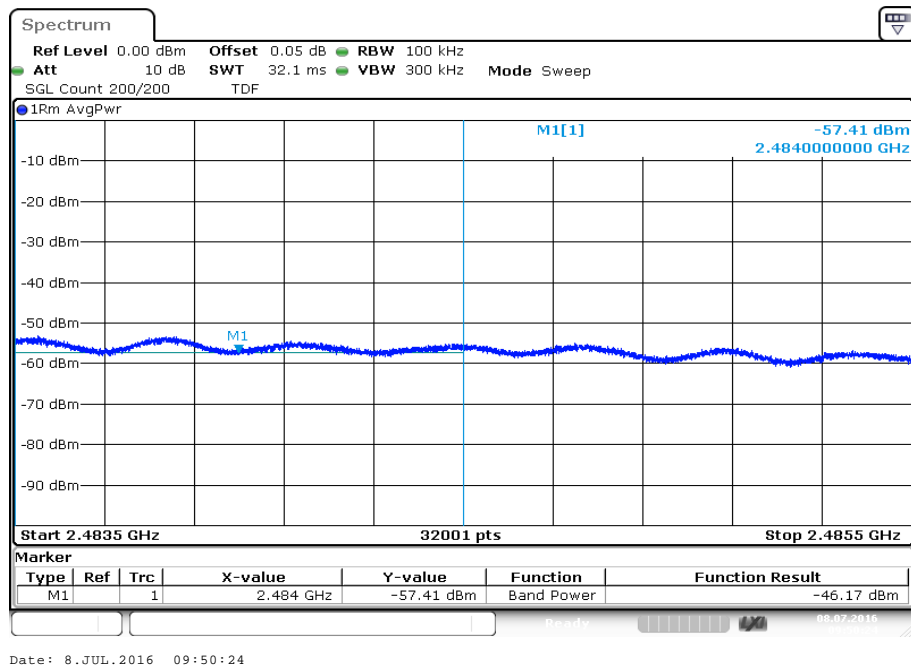
FCC	IC
-41.26 dBm	

Results:

Scenario Modulation	Band edge compliance [dBm] (gain calculation)		
	DSSS / b – mode	OFDM / g – mode	OFDM / n HT20 – mode
Max. lower band edge power conducted	-63.09	-49.75	-46.25
Antenna gain (low channel)	3.6		
Max. lower band edge power radiated	-59.49	-46.15	-42.65
Max. upper band edge power conducted	-58.94	-49.00	-46.17
Antenna gain (high channel)	4.6		
Max. upper band edge power radiated	-54.34	-44.4	-41.57

Plots: DSSS / b – mode**Plot 1:** Lower band edge**Plot 2:** Upper band edge

Plots: OFDM / g – mode**Plot 1:** Lower band edge**Plot 2:** Upper band edge

Plots: OFDM / n HT20 – mode**Plot 1:** Lower band edge**Plot 2:** Upper band edge

12.10 Spurious emissions conducted

Description:

Measurement of the conducted spurious emissions in transmit mode. The measurement is performed at channel 1, 6 and 11. The measurement is repeated for all modulations.

Measurement:

Measurement parameter	
Detector:	Peak
Sweep time:	Auto
Resolution bandwidth:	100 kHz
Video bandwidth:	500 kHz
Span:	9 kHz to 25 GHz
Trace mode:	Max Hold
Test setup:	See sub clause 7.5 – A
Measurement uncertainty	See sub clause 9

Limits:

FCC	IC
In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 30 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement. Attenuation below the general limits specified in Section 15.209(a) is not required	

Results: DSSS / b – mode

TX Spurious Emissions Conducted					
DSSS / b – mode					
f [MHz]		amplitude of emission [dBm]	limit max. allowed emission power	actual attenuation below frequency of operation [dB]	results
2412		-2.8	30 dBm		Operating frequency
No peaks detected. All detected emissions are below the -20 dBc & -30 dBc criteria.			-20 dBc (peak) -30 dBc (average)		compliant
2437		-1.7	30 dBm		Operating frequency
No peaks detected. All detected emissions are below the -20 dBc & -30 dBc criteria.			-20 dBc (peak) -30 dBc (average)		compliant
2462		-1.6	30 dBm		Operating frequency
No peaks detected. All detected emissions are below the -20 dBc & -30 dBc criteria.			-20 dBc (peak) -30 dBc (average)		compliant

Results: OFDM / g – mode

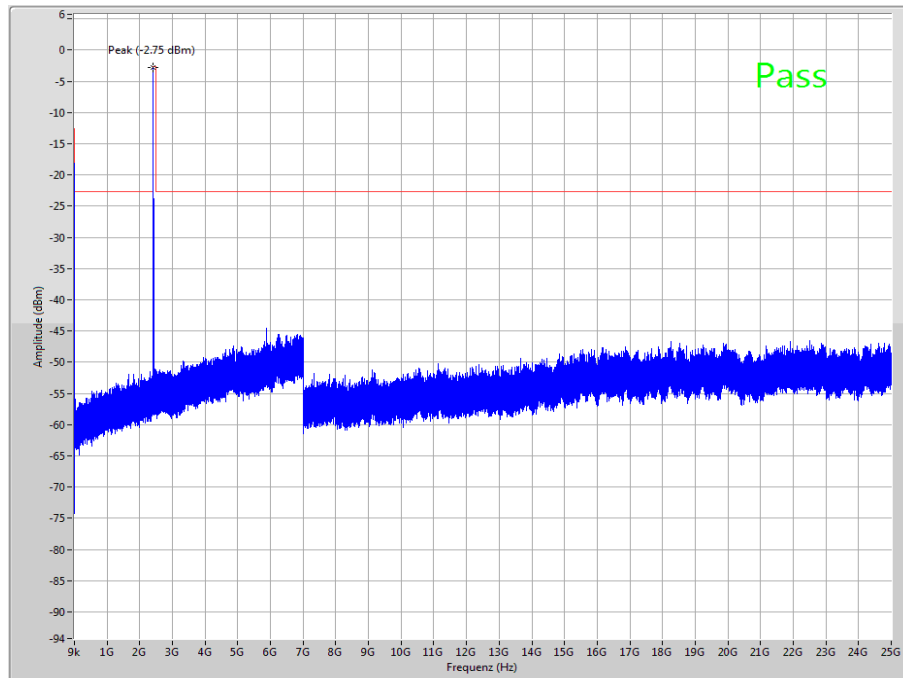
TX Spurious Emissions Conducted					
OFDM / g – mode					
f [MHz]		amplitude of emission [dBm]	limit max. allowed emission power	actual attenuation below frequency of operation [dB]	results
2412		-3.1	30 dBm		Operating frequency
No peaks detected. All detected emissions are below the -20 dBc & -30 dBc criteria.			-20 dBc (peak) -30 dBc (average)		compliant
2437		-3.7	30 dBm		Operating frequency
No peaks detected. All detected emissions are below the -20 dBc & -30 dBc criteria.			-20 dBc (peak) -30 dBc (average)		compliant
2462		-3.1	30 dBm		Operating frequency
No peaks detected. All detected emissions are below the -20 dBc & -30 dBc criteria.			-20 dBc (peak) -30 dBc (average)		compliant

Results: OFDM / n HT20 – mode

TX Spurious Emissions Conducted					
OFDM / n HT20 – mode					
f [MHz]		amplitude of emission [dBm]	limit max. allowed emission power	actual attenuation below frequency of operation [dB]	results
2412		-3.1	30 dBm		Operating frequency
No peaks detected. All detected emissions are below the -20 dBc & -30 dBc criteria.			-20 dBc (peak)		compliant
			-30 dBc (average)		
2437		-1.7	30 dBm		Operating frequency
No peaks detected. All detected emissions are below the -20 dBc & -30 dBc criteria.			-20 dBc (peak)		compliant
			-30 dBc (average)		
2462		-2.8	30 dBm		Operating frequency
No peaks detected. All detected emissions are below the -20 dBc & -30 dBc criteria.			-20 dBc (peak)		compliant
			-30 dBc (average)		

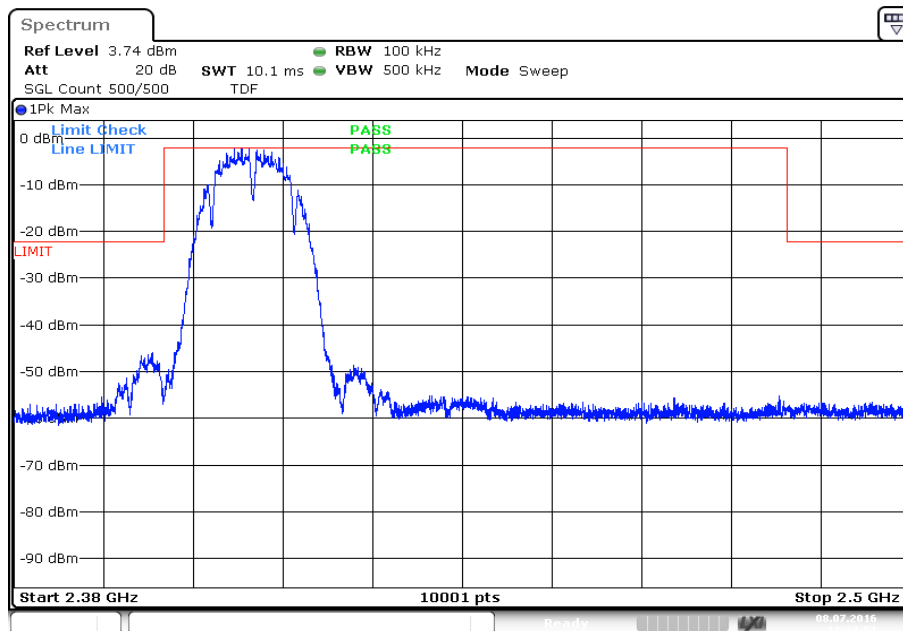
Plots: DSSS / b – mode

Plot 1: Lowest channel, up to 25 GHz

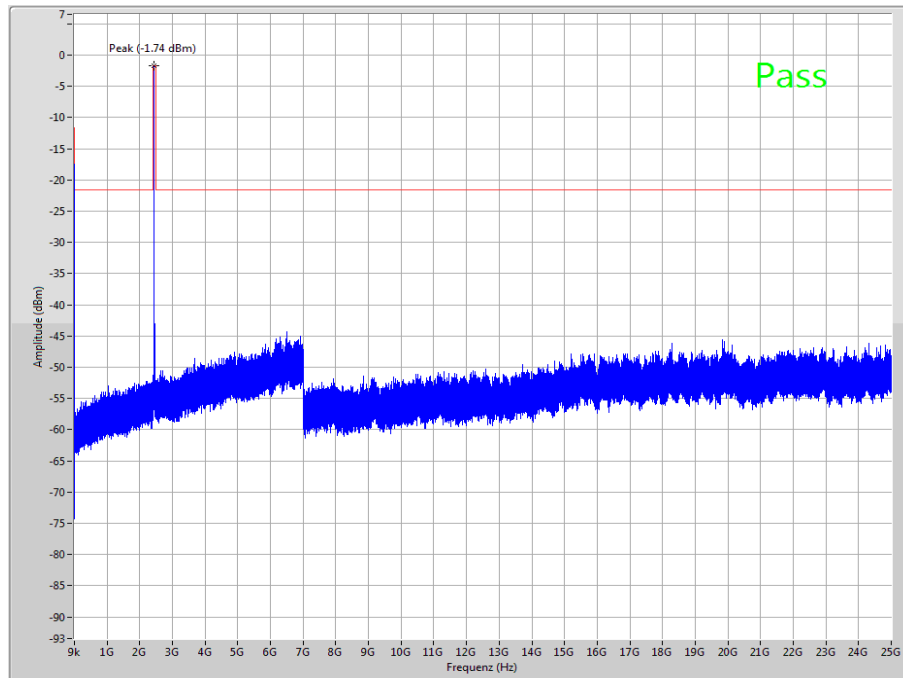


The peak at the beginning of the plot is the LO from the SA.

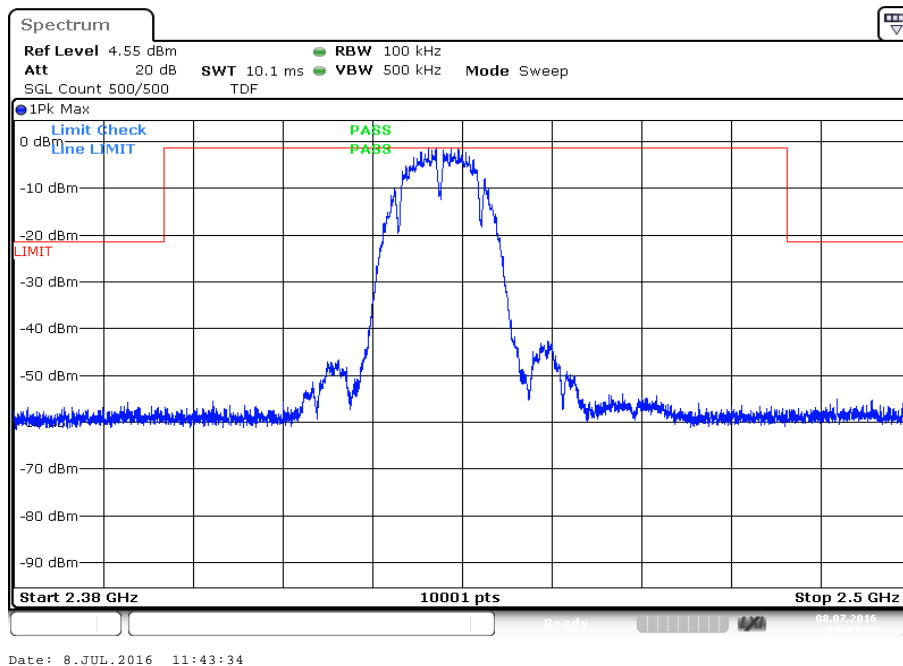
Plot 2: Lowest channel, zoomed carrier

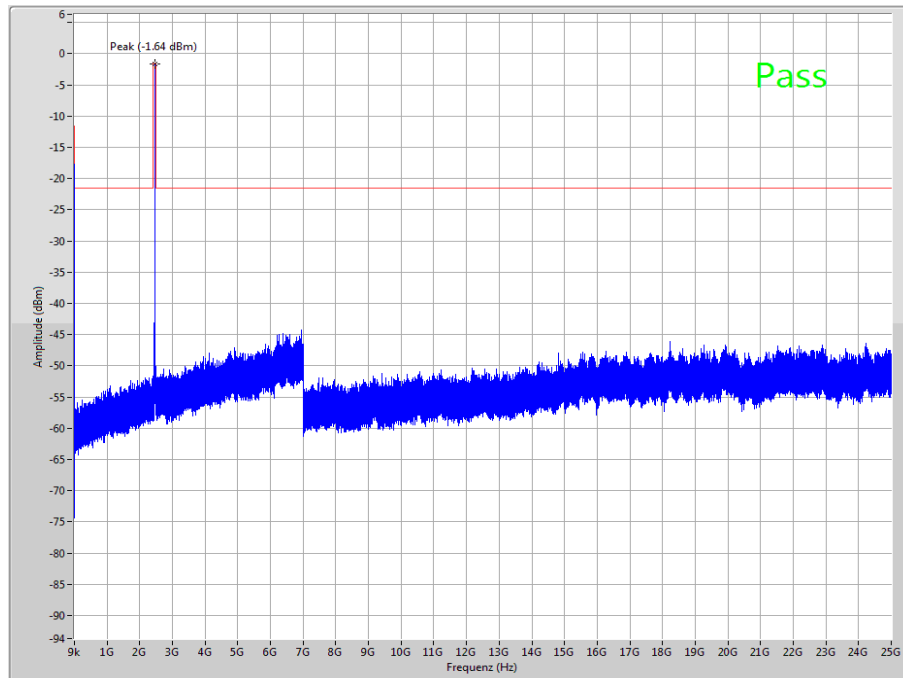


Date: 8.JUL.2016 11:27:52

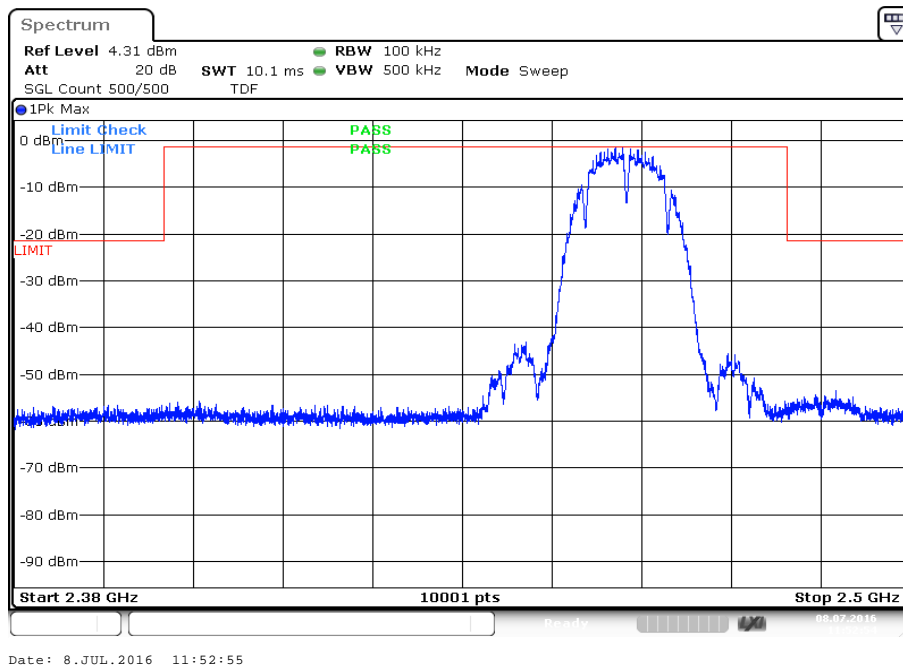
Plot 3: Middle channel, up to 25 GHz

The peak at the beginning of the plot is the LO from the SA.

Plot 4: Middle channel, zoomed carrier

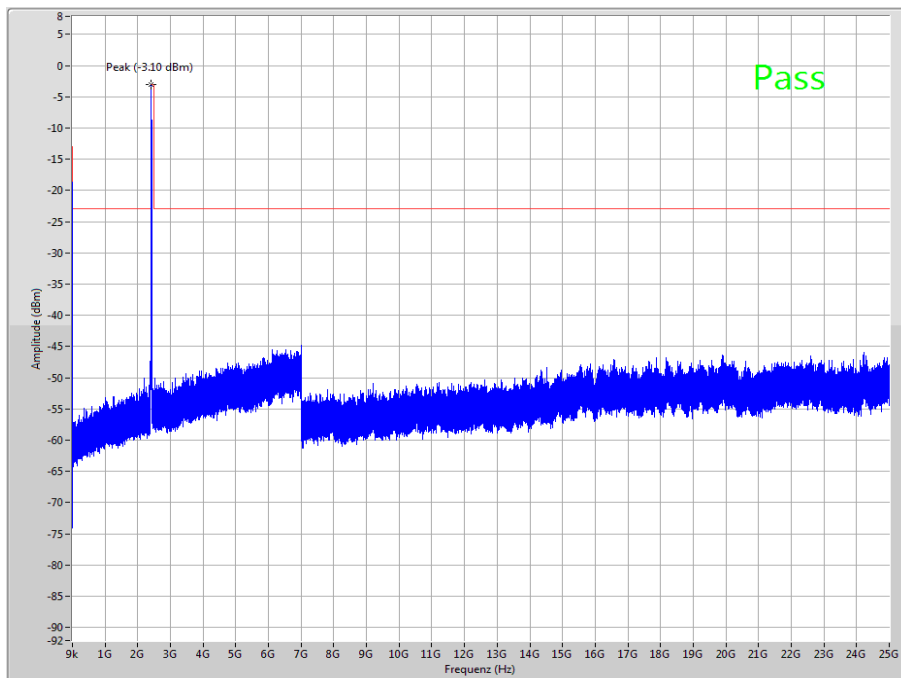
Plot 5: Highest channel, up to 25 GHz

The peak at the beginning of the plot is the LO from the SA.

Plot 6: Highest channel, zoomed carrier

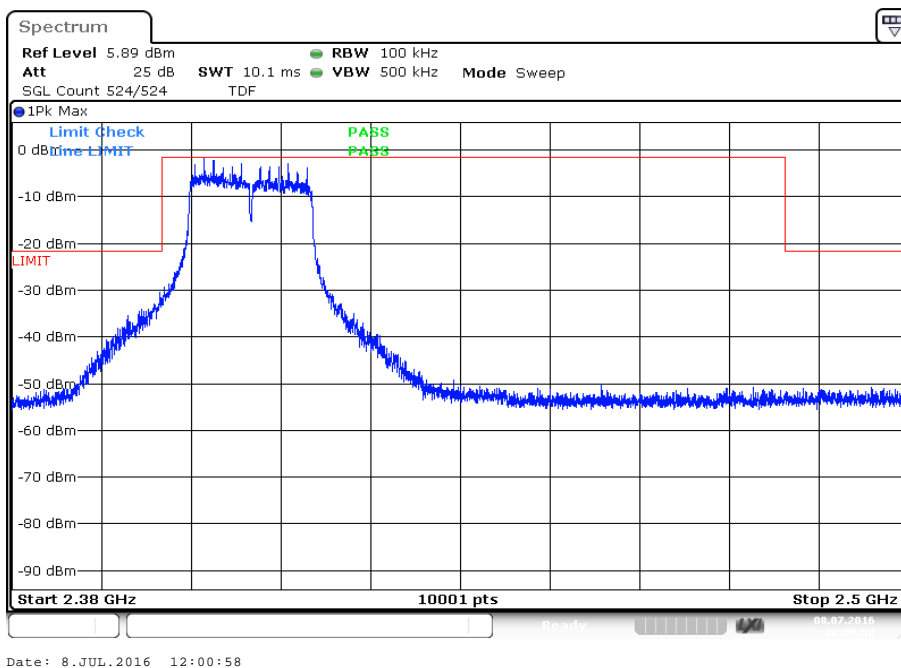
Plots: OFDM / g – mode

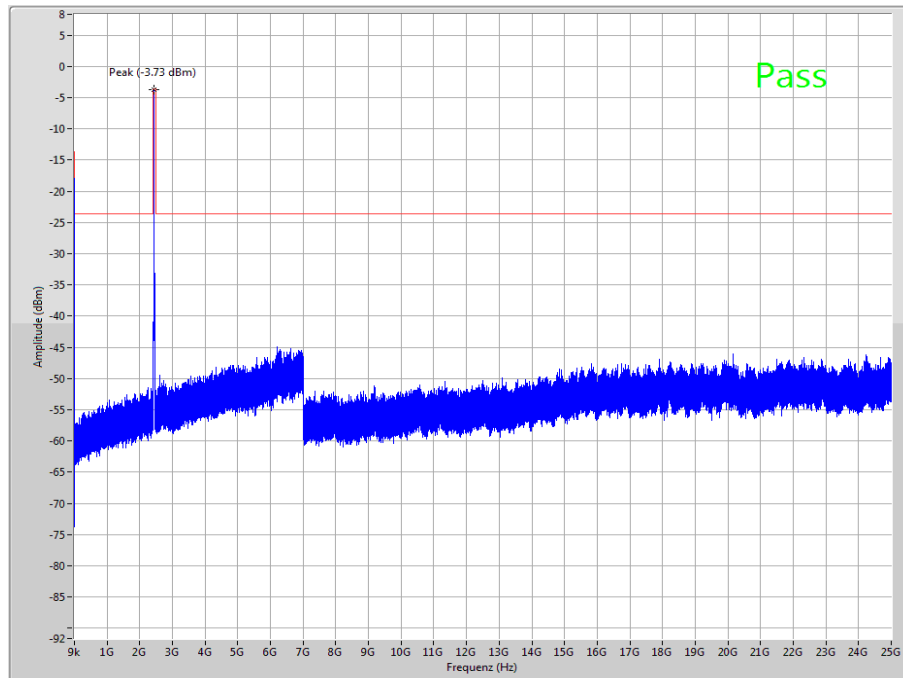
Plot 1: Lowest channel, up to 25 GHz



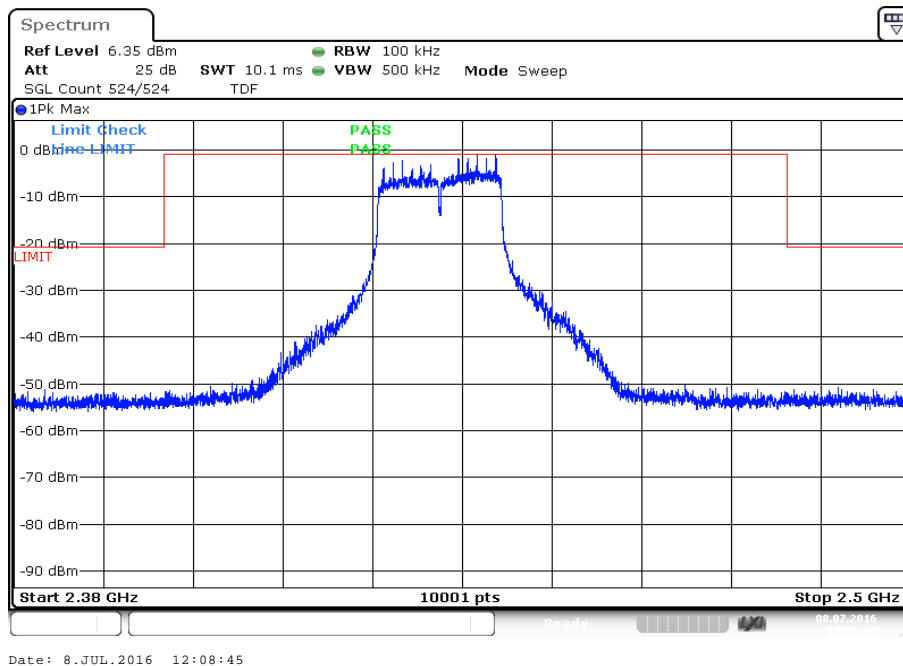
The peak at the beginning of the plot is the LO from the SA.

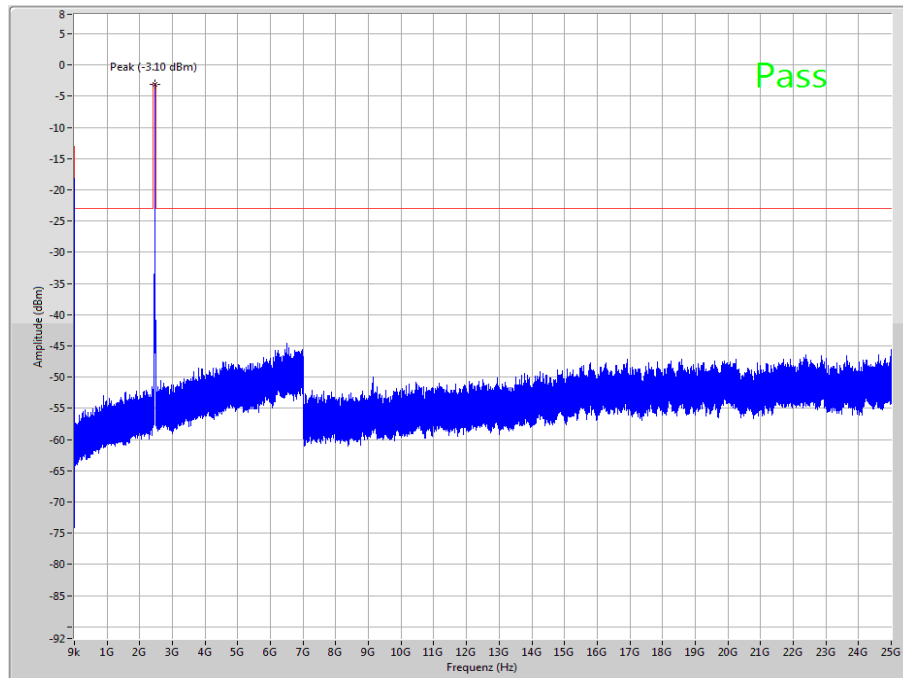
Plot 2: Lowest channel, zoomed carrier



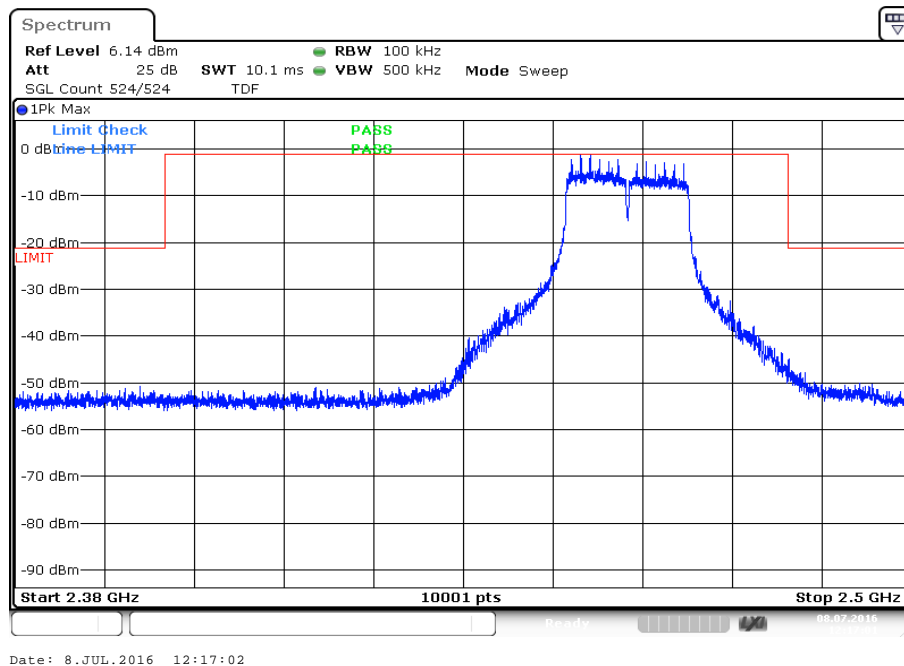
Plot 3: Middle channel, up to 25 GHz

The peak at the beginning of the plot is the LO from the SA.

Plot 4: Middle channel, zoomed carrier

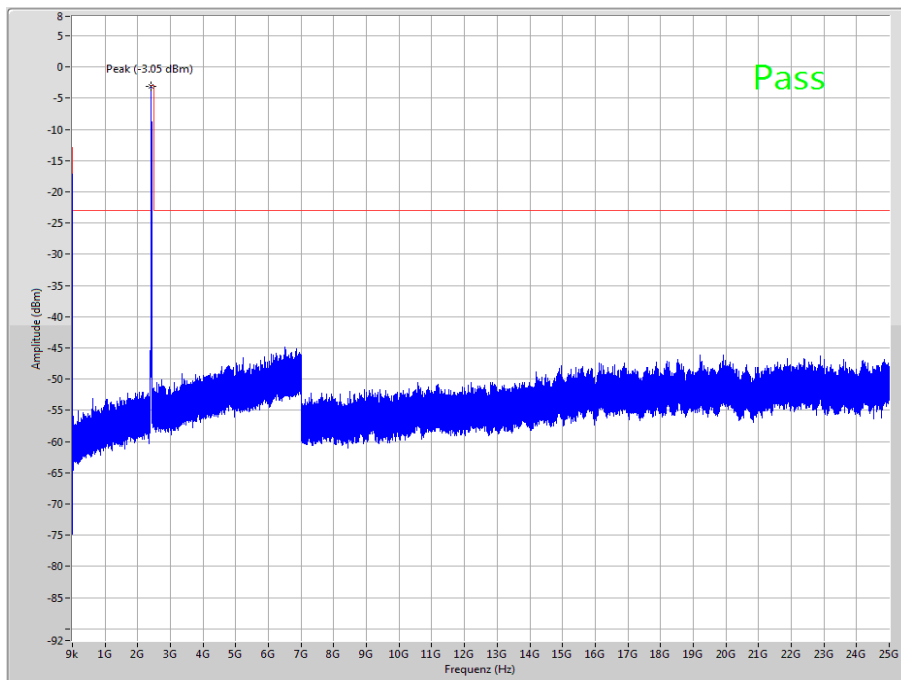
Plot 5: Highest channel, up to 25 GHz

The peak at the beginning of the plot is the LO from the SA.

Plot 6: Highest channel, zoomed carrier

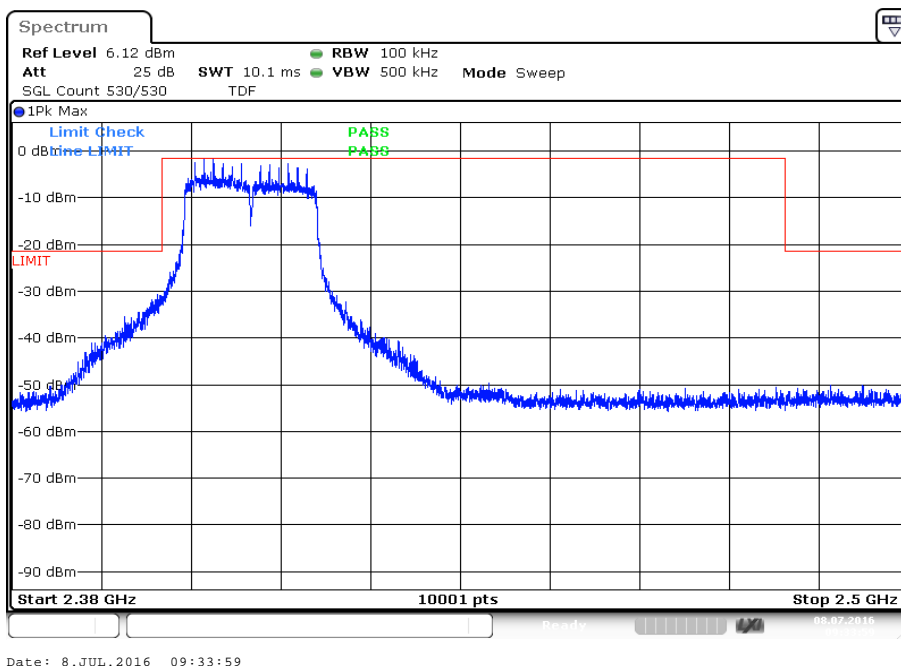
Plots: OFDM / n HT 20 – mode

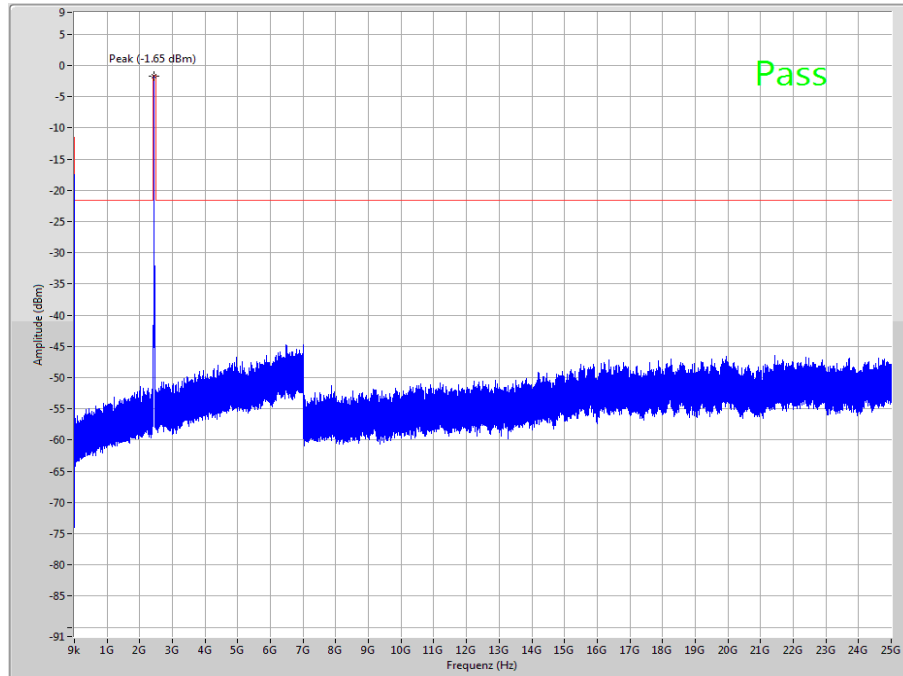
Plot 1: Lowest channel, up to 25 GHz



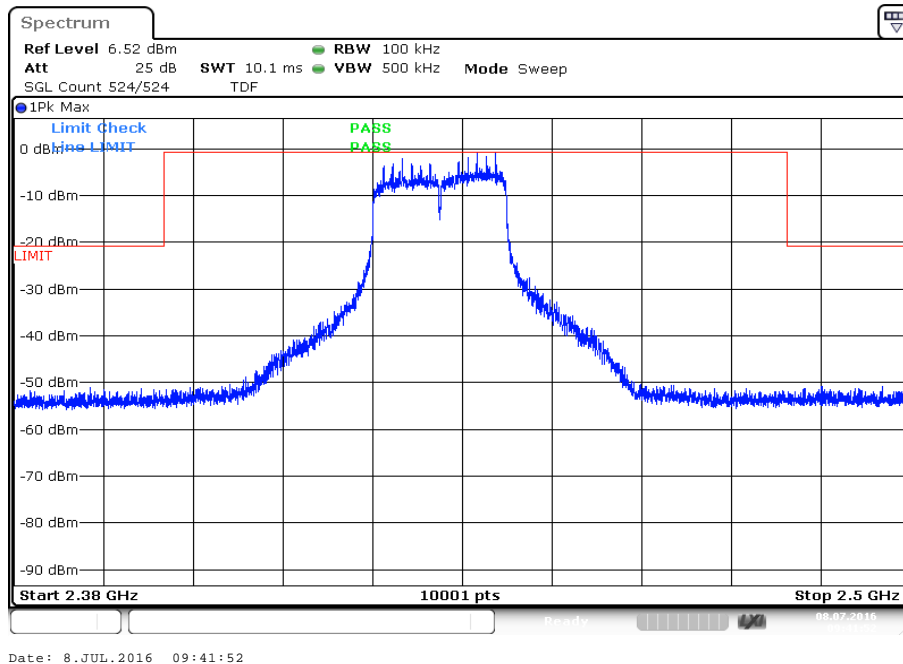
The peak at the beginning of the plot is the LO from the SA.

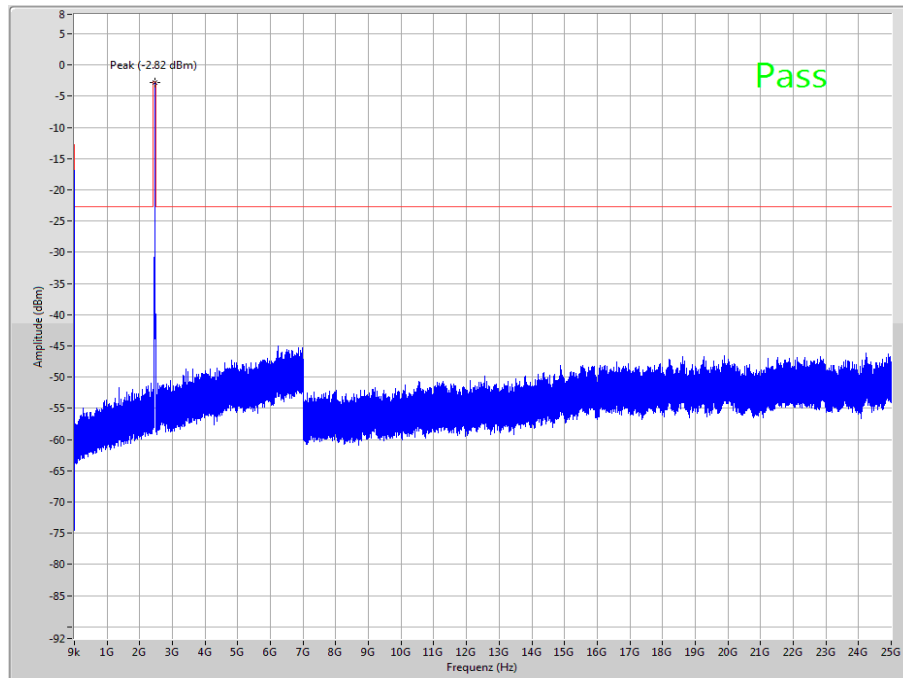
Plot 2: Lowest channel, zoomed carrier



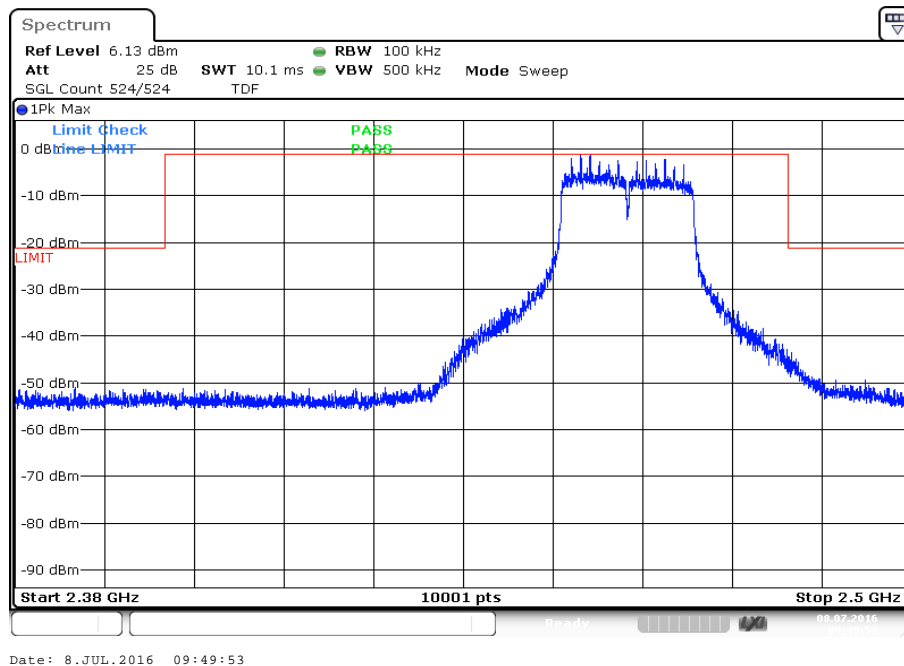
Plot 3: Middle channel, up to 25 GHz

The peak at the beginning of the plot is the LO from the SA.

Plot 4: Middle channel, zoomed carrier

Plot 5: Highest channel, up to 25 GHz

The peak at the beginning of the plot is the LO from the SA.

Plot 6: Highest channel, zoomed carrier

12.11 Spurious emissions radiated below 30 MHz

Description:

Measurement of the radiated spurious emissions in transmit mode below 30 MHz. The EUT is set to channel 6. This measurement is representative for all channels and modes. If peaks are found channel 1 and channel 11 will be measured too. The measurement is performed with the data rate producing the highest output power. The limits are recalculated to a measurement distance of 3 m with 40 dB/decade according CFR Part 2.

Measurement:

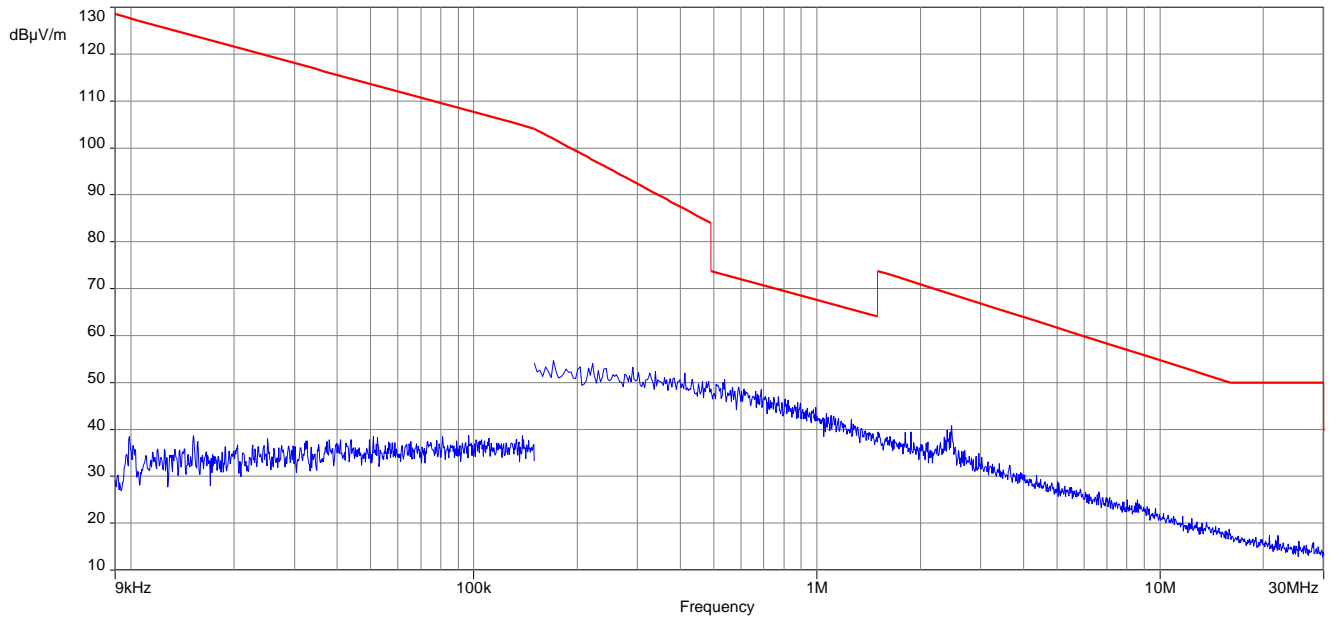
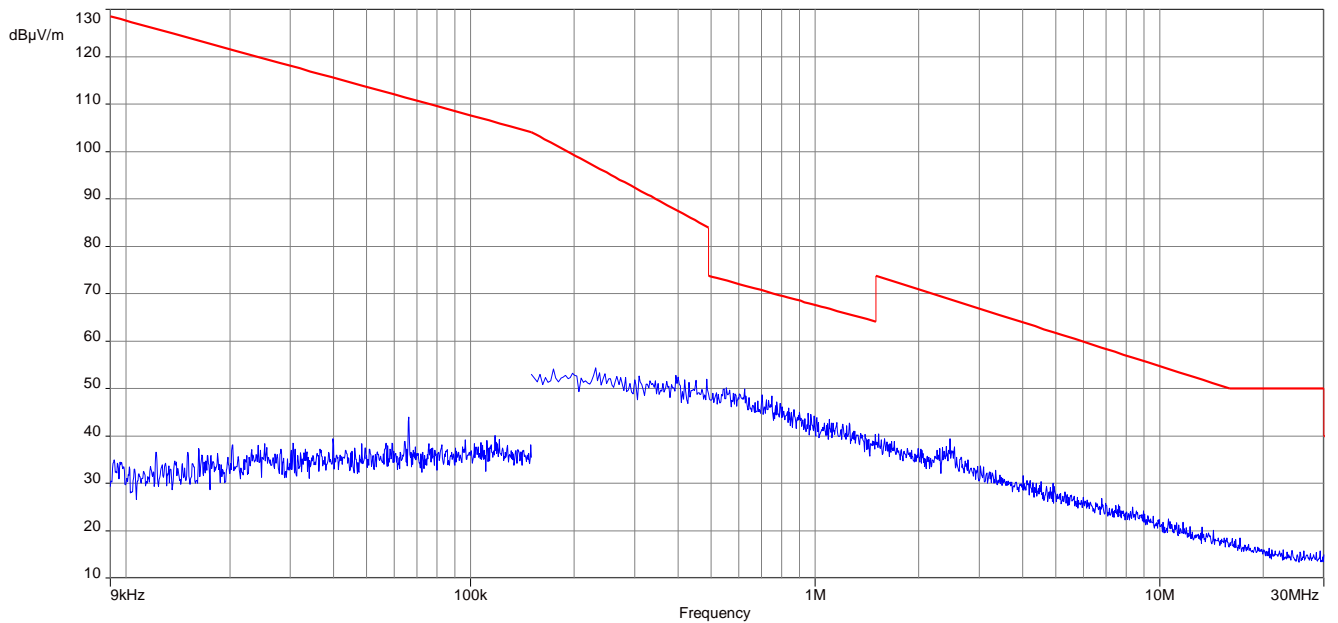
Measurement parameter	
Detector:	Peak / Quasi Peak
Sweep time:	Auto
Resolution bandwidth:	F < 150 kHz: 200 Hz F > 150 kHz: 9 kHz
Video bandwidth:	F < 150 kHz: 1 kHz F > 150 kHz: 100 kHz
Span:	9 kHz to 30 MHz
Trace mode:	Max Hold
Measured modulation	<input checked="" type="checkbox"/> DSSS b – mode <input type="checkbox"/> OFDM g – mode <input checked="" type="checkbox"/> OFDM n HT20 – mode <input type="checkbox"/> OFDM n HT40 – mode
Test setup:	See sub clause 7.2 - A
Measurement uncertainty	See sub clause 9

Limits:

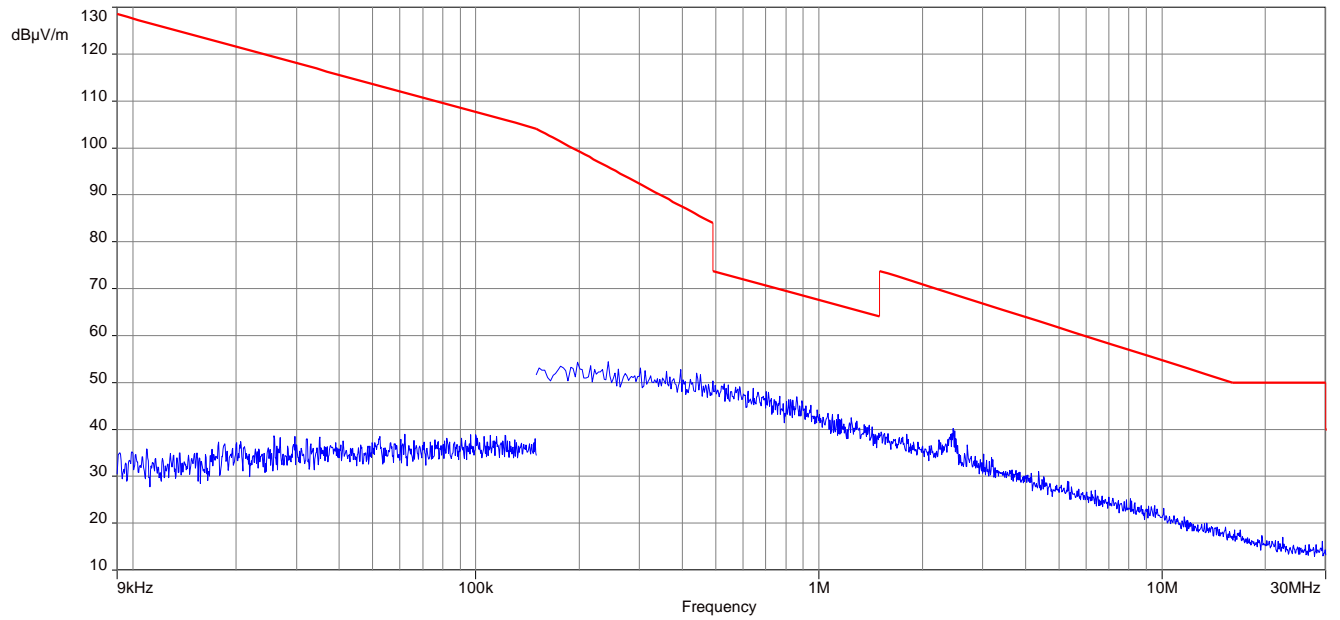
FCC		IC
Frequency (MHz)	Field Strength (dB μ V/m)	Measurement distance
0.009 – 0.490	2400/F(kHz)	300
0.490 – 1.705	24000/F(kHz)	30
1.705 – 30.0	30	30

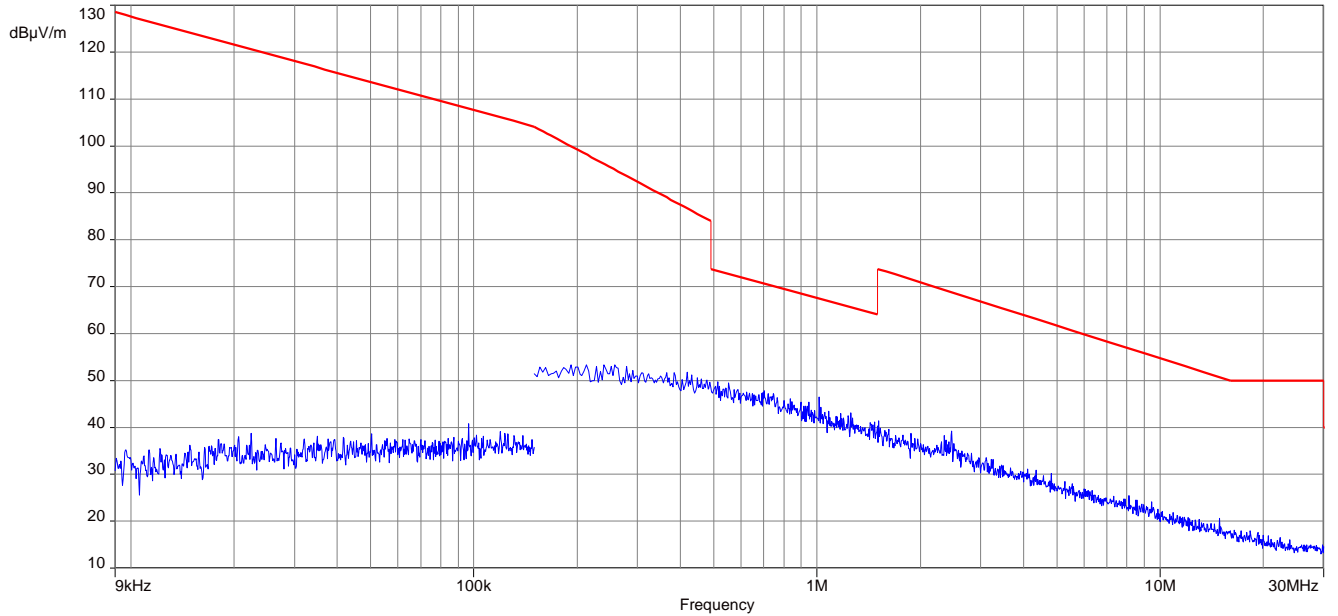
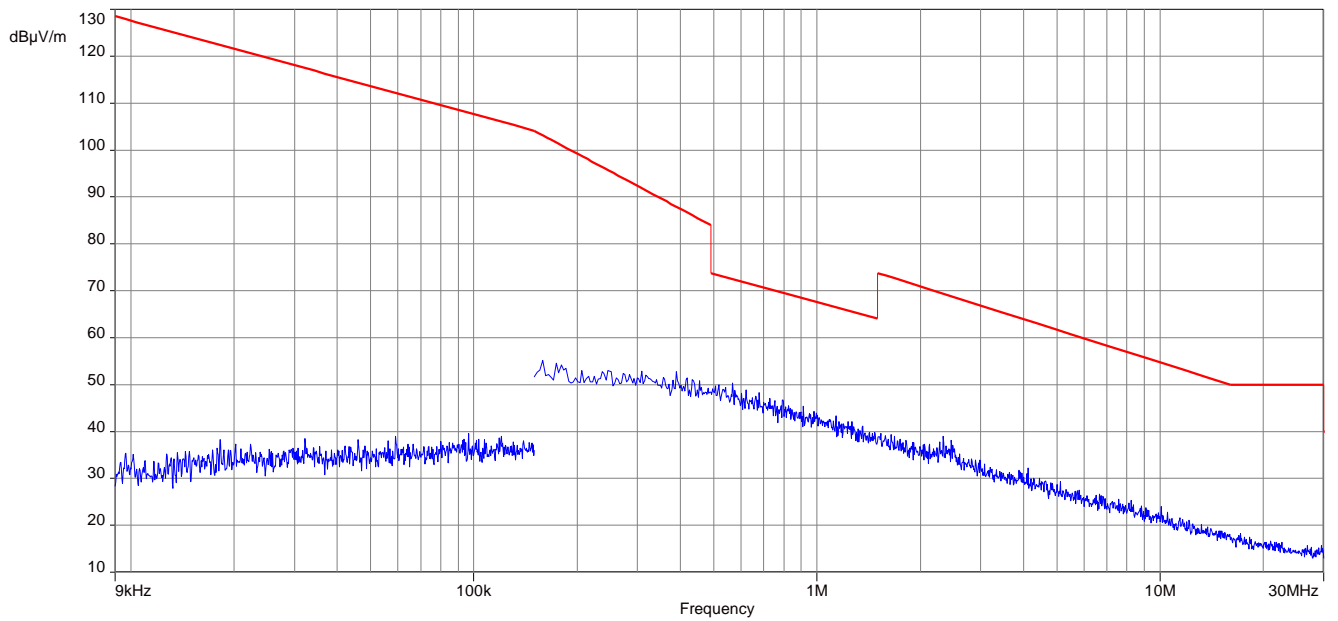
Results:

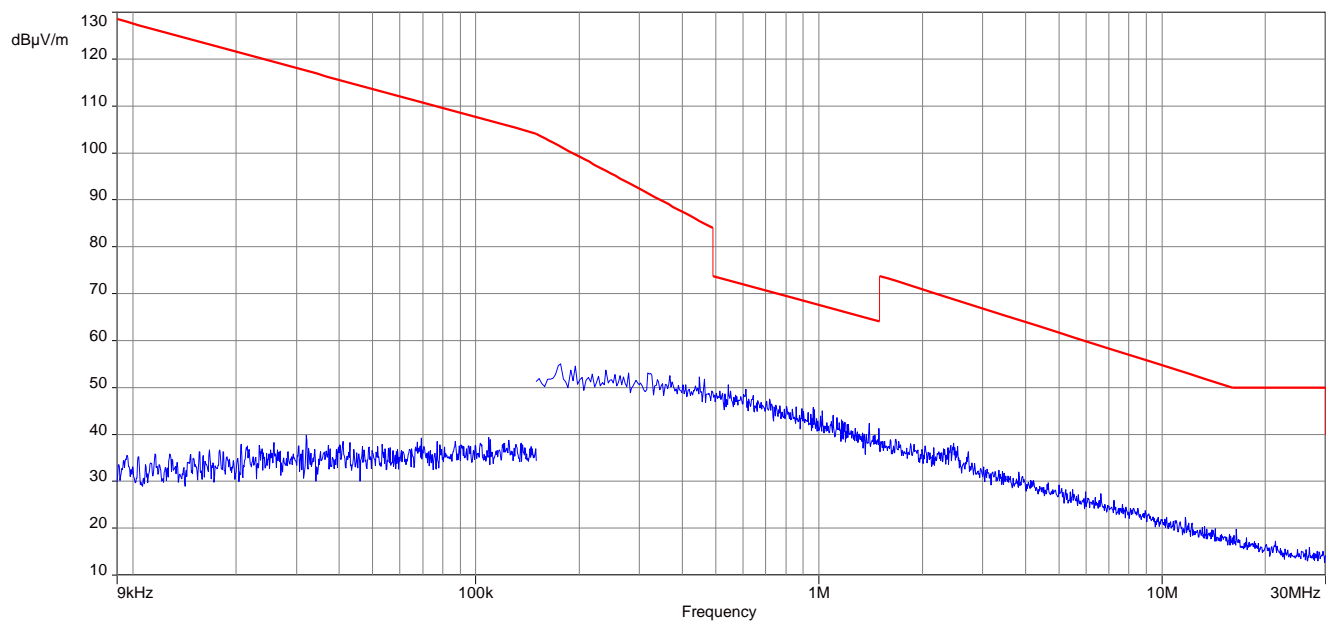
TX Spurious Emissions Radiated < 30 MHz [dB μ V/m]		
F [MHz]	Detector	Level [dB μ V/m]
All detected peaks are more than 20 dB below the limit.		

Plots: DSSS**Plot 1:** 9 kHz to 30 MHz, low channel**Plot 2:** 9 kHz to 30 MHz, mid channel

Plot 3: 9 kHz to 30 MHz, high channel



Plots: OFDM (20 MHz)**Plot 1:** 9 kHz to 30 MHz, low channel**Plot 2:** 9 kHz to 30 MHz, mid channel

Plot 3: 9 kHz to 30 MHz, high channel

12.12 Spurious emissions radiated 30 MHz to 1 GHz

Description:

Measurement of the radiated spurious emissions and cabinet radiations below 1 GHz.

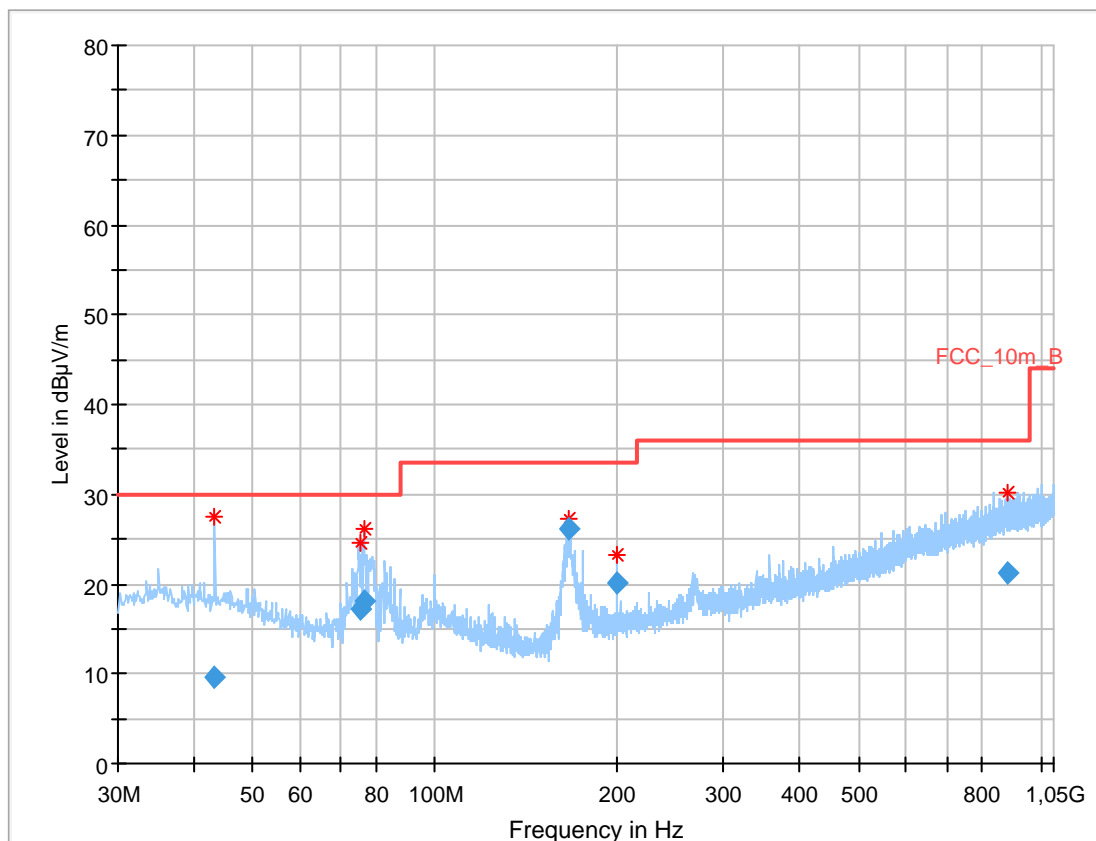
Measurement:

Measurement parameter	
Detector:	Peak / Quasi Peak
Sweep time:	Auto
Resolution bandwidth:	120 kHz
Video bandwidth:	3 x RBW
Span:	30 MHz to 1 GHz
Trace mode:	Max Hold
Measured modulation	<input checked="" type="checkbox"/> DSSS b – mode <input type="checkbox"/> OFDM g – mode <input checked="" type="checkbox"/> OFDM n HT20 – mode <input type="checkbox"/> OFDM n HT40 – mode <input checked="" type="checkbox"/> RX / Idle – mode
Test setup:	See sub clause 7.1 - A
Measurement uncertainty	See sub clause 9

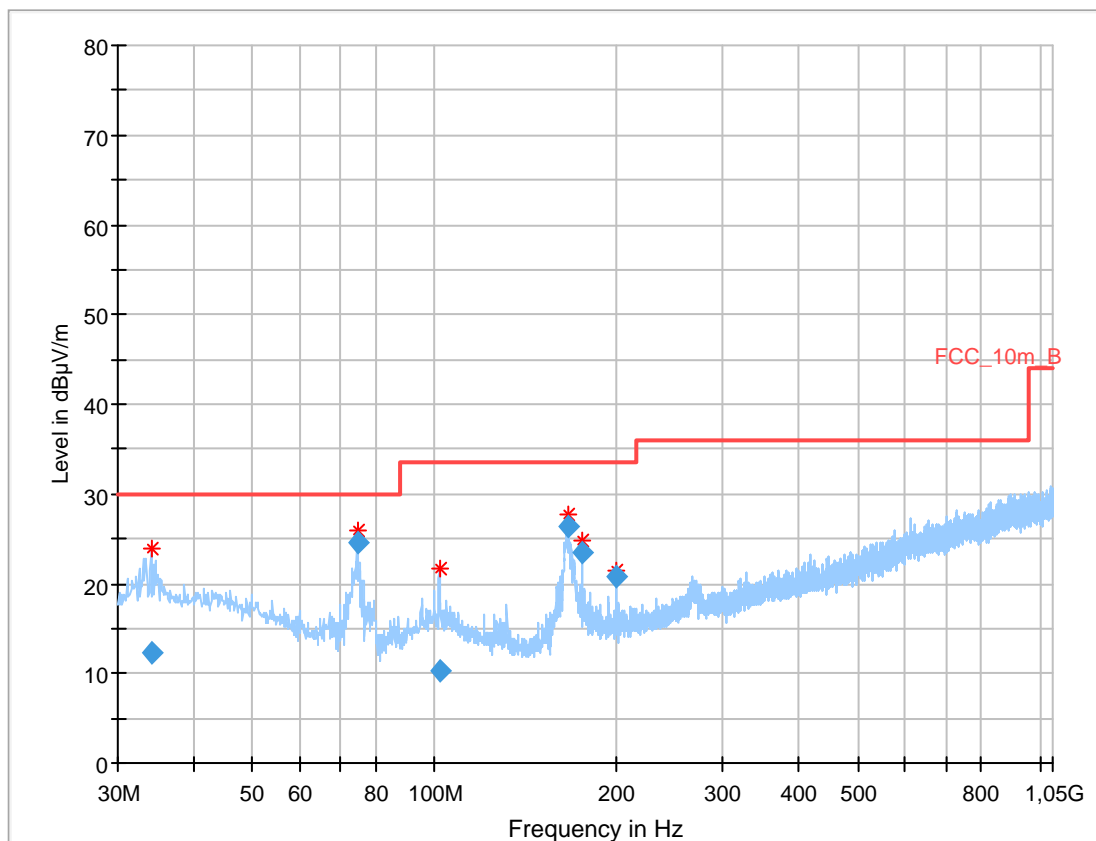
The modulation with the highest output power was used to perform the transmitter spurious emissions. If spurious were detected a re-measurement was performed on the detected frequency with each modulation.

Limits:

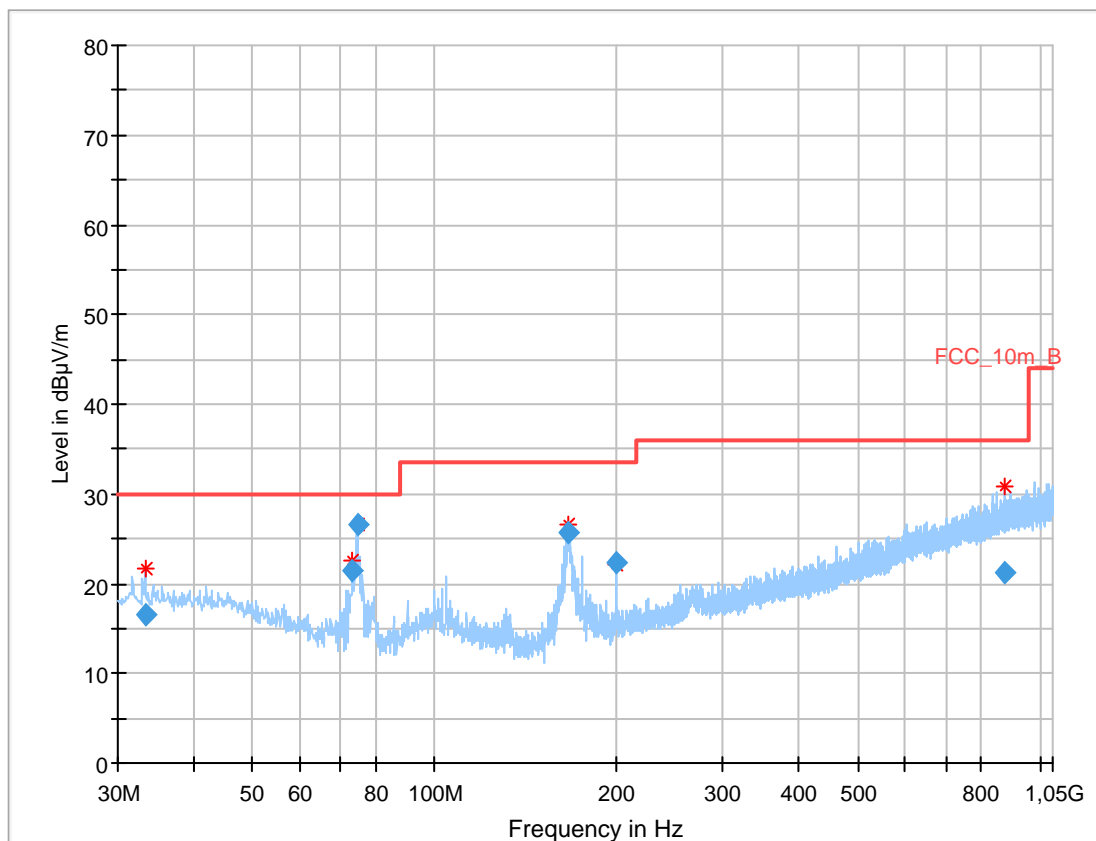
FCC		IC
In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement. Attenuation below the general limits specified in Section 15.209(a) is not required. In addition, radiated emissions which fall in the restricted bands, as defined in §15.205(a), must also comply with the radiated emission limits specified in §15.209(a) (see §15.205(c)).		
Frequency (MHz)	Field Strength (dBμV/m)	Measurement distance
30 - 88	30.0	10
88 – 216	33.5	10
216 – 960	36.0	10

Plot: DSSS**Plot 1:** 30 MHz to 1 GHz, vertical & horizontal polarization, low channel**Final_Result:**

Frequency (MHz)	QuasiPeak (dBμV/m)	Limit (dBμV/m)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB)
43.384350	9.62	30.00	20.38	1000.0	120.000	101.0	H	349.0	13.9
75.505650	17.21	30.00	12.79	1000.0	120.000	101.0	V	349.0	8.2
76.327650	18.01	30.00	11.99	1000.0	120.000	98.0	V	327.0	8.2
166.011000	26.25	33.50	7.25	1000.0	120.000	101.0	V	186.0	9.5
199.977000	20.13	33.50	13.37	1000.0	120.000	101.0	V	312.0	11.7
881.355900	21.34	36.00	14.66	1000.0	120.000	101.0	V	155.0	23.9

Plot 2: 30 MHz to 1 GHz, vertical & horizontal polarization, mid channel**Final_Result:**

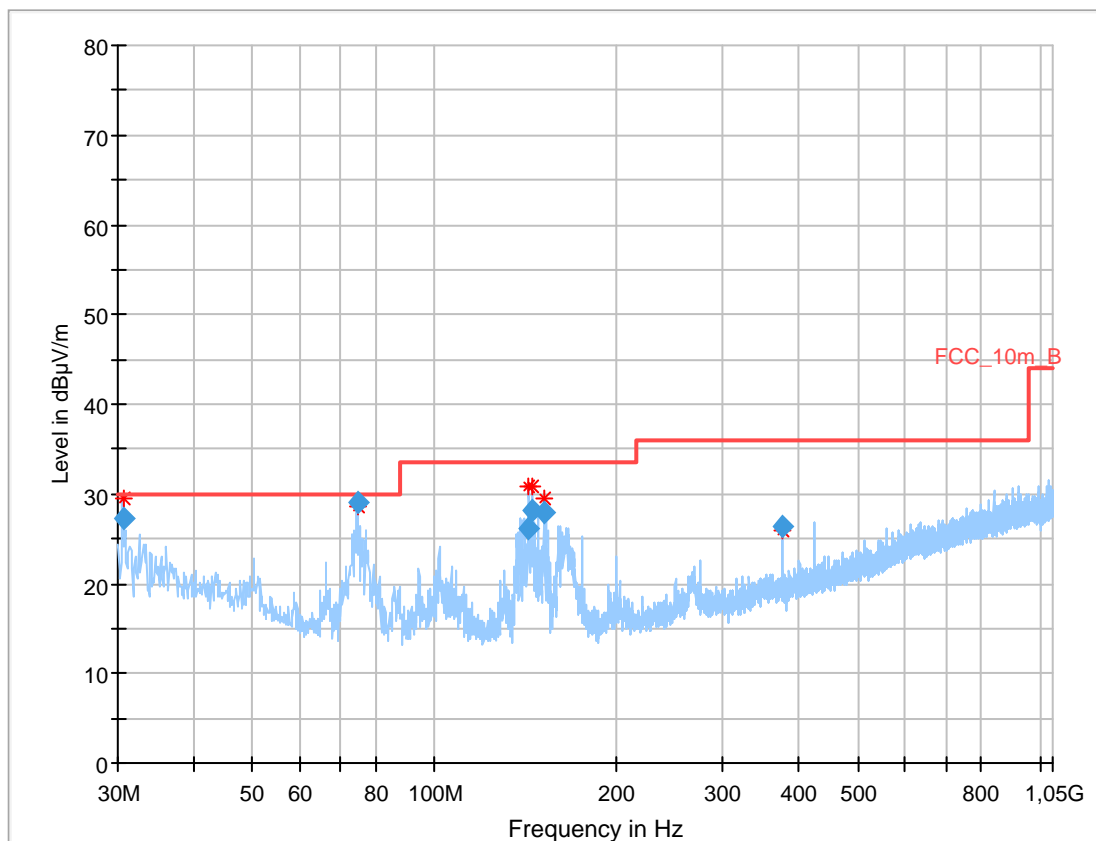
Frequency (MHz)	QuasiPeak (dBμV/m)	Limit (dBμV/m)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB)
34.016700	12.24	30.00	17.76	1000.0	120.000	179.0	V	0.0	13.7
74.622450	24.67	30.00	5.33	1000.0	120.000	101.0	V	71.0	8.3
101.937300	10.19	33.50	23.31	1000.0	120.000	185.0	V	0.0	12.0
166.161450	26.46	33.50	7.04	1000.0	120.000	98.0	V	29.0	9.5
174.991650	23.51	33.50	9.99	1000.0	120.000	98.0	V	36.0	10.1
200.000550	20.85	33.50	12.65	1000.0	120.000	98.0	V	307.0	11.7

Plot 3: 30 MHz to 1 GHz, vertical & horizontal polarization, high channel**Final_Result:**

Frequency (MHz)	QuasiPeak (dBμV/m)	Limit (dBμV/m)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB)
33.330000	16.56	30.00	13.44	1000.0	120.000	185.0	V	264.0	13.6
73.018950	21.37	30.00	8.63	1000.0	120.000	185.0	V	95.0	8.3
74.604600	26.53	30.00	3.47	1000.0	120.000	185.0	V	84.0	8.3
166.118250	25.68	33.50	7.82	1000.0	120.000	98.0	V	22.0	9.5
200.002800	22.27	33.50	11.23	1000.0	120.000	98.0	V	322.0	11.7
876.077100	21.32	36.00	14.68	1000.0	120.000	98.0	H	105.0	23.8

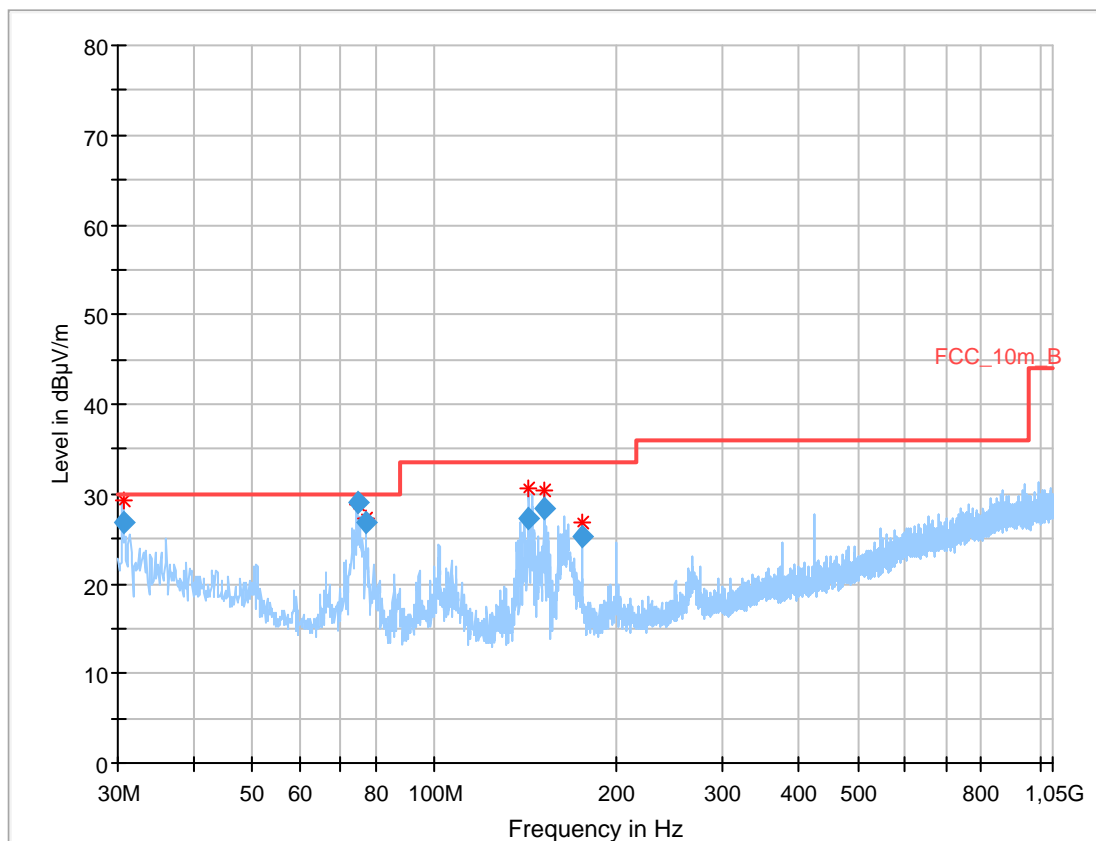
Plot: OFDM (20 MHz)

Plot 1: 30 MHz to 1 GHz, vertical & horizontal polarization, low channel

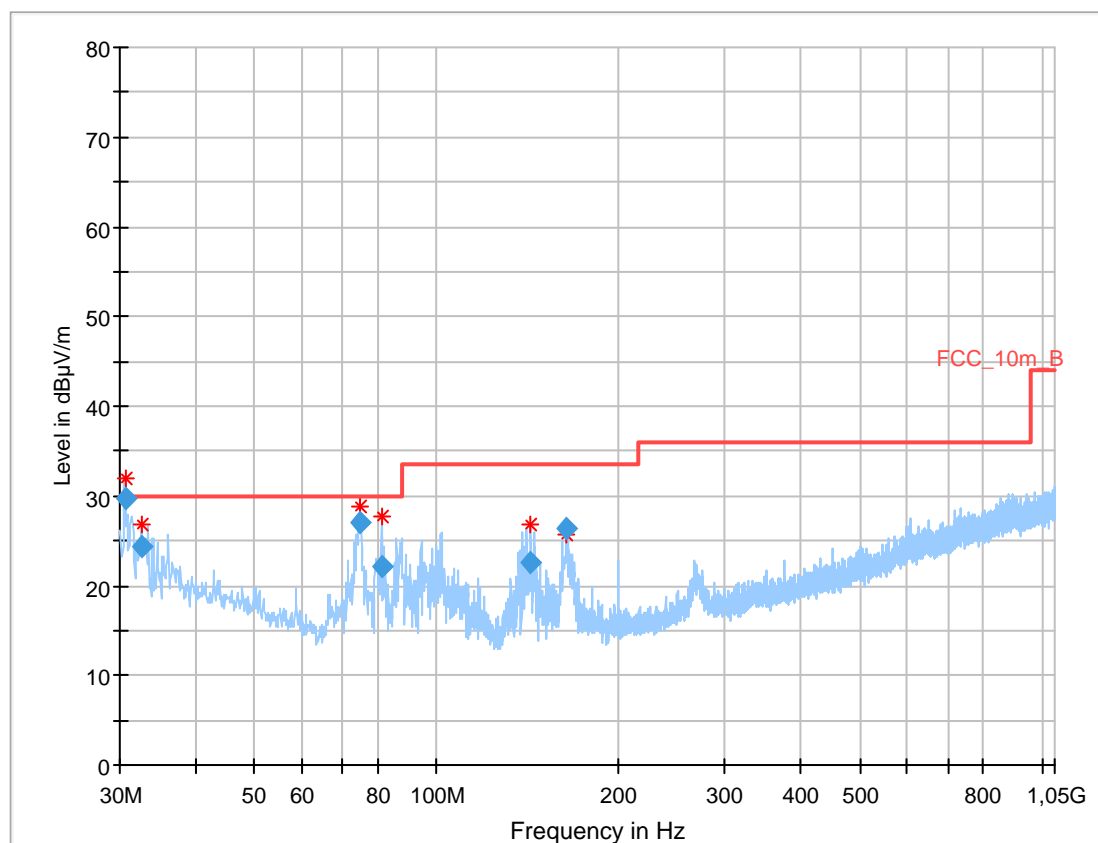


Final_Result:

Frequency (MHz)	QuasiPeak (dBμV/m)	Limit (dBμV/m)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB)
30.626734	27.17	30.00	2.83	1000.0	120.000	101.0	V	119.0	13.4
74.589600	28.98	30.00	1.02	1000.0	120.000	185.0	V	262.0	8.3
143.304600	26.23	33.50	7.27	1000.0	120.000	98.0	V	131.0	8.8
145.244250	28.07	33.50	5.43	1000.0	120.000	98.0	V	138.0	8.8
151.578900	27.88	33.50	5.62	1000.0	120.000	98.0	V	346.0	8.9
375.006300	26.43	36.00	9.57	1000.0	120.000	185.0	H	54.0	16.5

Plot 2: 30 MHz to 1 GHz, vertical & horizontal polarization, mid channel**Final_Result:**

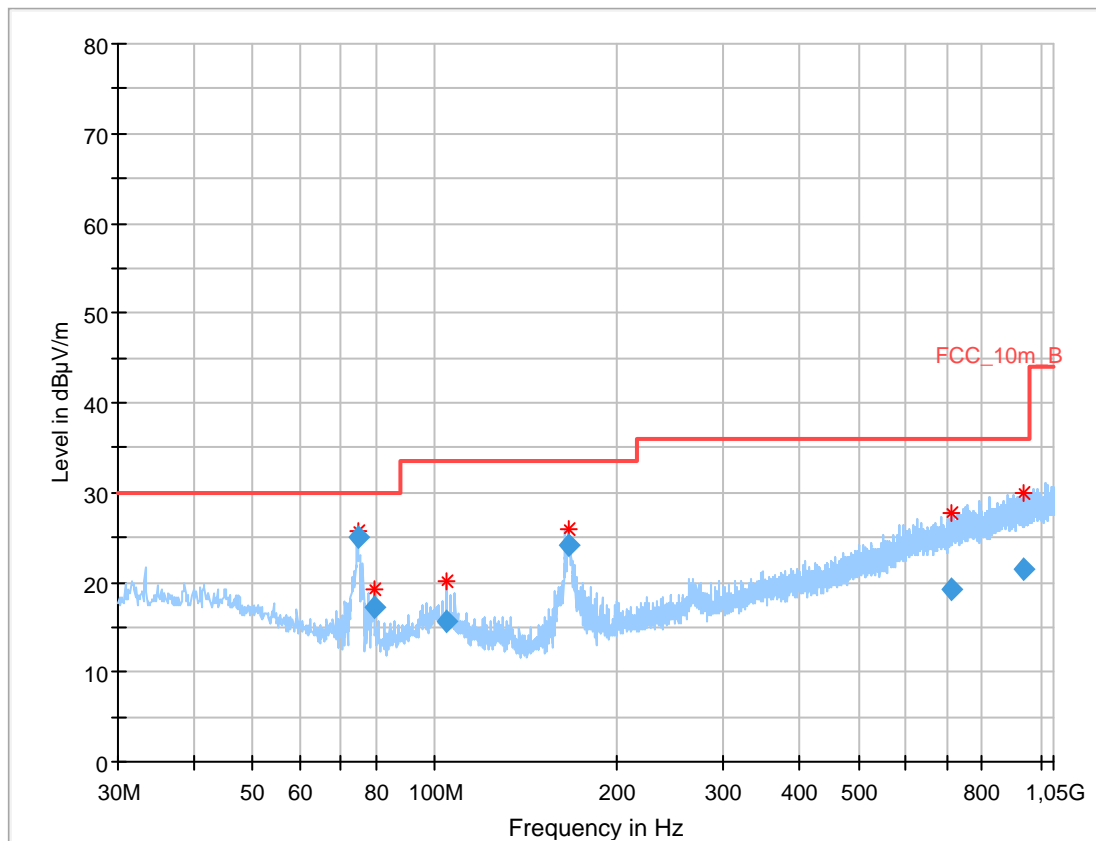
Frequency (MHz)	QuasiPeak (dBμV/m)	Limit (dBμV/m)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB)
30.622016	26.84	30.00	3.16	1000.0	120.000	101.0	V	233.0	13.4
74.559000	29.15	30.00	0.85	1000.0	120.000	179.0	V	257.0	8.3
77.202000	26.75	30.00	3.25	1000.0	120.000	185.0	V	295.0	8.2
143.312550	27.33	33.50	6.17	1000.0	120.000	98.0	V	79.0	8.8
151.580100	28.45	33.50	5.05	1000.0	120.000	98.0	V	353.0	8.9
175.003800	25.36	33.50	8.14	1000.0	120.000	98.0	V	233.0	10.1

Plot 3: 30 MHz to 1 GHz, vertical & horizontal polarization, high channel**Final_Result:**

Frequency (MHz)	QuasiPeak (dBμV/m)	Limit (dBμV/m)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB)
30.607170	29.78	30.00	0.22	1000.0	120.000	185.0	V	200.0	13.4
32.583300	24.33	30.00	5.67	1000.0	120.000	101.0	V	192.0	13.6
74.649000	27.07	30.00	2.93	1000.0	120.000	180.0	V	99.0	8.3
81.183300	22.04	30.00	7.96	1000.0	120.000	101.0	V	55.0	8.4
143.301900	22.65	33.50	10.85	1000.0	120.000	101.0	V	242.0	8.8
163.915800	26.26	33.50	7.24	1000.0	120.000	98.0	V	192.0	9.3

Plot: RX / Idle mode

Plot 1: 30 MHz to 1 GHz, vertical & horizontal polarization



Final_Result:

Frequency (MHz)	QuasiPeak (dBμV/m)	Limit (dBμV/m)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB)
74.583150	24.98	30.00	5.02	1000.0	120.000	101.0	V	135.0	8.3
79.312500	17.20	30.00	12.80	1000.0	120.000	101.0	V	278.0	8.1
104.703150	15.56	33.50	17.94	1000.0	120.000	101.0	V	332.0	11.7
166.088700	24.13	33.50	9.37	1000.0	120.000	98.0	V	1.0	9.5
710.010900	19.12	36.00	16.88	1000.0	120.000	185.0	V	220.0	21.8
933.805200	21.35	36.00	14.65	1000.0	120.000	101.0	H	82.0	24.2

12.13 Spurious emissions radiated above 1 GHz

Description:

Measurement of the radiated spurious emissions above 1 GHz in transmit mode and receiver / idle mode.

Measurement:

Measurement parameter	
Detector:	Peak / RMS
Sweep time:	Auto
Resolution bandwidth:	1 MHz
Video bandwidth:	3 x RBW
Span:	1 GHz to 26 GHz
Trace mode:	Max Hold
Measured modulation	<input checked="" type="checkbox"/> DSSS b – mode <input type="checkbox"/> OFDM g – mode <input checked="" type="checkbox"/> OFDM n HT20 – mode <input type="checkbox"/> OFDM n HT40 – mode <input checked="" type="checkbox"/> RX / Idle – mode
Test setup:	See sub clause 7.2 – A & 7.3 - A
Measurement uncertainty	See sub clause 9

Limits:

FCC		IC
In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 30 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement. Attenuation below the general limits specified in Section 15.209(a) is not required. In addition, radiated emissions which fall in the restricted bands, as defined in §15.205(a), must also comply with the radiated emission limits specified in §15.209(a) (see §15.205(c)).		
Frequency (MHz)	Field Strength (dB μ V/m)	Measurement distance
Above 960	54.0	3

Results: DSSS

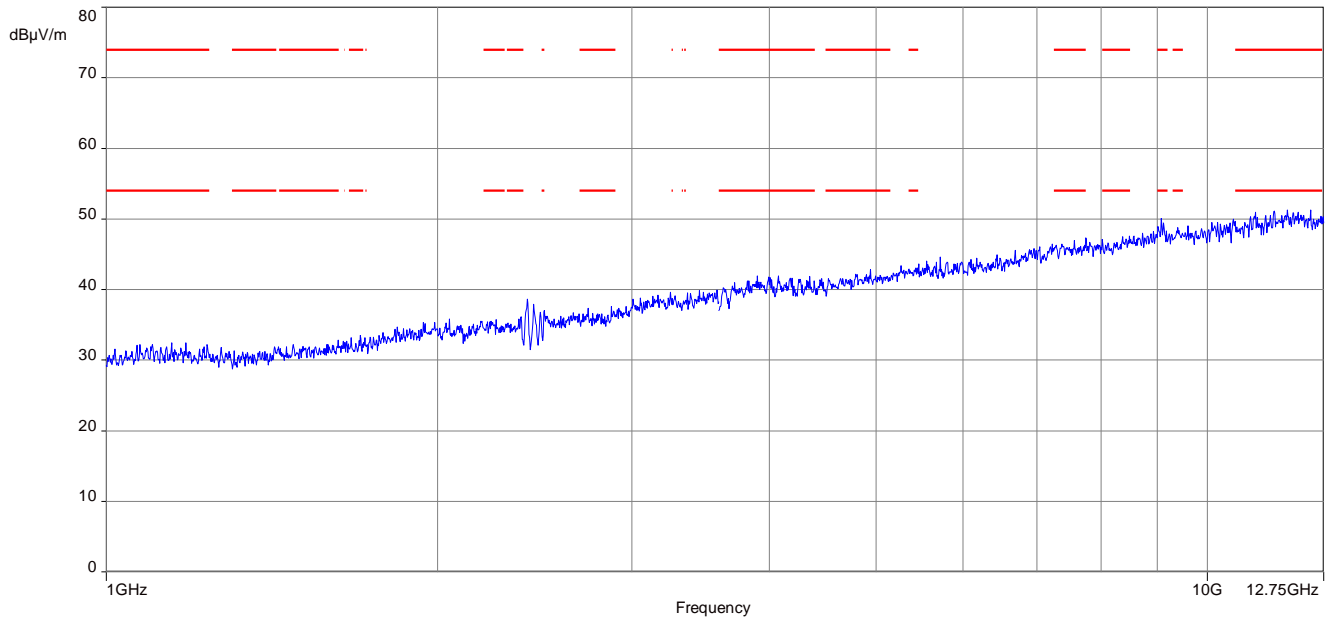
TX Spurious Emissions Radiated [dBμV/m]								
2412 MHz			2437 MHz			2462 MHz		
F [MHz]	Detector	Level [dBμV/m]	F [MHz]	Detector	Level [dBμV/m]	F [MHz]	Detector	Level [dBμV/m]
No spurious emissions detected.			No spurious emissions detected.			No spurious emissions detected.		
-/-	Peak	-/-	-/-	Peak	-/-	-/-	Peak	-/-
	AVG	-/-		AVG	-/-		AVG	-/-
-/-	Peak	-/-	-/-	Peak	-/-	-/-	Peak	-/-
	AVG	-/-		AVG	-/-		AVG	-/-

Results: OFDM (20 MHz)

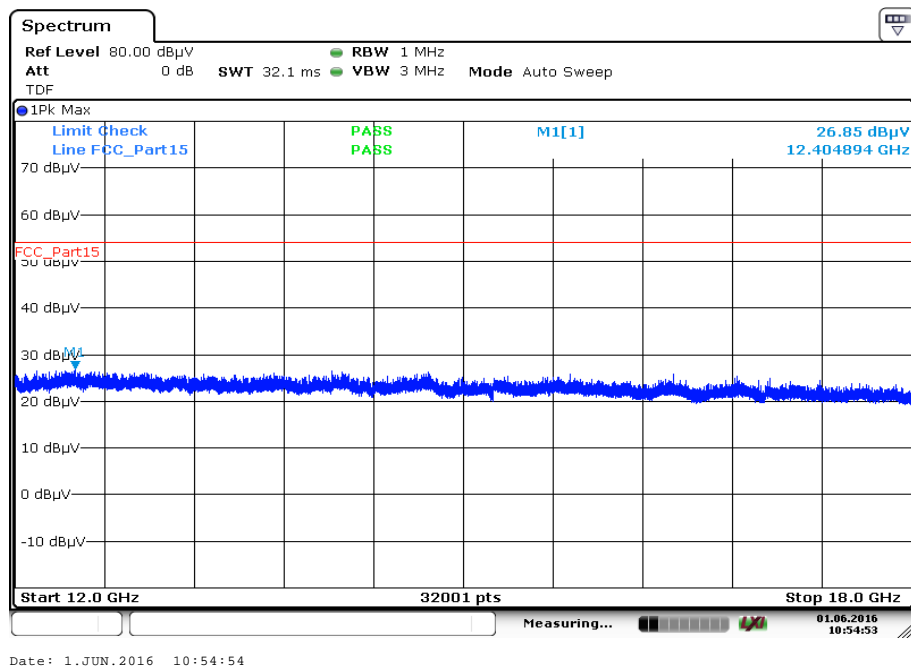
TX Spurious Emissions Radiated [dBμV/m]								
2412 MHz			2437 MHz			2462 MHz		
F [MHz]	Detector	Level [dBμV/m]	F [MHz]	Detector	Level [dBμV/m]	F [MHz]	Detector	Level [dBμV/m]
No spurious emissions detected.			No spurious emissions detected.			No spurious emissions detected.		
-/-	Peak	-/-	-/-	Peak	-/-	-/-	Peak	-/-
	AVG	-/-		AVG	-/-		AVG	-/-
-/-	Peak	-/-	-/-	Peak	-/-	-/-	Peak	-/-
	AVG	-/-		AVG	-/-		AVG	-/-

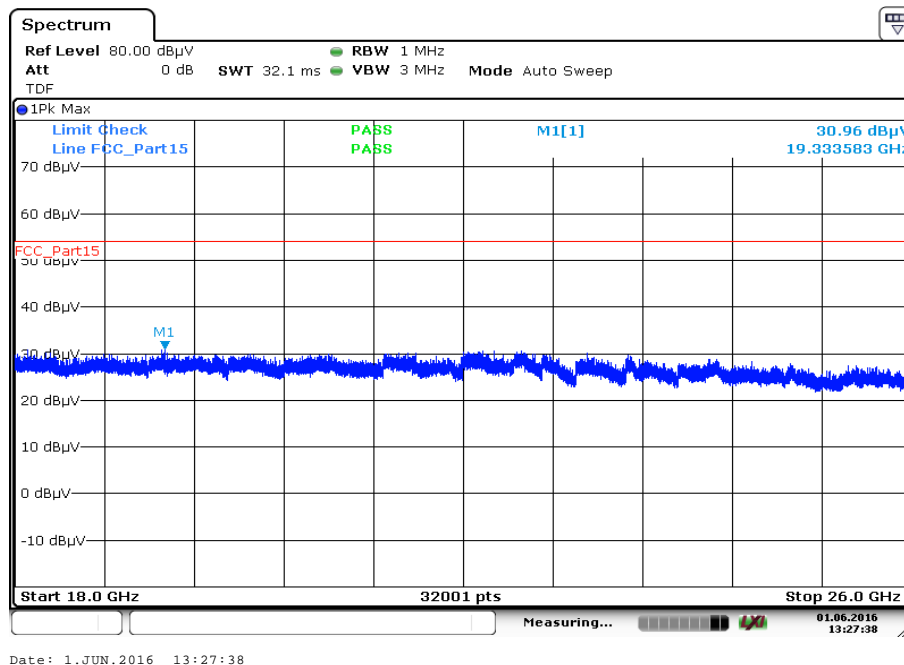
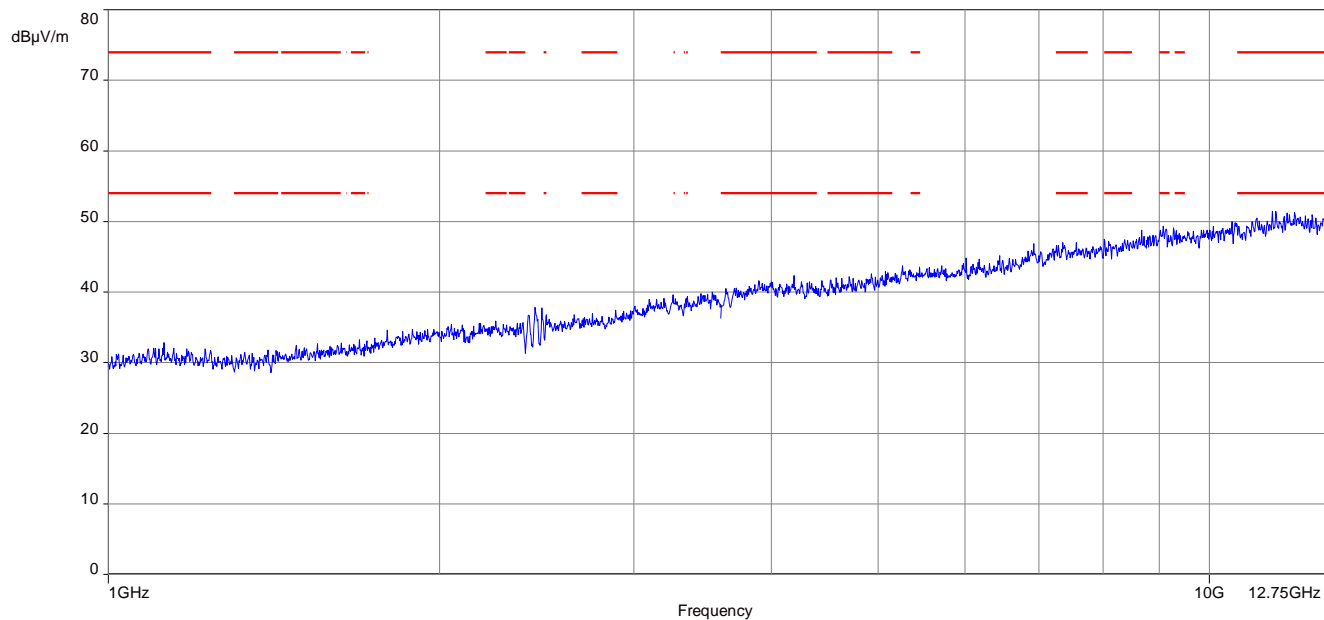
Results: RX / idle – mode

TX Spurious Emissions Radiated [dBμV/m]		
F [MHz]	Detector	Level [dBμV/m]
No spurious emissions detected.		
-/-	Peak	-/-
	AVG	-/-
-/-	Peak	-/-
	AVG	-/-

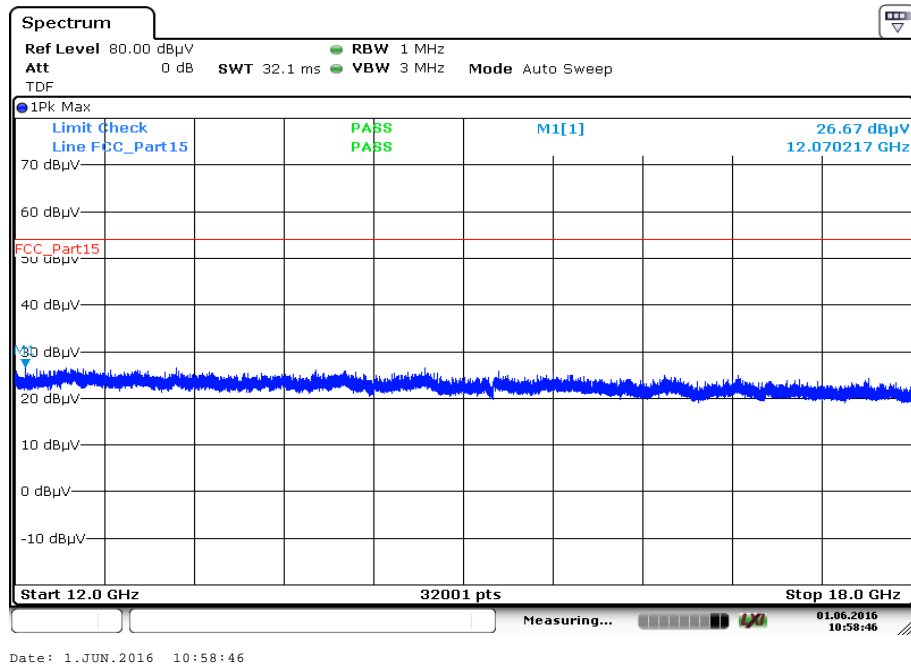
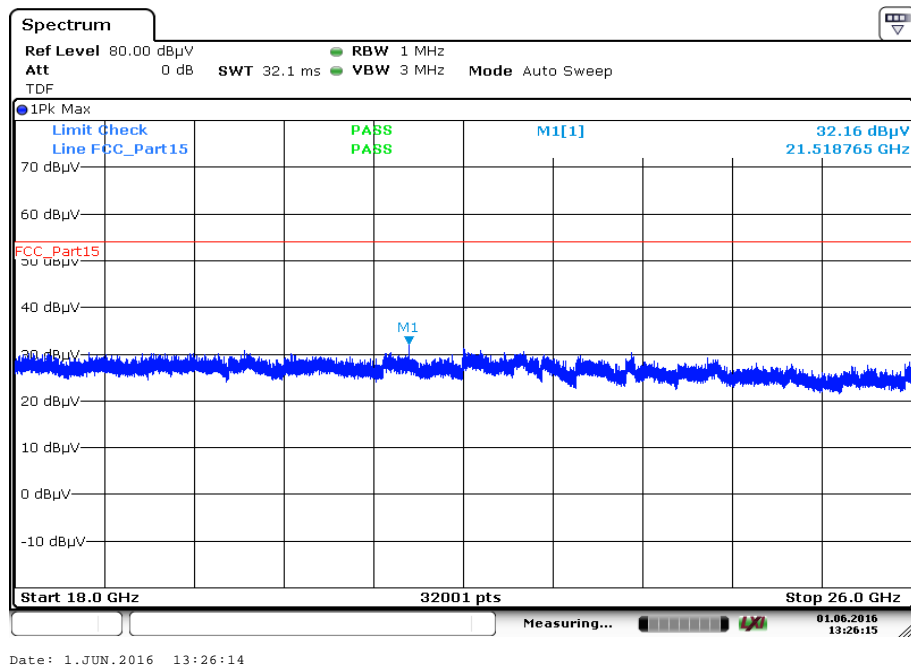
Plots: DSSS**Plot 1:** Lowest channel, 1 GHz to 12.75 GHz, vertical & horizontal polarization

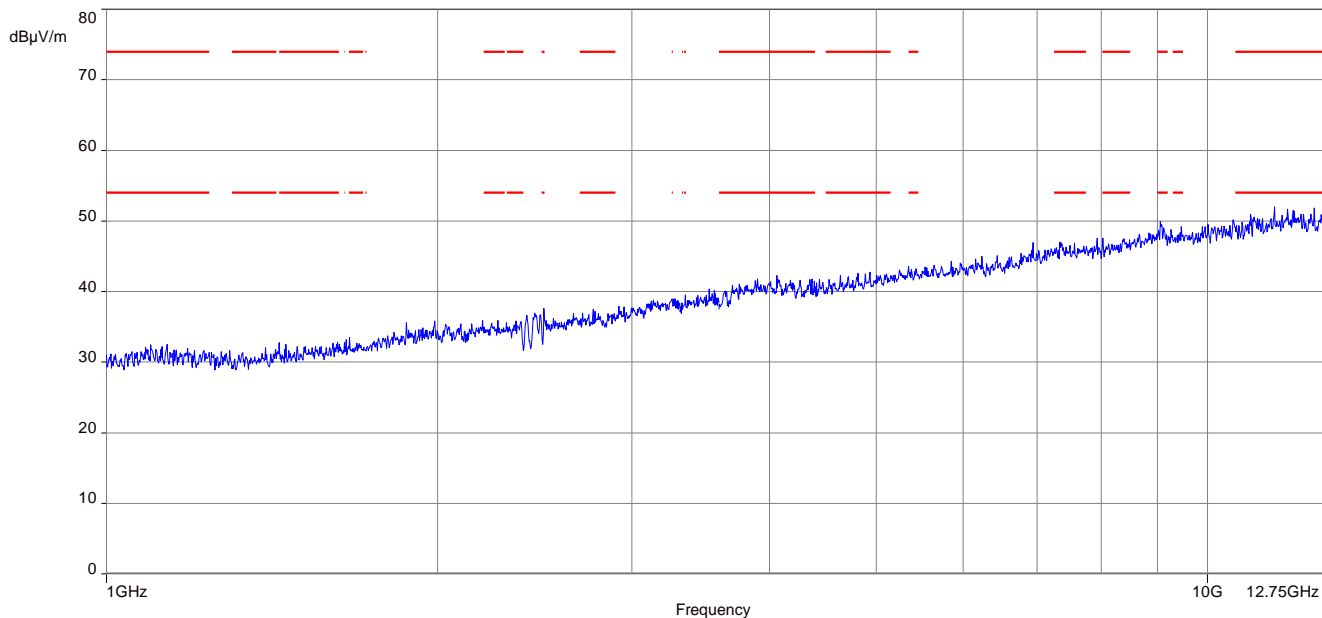
The carrier signal is notched with a 2.4 GHz band rejection filter.

Plot 2: Lowest channel, 12 GHz to 18 GHz, vertical & horizontal polarization, peak & average

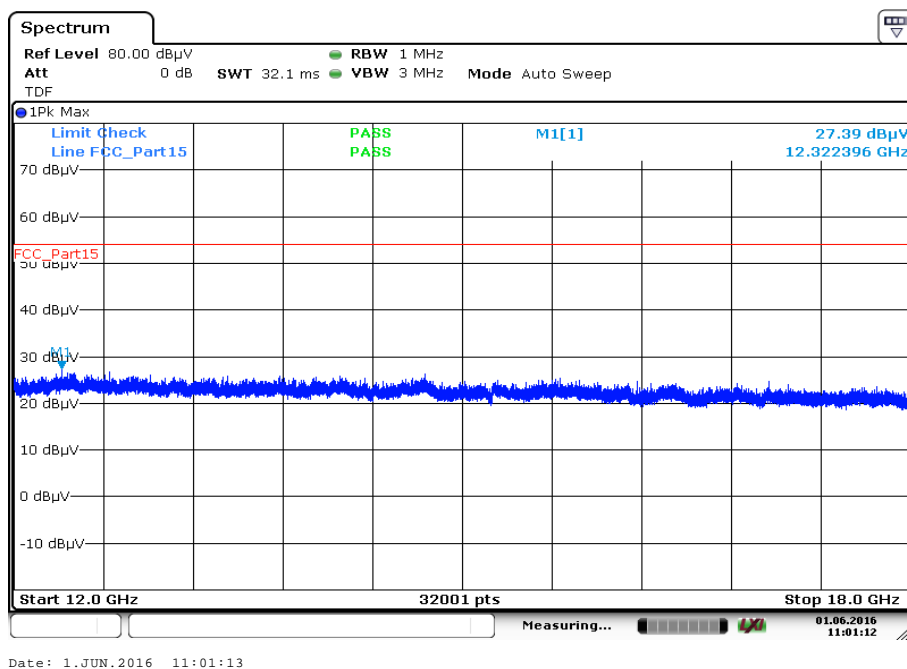
Plot 3: Lowest channel, 18 GHz to 26 GHz, vertical & horizontal polarization**Plot 4:** Middle channel, 1 GHz to 12.75 GHz, vertical & horizontal polarization

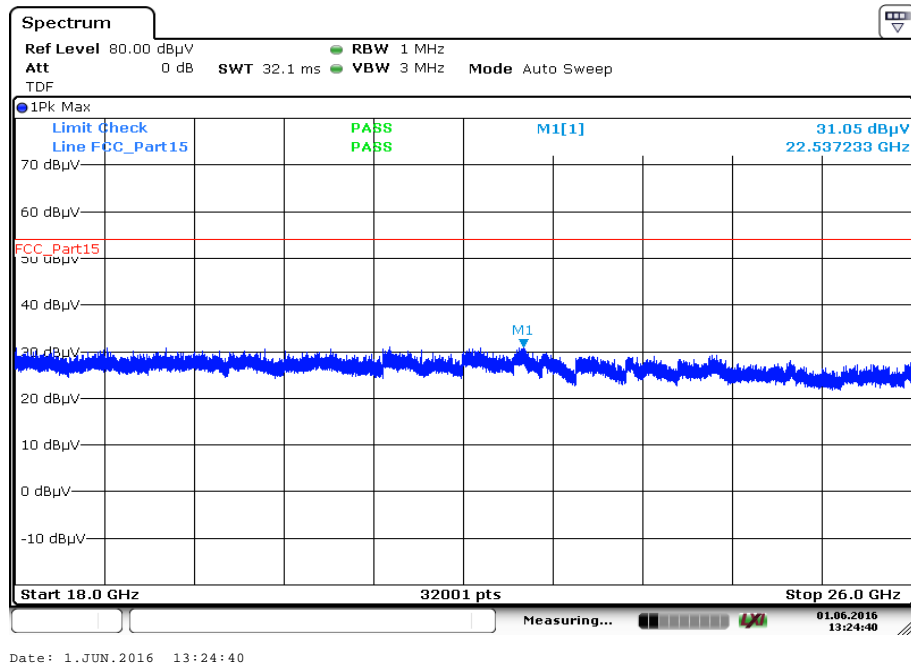
The carrier signal is notched with a 2.4 GHz band rejection filter.

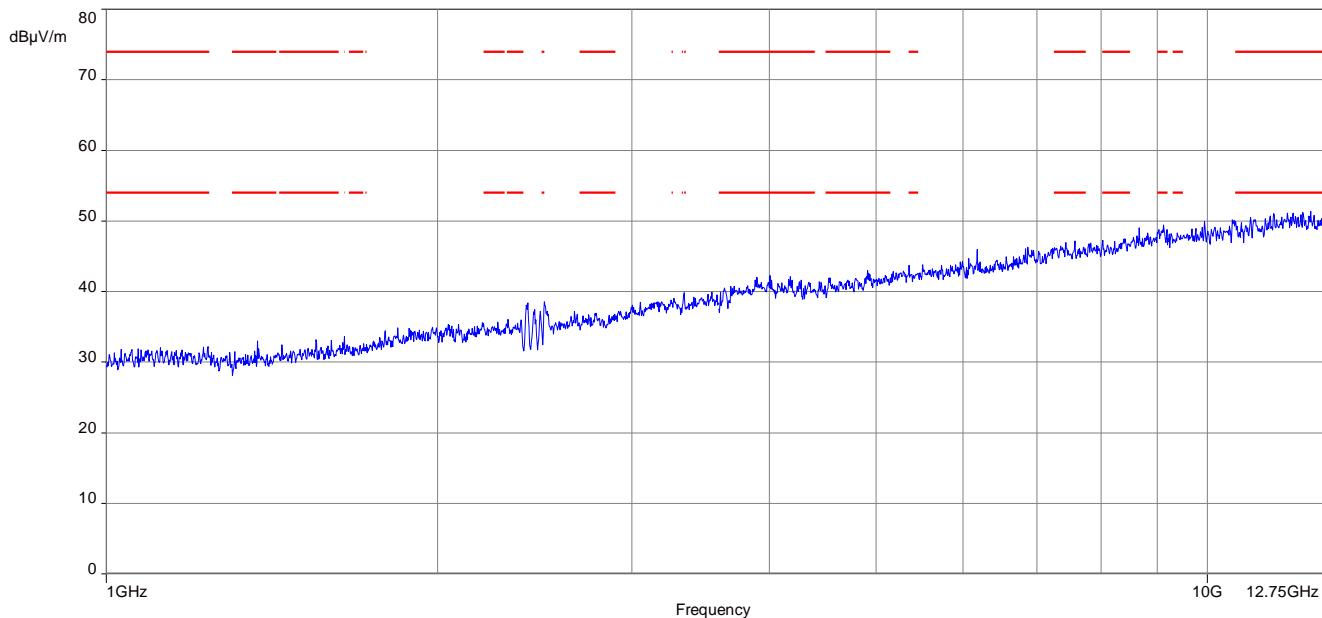
Plot 5: Middle channel, 12 GHz to 18 GHz, vertical & horizontal polarization**Plot 6:** Middle channel, 18 GHz to 26 GHz, vertical & horizontal polarization

Plot 7: Highest channel, 1 GHz to 12.75 GHz, vertical & horizontal polarization

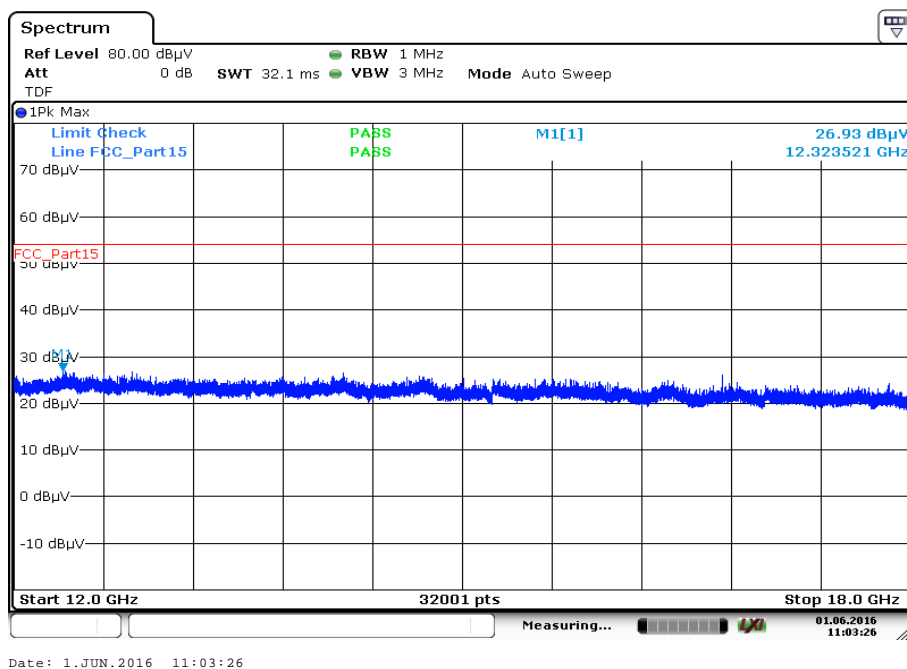
The carrier signal is notched with a 2.4 GHz band rejection filter.

Plot 8: Highest channel, 12 GHz to 18 GHz, vertical & horizontal polarization

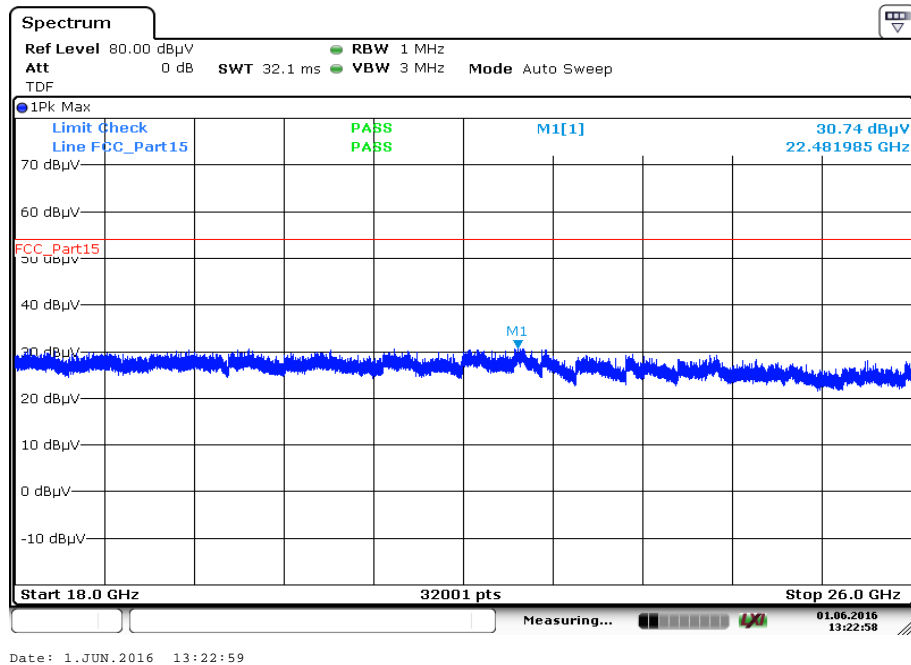
Plot 9: Highest channel, 18 GHz to 26 GHz, vertical & horizontal polarization

Plots: OFDM (20 MHz)**Plot 1:** Lowest channel, 1 GHz to 12.75 GHz, vertical & horizontal polarization

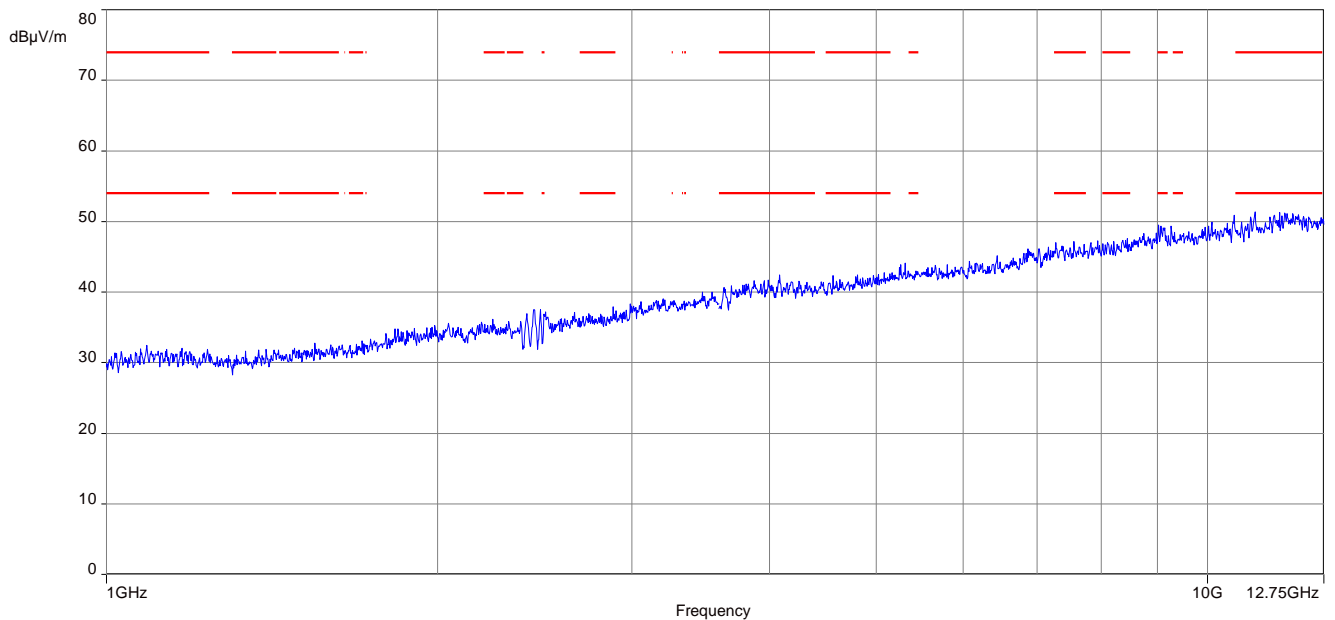
The carrier signal is notched with a 2.4 GHz band rejection filter.

Plot 2: Lowest channel, 12 GHz to 18 GHz, vertical & horizontal polarization

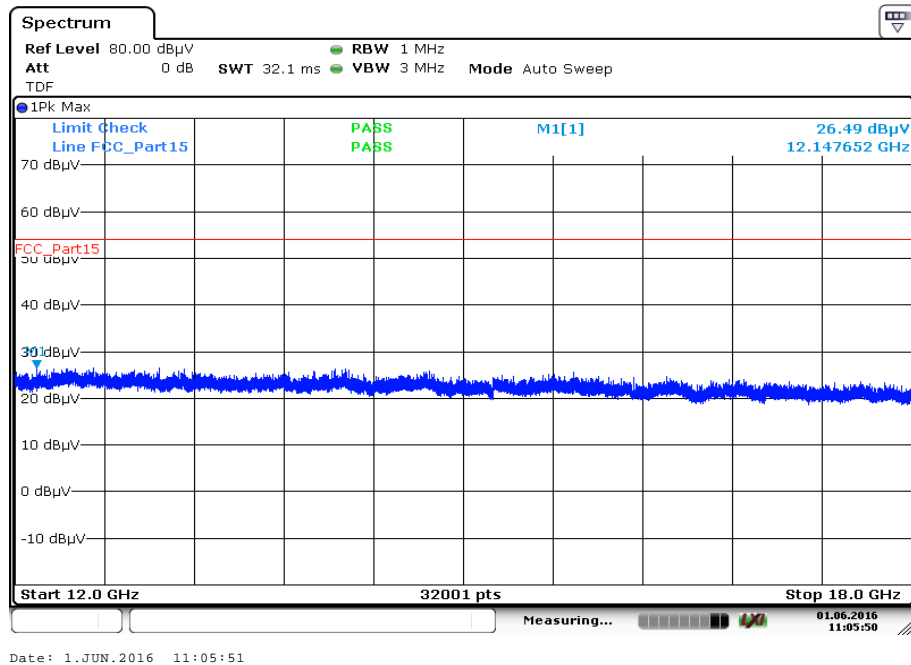
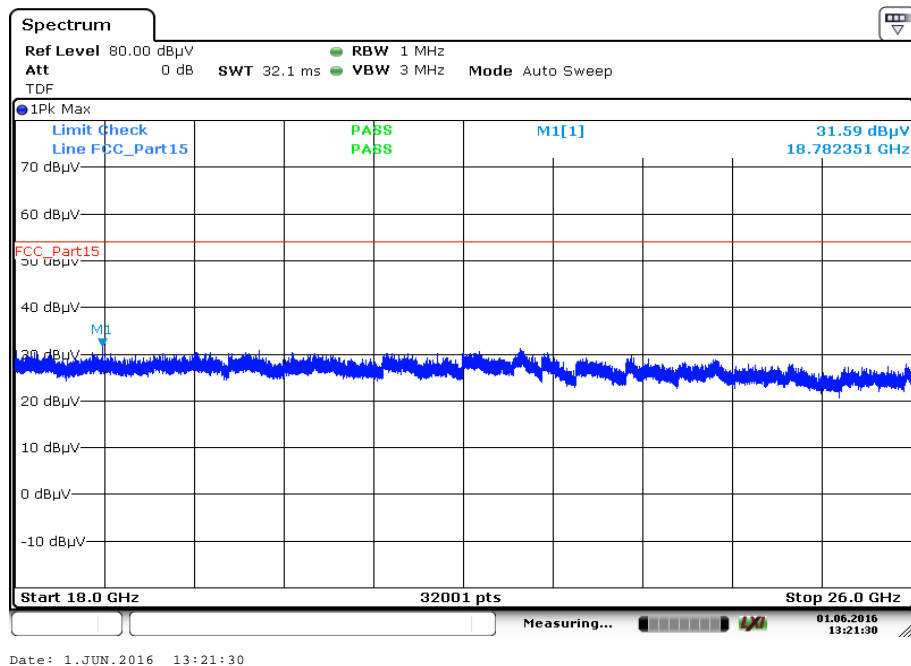
Plot 3: Lowest channel, 18 GHz to 26 GHz, vertical & horizontal polarization

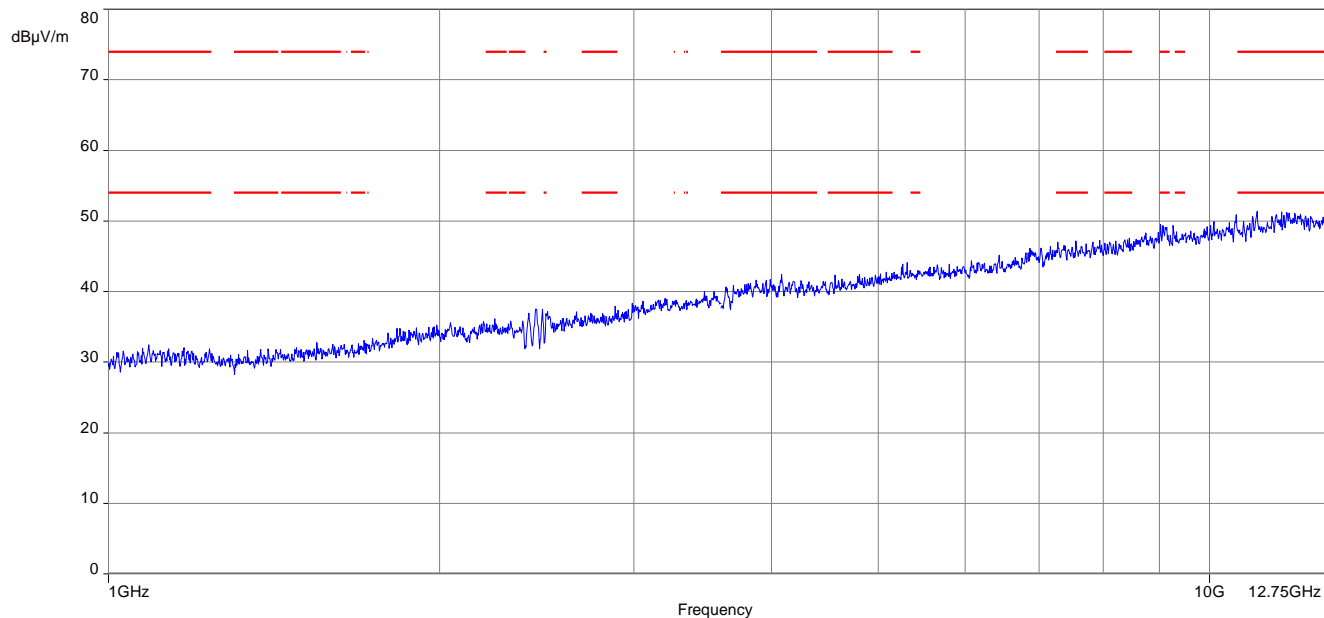


Plot 4: Middle channel, 1 GHz to 12.75 GHz, vertical & horizontal polarization

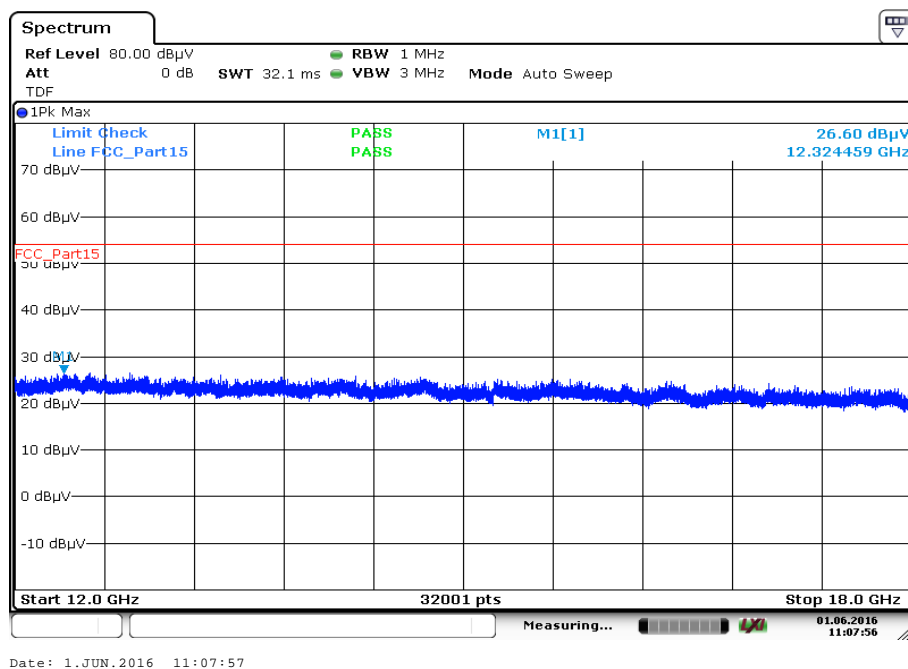


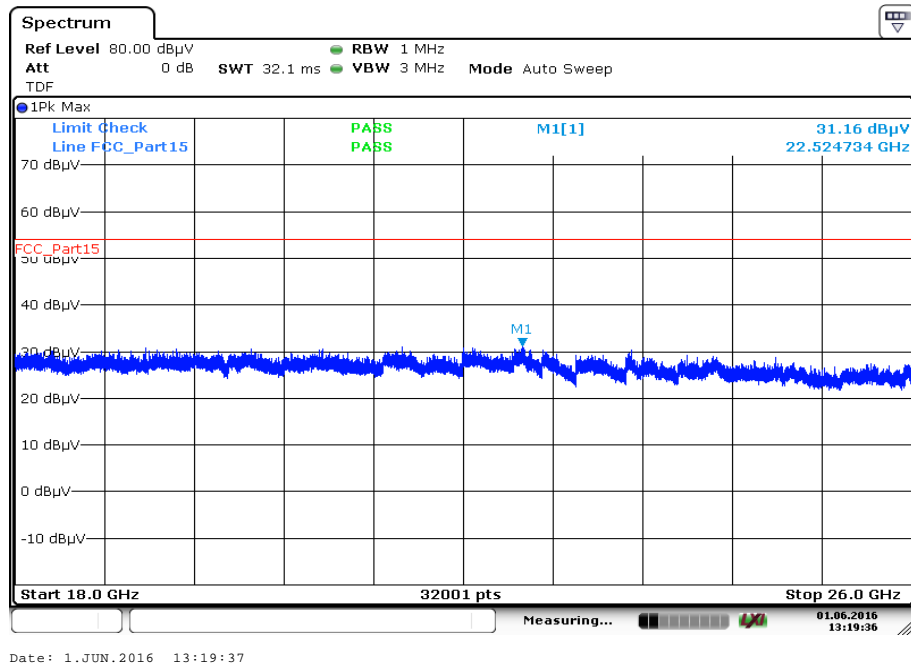
The carrier signal is notched with a 2.4 GHz band rejection filter.

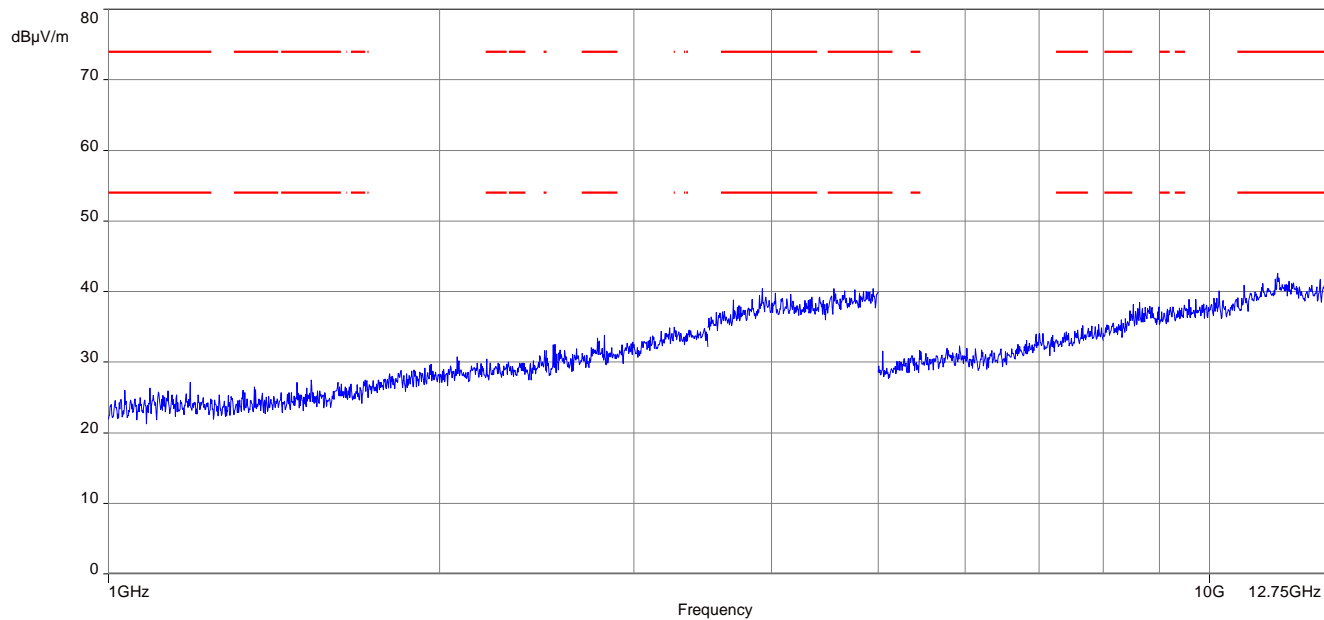
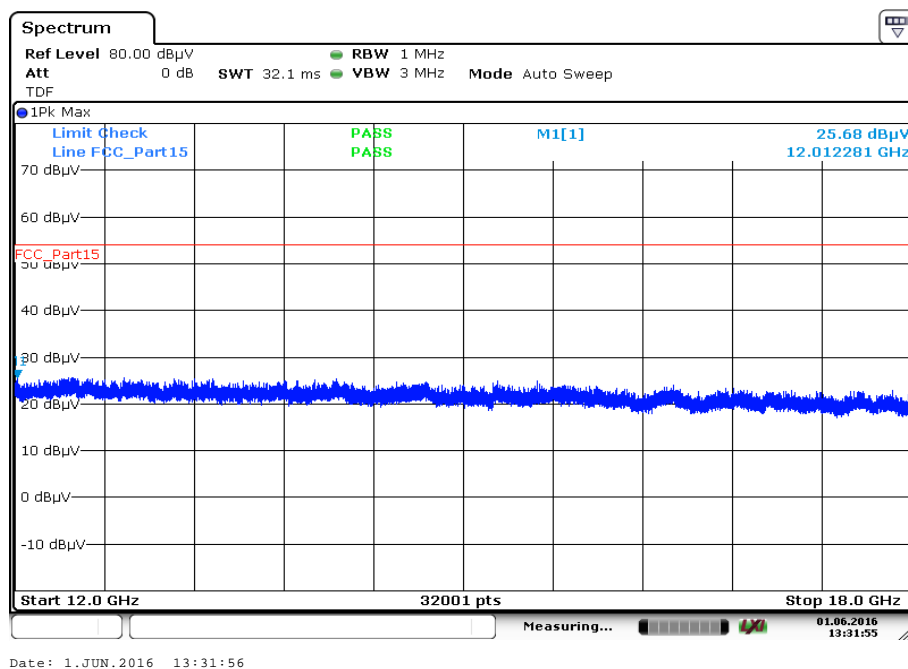
Plot 5: Middle channel, 12 GHz to 18 GHz, vertical & horizontal polarization**Plot 6:** Middle channel, 18 GHz to 26 GHz, vertical & horizontal polarization

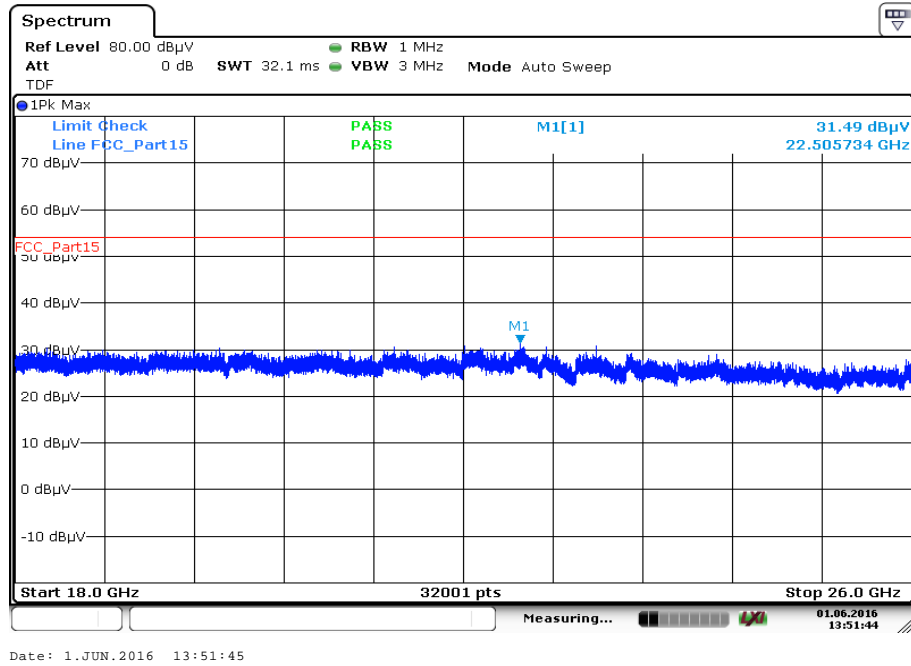
Plot 7: Highest channel, 1 GHz to 12.75 GHz, vertical & horizontal polarization

The carrier signal is notched with a 2.4 GHz band rejection filter.

Plot 8: Highest channel, 12 GHz to 18 GHz, vertical & horizontal polarization

Plot 9: Highest channel, 18 GHz to 26 GHz, vertical & horizontal polarization

Plots: RX / idle mode**Plot 1:** 1 GHz to 12.75 GHz, vertical & horizontal polarization**Plot 2:** 12 GHz to 18 GHz, vertical & horizontal polarization

Plot 3: 18 GHz to 26 GHz, vertical & horizontal polarization

12.14 Spurious emissions conducted below 30 MHz (AC conducted)

Description:

Measurement of the conducted spurious emissions in transmit mode below 30 MHz. The EUT is set to channel 6. This measurement is repeated for DSSS and OFDM modulation. If peaks are found channel 1 and channel 11 will be measured too. The measurement is performed with the data rate producing the highest output power. Both power lines, phase and neutral line, are measured. Found peaks are re-measured with average and quasi peak detection to show compliance to the limits.

Measurement:

Measurement parameter	
Detector:	Peak - Quasi Peak / Average
Sweep time:	Auto
Resolution bandwidth:	F < 150 kHz: 200 Hz F > 150 kHz: 9 kHz
Video bandwidth:	F < 150 kHz: 1 kHz F > 150 kHz: 100 kHz
Span:	9 kHz to 30 MHz
Trace mode:	Max Hold
Test setup:	See sub clause 7.4 - A
Measurement uncertainty:	See sub clause 9

Limits:

FCC		IC
Frequency (MHz)	Quasi-Peak (dB μ V/m)	Average (dB μ V/m)
0.15 – 0.5	66 to 56*	56 to 46*
0.5 – 5	56	46
5 – 30.0	60	50

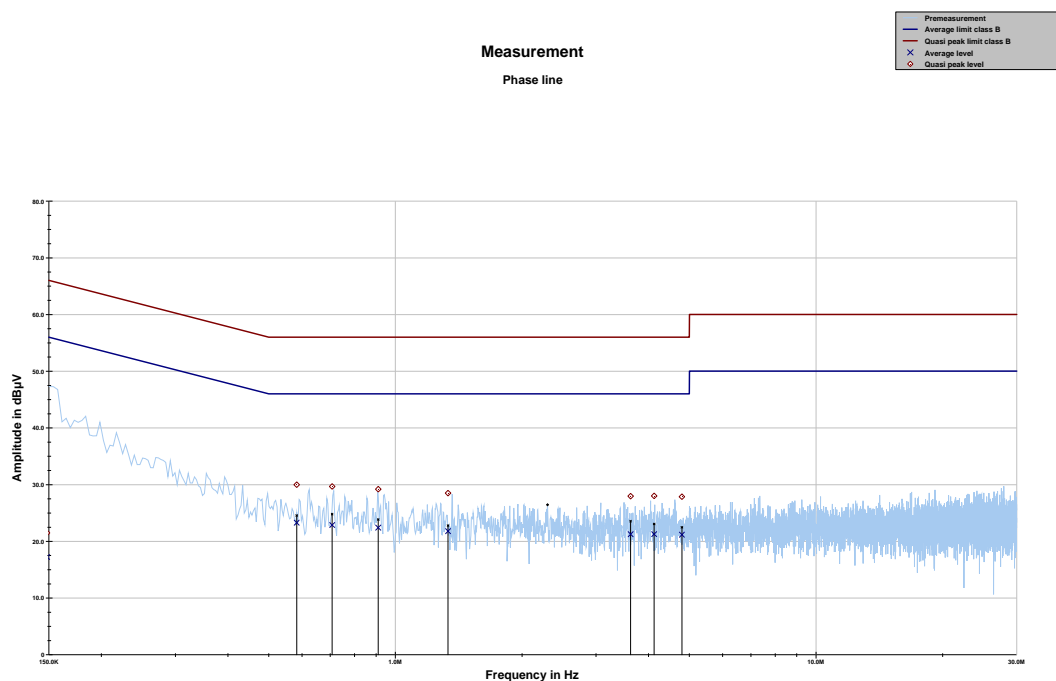
*Decreases with the logarithm of the frequency

Results:

TX Spurious Emissions Conducted < 30 MHz [dB μ V/m]		
F [MHz]	Detector	Level [dB μ V/m]
All detected peaks are more than 20 dB below the limit.		

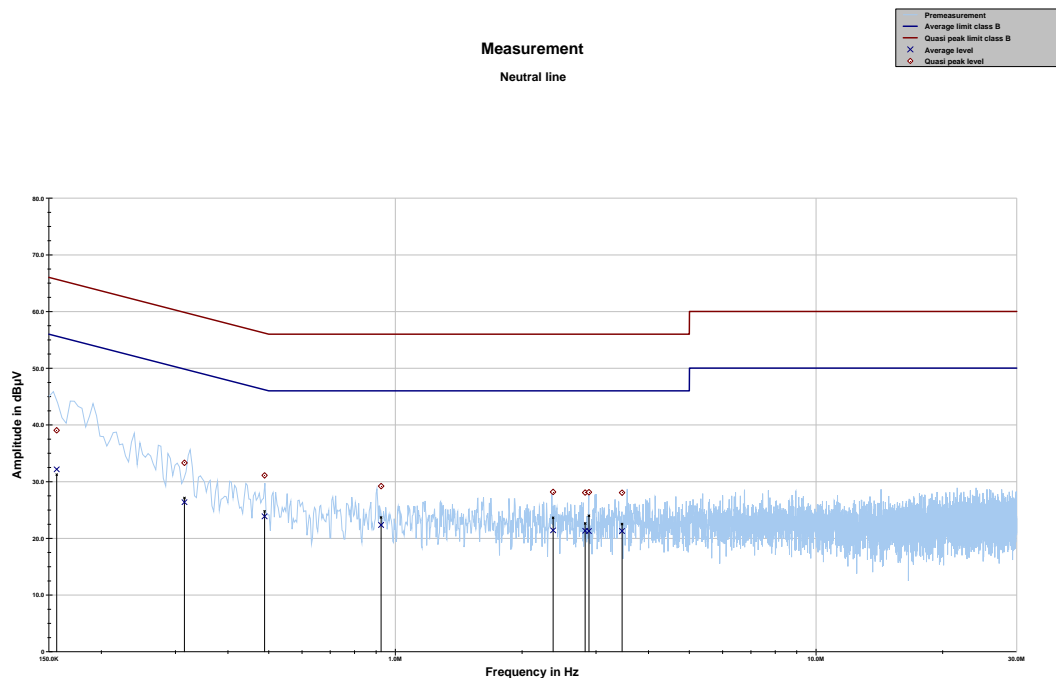
Plots:

Plot 1: 150 kHz to 30 MHz, phase line



Frequency	Quasi peak level	Margin quasi peak	Limit QP	Average level	Margin average	Limit AV
MHz	dBμV	dB	dBμV	dBμV	dB	dBμV
0.582754	29.98	26.02	56.000	23.28	22.72	46.000
0.707582	29.66	26.34	56.000	22.88	23.12	46.000
0.910275	29.20	26.80	56.000	22.41	23.59	46.000
1.334074	28.51	27.49	56.000	21.78	24.22	46.000
3.624898	27.96	28.04	56.000	21.25	24.75	46.000
4.122355	28.02	27.98	56.000	21.27	24.73	46.000
4.798027	27.87	28.13	56.000	21.17	24.83	46.000

Plot 2: 150 kHz to 30 MHz, neutral line



Project ID: 1-0644/15-01-02

Frequency	Quasi peak level	Margin quasi peak	Limit QP	Average level	Margin average	Limit AV
MHz	dBµV	dB	dBµV	dBµV	dB	dBµV
0.156567	39.04	26.60	65.644	32.16	23.66	55.812
0.315156	33.31	26.52	59.833	26.37	24.91	51.281
0.488836	31.09	25.10	56.188	23.87	22.45	46.319
0.924693	29.21	26.79	56.000	22.35	23.65	46.000
2.370510	28.17	27.83	56.000	21.40	24.60	46.000
2.827326	28.06	27.94	56.000	21.33	24.67	46.000
2.885429	28.13	27.87	56.000	21.28	24.72	46.000
3.459000	28.05	27.95	56.000	21.28	24.72	46.000

13 Observations

No observations except those reported with the single test cases have been made.

Annex A Document history

Version	Applied changes	Date of release
	Initial release	2016-11-14

Annex B Further information

Glossary

AVG	-	Average
DUT	-	Device under test
EMC	-	Electromagnetic Compatibility
EN	-	European Standard
EUT	-	Equipment under test
ETSI	-	European Telecommunications Standard Institute
FCC	-	Federal Communication Commission
FCC ID	-	Company Identifier at FCC
HW	-	Hardware
IC	-	Industry Canada
Inv. No.	-	Inventory number
N/A	-	Not applicable
PP	-	Positive peak
QP	-	Quasi peak
S/N	-	Serial number
SW	-	Software
PMN	-	Product marketing name
HMN	-	Host marketing name
HVIN	-	Hardware version identification number
FVIN	-	Firmware version identification number

Annex C Accreditation Certificate

Front side of certificate



Deutsche Akkreditierungsstelle GmbH

Befähigte gemäß § 8 Absatz 1 AkkStelleG i.V.m. § 1 Absatz 1 AkkStelleGBV
Unterzeichnerin der Multilateralen Abkommen
von EA, ILAC und IAF zur gegenseitigen Anerkennung

Akkreditierung



Die Deutsche Akkreditierungsstelle GmbH bestätigt hiermit, dass das Prüflaboratorium

CETECOM ICT Services GmbH
Untertürkheimer Straße 6-10, 66117 Saarbrücken

die Kompetenz nach DIN EN ISO/IEC 17025:2005 besitzt, Prüfungen in folgenden Bereichen durchzuführen:

Funk
Mobilfunk (GSM / DCS) + OTA
Elektromagnetische Verträglichkeit (EMV)
Produktsicherheit
SAR / EMF
Umwelt
Smart Card Technology
Bluetooth®
Automotive
Wi-Fi-Services
Kanadische Anforderungen
US-Anforderungen
Akustik
Near Field Communication (NFC)

Die Akkreditierungsurkunde gilt nur in Verbindung mit dem Bescheid vom 04.05.2016 mit der Akkreditierungsnummer D-PL-12076-01 und ist gültig bis 17.01.2018. Sie besteht aus diesem Deckblatt, der Rückseite des Deckblatts und der folgenden Anlage mit insgesamt 63 Seiten.

Registrierungsnummer der Urkunde: D-PL-12076-01-01

Frankfurt, 04.05.2016

Siehe Hinweis auf der Rückseite

Im Auftrag Dipl.-Ing. (FH) Ralf Eigner
Abteilungsleiter

Back side of certificate

Deutsche Akkreditierungsstelle GmbH

Standort Berlin
Spittelmarkt 10
10117 Berlin

Standort Frankfurt am Main
Europa-Allee 52
60327 Frankfurt am Main

Standort Braunschweig
Bundesallee 100
38116 Braunschweig

Die auszugsweise Veröffentlichung der Akkreditierungsurkunde bedarf der vorherigen schriftlichen Zustimmung der Deutschen Akkreditierungsstelle GmbH (DAkkS). Ausgenommen davon ist die separate Weiterverbreitung des Deckblattes durch die umseitig genannte Konformitätsbewertungsstelle in unveränderter Form.

Es darf nicht der Anschein erweckt werden, dass sich die Akkreditierung auch auf Bereiche erstreckt, die über den durch die DAkkS bestätigten Akkreditierungsbereich hinausgehen.

Die Akkreditierung erfolgte gemäß des Gesetzes über die Akkreditierungsstelle (AkkStelleG) vom 31. Juli 2009 (BGBl. I S. 2625) sowie der Verordnung (EG) Nr. 765/2008 des Europäischen Parlaments und des Rates vom 9. Juli 2008 über die Vorschriften für die Akkreditierung und Marktüberwachung im Zusammenhang mit der Vermarktung von Produkten (Abt. L 218 vom 9. Juli 2008, S. 30). Die DAkkS ist Unterzeichnerin der Multilateralen Abkommen zur gegenseitigen Anerkennung der European co-operation for Accreditation (EA), des International Accreditation Forum (IAF) und der International Laboratory Accreditation Cooperation (ILAC). Die Unterzeichner dieser Abkommen erkennen ihre Akkreditierungen gegenseitig an.

Der aktuelle Stand der Mitgliedschaft kann folgenden Webseiten entnommen werden:

EA: www.european-accreditation.org

ILAC: www.ilac.org

IAF: www.iaf.nu

Note:

The current certificate including annex can be received from CETECOM ICT Services GmbH on request.